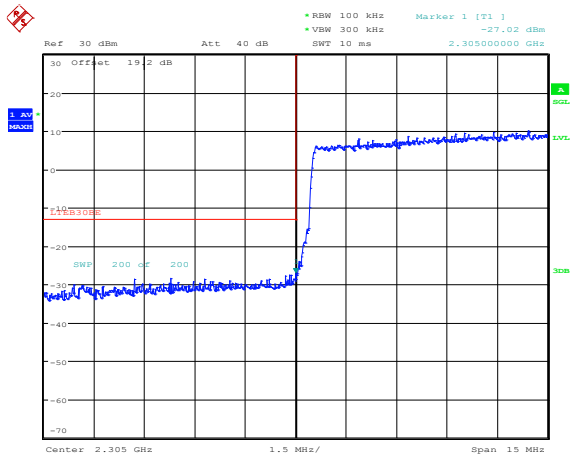
	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 8A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

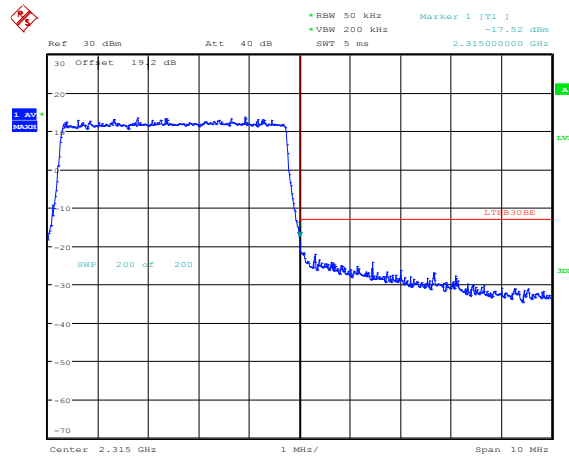
LTE Band 30 Conducted RF Emission Test Data cont'd

Figure 8-17a: Band 30 Channel Mask, 10MHz BW, RB=50



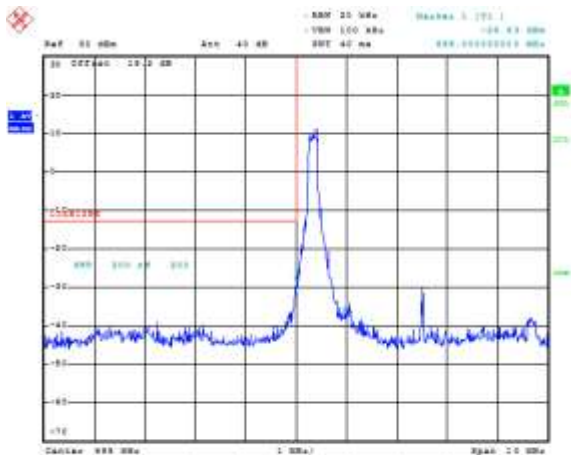
Date: 29.JUL.2015 20:50:14

Figure 8-17a: Band 30 Channel Mask, 10MHz BW, RB=50



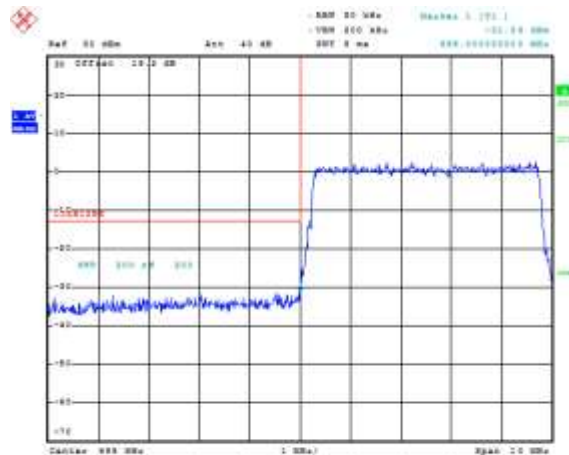
Date: 29.JUL.2015 20:55:35

Figure 8-18a: Band 30 Low Channel Mask, 5MHz BW, RB=1




Date: 29.JUL.2015 20:50:58

Figure 8-19a: Band 30 Low Channel Mask, 5MHz BW, RB=25



Date: 29.JUL.2015 20:51:07

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 8A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 30 Conducted RF Emission Test Data cont'd

Figure 8-20a: Band 30 High Channel Mask, 5MHz BW, RB=1

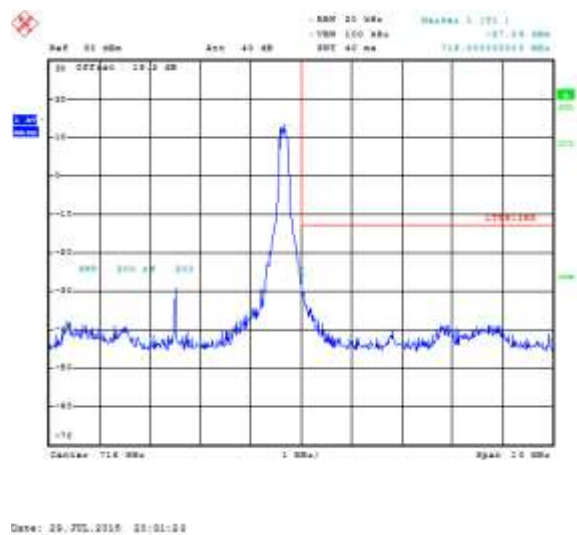


Figure 8-21a: Band 30 High Channel Mask, 5MHz BW, RB=25

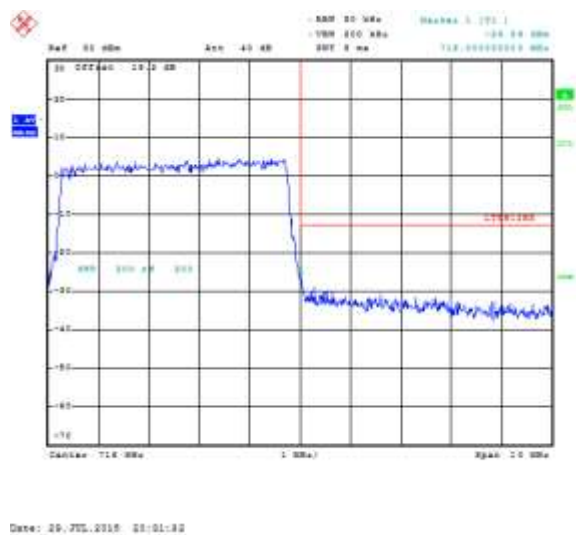
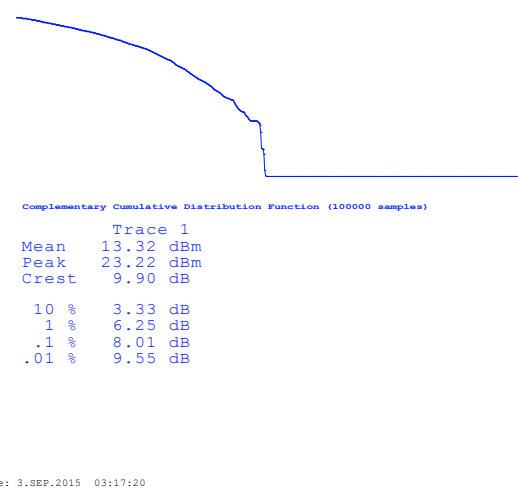


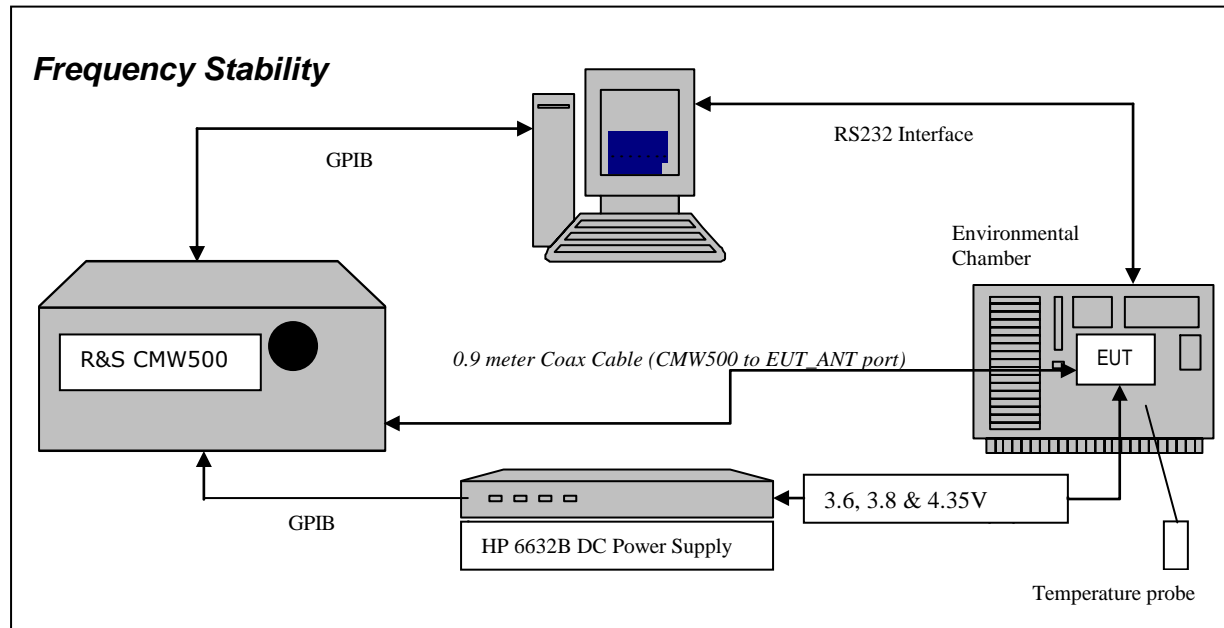
Figure 8-22a: Band 30 PAR, 10MHz BW, RB=25



APPENDIX 8B – LTE Band 30 FREQUENCY STABILITY TEST DATA

BlackBerry	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 8B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 30 Frequency Stability Test Data



The following configurations were measured for model RHK211LW (STV100-1):

The following measurements were performed by Sijia Li.

CFR 47 Chapter 1 - Federal Communications Commission Rules

Part 2 Required Measurements


2.1055 Frequency Stability - Procedures

(a,b) Frequency Stability - Temperature Variation

(d) Frequency Stability - Voltage Variation

The EUT meets the requirements as stated in CFR 47 chapter 1, Section 27.54, Frequency Stability.

Frequency Stability measurement devices were configured as presented in the block diagram recording frequency, power, data, temperatures, and stepped voltages controlled via a GPIB interface linked to the Environmental chamber, a DC power supply, and the Communications Test Set. A 0.9-metre coax cable was calibrated to characterize the insertion loss for the transmitted frequencies between the RF input/output of the CMW 500 and the EUT antenna port.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 8B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Test Setup:

The EUT was placed in the Temperature chamber and connected to CMW 500 outside as shown in the figure above. Dry air was pumped inside the temperature chamber to maintain a backpressure during the test. The EUT was kept in the off condition at all times except when the following measurements were to be made.


The chamber was switched on and the temperature was set to -30°C. After the chamber stabilized at -30 °C there was a soak period of one hour to alleviate moisture in the chamber, the EUT voltage was enabled. The system software recorded the frequency, power, and associated measurements.

A Computer system controlled the automated software. This application was given the command of activating all machines intrinsic to the temperature and voltage tests controlling the CMW 500 via the GPIB Bus. The Environmental Chamber was instructed through an RS-232 serial line. The EUT dialogue was passed through a serial connection.

The EUT repetitively transmitted 100 bursts for each set of programmed parameters recording temperature, voltage settings, and systematically selected frequencies. The power supply was cycled from minimum voltage 3.6 volts, 3.8 volts and to 4.35 volts maximum voltage. The frequency error was measured at a maximum output power and recorded by the automated system test software.

The EUT output power and frequency was measured at 3.6 volts, 3.8 volts and 4.35 volts. The transmit frequency was measured on 782MHz for 10MHz bandwidth with maximum (50) RB. The transmit frequency was varied in 3 steps consisting of 779.5 MHz, 782.0 MHz and 784.5 MHz each was measured under 5 MHz bandwidth with maximum (25) RBs. This frequency was recorded in MHz and deviation from nominal, in Parts Per Million.

After the initial one-hour soak at the beginning of the tests, a period of thirty minutes soak was initialized between each ascending temperature step, before proceeding to the next measurement test cycle.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 8B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW


Procedure:

The test system software for commencing the Frequency Stability Tests carried through the following cycle.

85. Switch on the HP 6632B power supply; CMW 500 Communications test Set, and Environmental Chamber.
86. Start test program
87. Set the Temperature to –30°C and maintain a period of one- hour soak time, with the EUT supply voltage disabled.
88. Set power supply voltage to 3.6 volts.
89. Set up CMW 500 Radio Communication Tester.
90. Command the CMW 500 to switch to the low channel.
91. Enable the voltage to the EUT, and connect a link to the CMW 500 test set.
92. EUT is commanded to Transmit 100 Bursts.
93. Software logs the following data from the CMW 500, power supply and temperature chamber: Traffic Channel Number, Traffic Channel Frequency, Power Level, Chamber Temperature, Supply Voltage, Power and Frequency Error.
94. The CMW 500 commands the EUT to change frequency to the middle channel and high channel and repeats steps 7 to 9.
95. Repeat steps 5 to 10 changing the supply voltage to 3.8 Volts
96. Increase temperature by 10°C and soak for 1/2 hour.
97. Repeat steps 4 - 12 for temperatures –30°C to 60°C.
98. Repeat steps 5 to 10 changing the supply voltage to 4.35 volts

Procedure 5 to 10 was repeated at room temperature (20°C) with the power supply voltage set to 3.6, 3.8 and 4.35 volts


The maximum frequency error in the LTE Band 30 measured was **0.0093 PPM**.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 8B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Date of test: August 25, 2015

LTE Band 30 results (10MHz Bandwidth): channels 27710 @ 20°C maximum transmitted power

Traffic Channel Number	LTE Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
27710	2310.00	3.6	20	-4.79	-0.0021
27710	2310.00	3.8	20	-5.75	-0.0025
27710	2310.00	4.35	20	-7.08	-0.0031

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 8B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 30 Results (10MHz Bandwidth): channel 27710 @ maximum transmitted power

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
27710	704	3.6	-30	-8.23	-0.0036
27710	704	3.6	-20	-5.49	-0.0024
27710	704	3.6	-10	-6.04	-0.0026
27710	704	3.6	0	-7.52	-0.0033
27710	704	3.6	10	-5.89	-0.0026
27710	704	3.6	20	-4.79	-0.0021
27710	704	3.6	30	-6.34	-0.0027
27710	704	3.6	40	-8.45	-0.0037
27710	704	3.6	50	-8.51	-0.0037
27710	704	3.6	60	-7.28	-0.0032

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
27710	704	3.8	-30	21.59	0.0093
27710	704	3.8	-20	-6.28	-0.0027
27710	704	3.8	-10	-5.05	-0.0022
27710	704	3.8	0	-6.19	-0.0027
27710	704	3.8	10	-7.32	-0.0032
27710	704	3.8	20	-5.75	-0.0025
27710	704	3.8	30	-6.98	-0.0030
27710	704	3.8	40	-8.41	-0.0036
27710	704	3.8	50	-6.41	-0.0028
27710	704	3.8	60	-7.80	-0.0034

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
27710	704	4.35	-30	-5.85	-0.0025
27710	704	4.35	-20	-7.38	-0.0032
27710	704	4.35	-10	-4.98	-0.0022
27710	704	4.35	0	-5.75	-0.0025
27710	704	4.35	10	-5.19	-0.0022
27710	704	4.35	20	-7.08	-0.0031
27710	704	4.35	30	-7.77	-0.0034
27710	704	4.35	40	-6.98	-0.0030
27710	704	4.35	50	-7.65	-0.0033
27710	704	4.35	60	-7.67	-0.0033

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APPENDIX 8C – LTE Band 30 RADIATED EMISSIONS TEST DATA

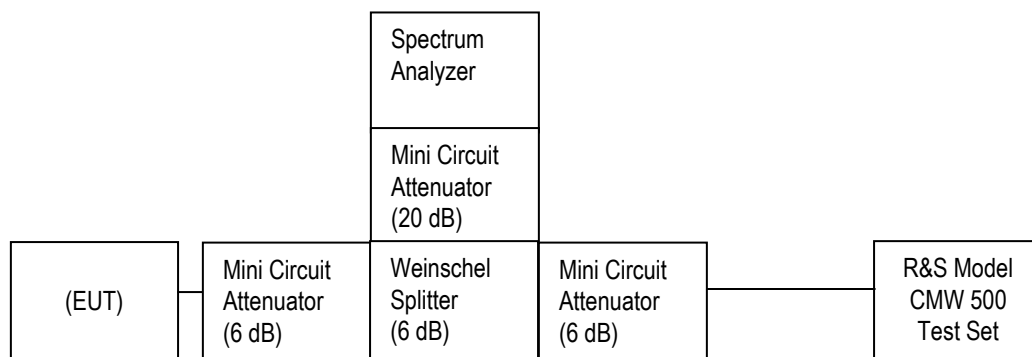
APPENDIX 9A– LTE Band 13 CONDUCTED RF EMISSIONS TEST DATA/PLOTS

BlackBerry	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 13 Conducted RF Emission Test Data

This appendix contains measurement data pertaining to conducted spurious emissions, 99% power bandwidth and the channel mask.

Test Setup Diagram




The following configurations were measured for model RHL211LW (STV100-3):

Date of Test: April 25 – September 2, 2015

The environmental test conditions were: Temperature: 23.0 – 27.5 °C
 Relative Humidity: 40.5 – 48.3 %

The following measurements were performed by Sijia Li and Landon Martin.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 13 Conducted RF Emission Test Data cont'd

Emission Designator Table

Frequency Range (MHz)	Conducted Output Power (dBm)	Emission Designator	Band	Bandwidth (MHz)	Modulation
779.5-784.4	22.74	4M50G7D	LTE B13	5	QPSK
779.5-784.4	22.45	4M50D7W	LTE B13	5	16QAM
782-782	22.72	8M96G7D	LTE B13	10	QPSK
782-782	22.55	8M94D7W	LTE B13	10	16QAM

The following test configurations were measured on RHL211LW (STV100-3):

The conducted spurious emissions – As per 47 CFR 2.1051, 27.53(c), RSS-130, 4.6 were measured from 30 MHz to 20 GHz.

–26 dBc Bandwidth and Occupied Bandwidth (99%)

The modulation spectrum was measured by both methods of 99% power bandwidth and – 26 dBc bandwidth for each 5MHz and 10MHz with different number of RBs for LTE Band 13. QPSK and 16-QAM modulations were applied to each of the bandwidths. Only the worst case measurements are documented in this report. A minimum RB condition was also measured (RB = 1). The resolution bandwidth required for out-of-band emissions in the 1 MHz bands immediately outside and adjacent to the frequency block, was determined to be at least 1% of the emission bandwidth.


The worst case –26dBc bandwidth for LTE Band 13 was measured to be 9.24 MHz. Results were derived in a 100 kHz resolution bandwidth. On any frequency outside the frequency block and outside the adjacent 1 MHz bands, a resolution bandwidth of at least 1 MHz was applied.

Test Data for LTE Band 13 selected Frequencies in 10MHz BW (RB = 50)


LTE Band 13 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
782	9.24	8.96

Test Data for LTE Band 13 selected Frequencies in 5MHz BW (RB = 25)

LTE Band 13 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
777	4.585	4.471
782	4.6	4.483

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

787	4.63	4.495
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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Peak to Average Ratio (PAR)

For each 5MHz and 10MHz with Resource Block allocation 50,25 and 15 as per scalable bandwidths for LTE Band 13, the peak to average ratio was measured on the middle channel with QPSK modulation.

On any frequency outside the frequency block and outside the adjacent 1 MHz bands, a resolution bandwidth of at least 1 MHz was applied.

The worst case measured was 10.22 dB on 10MHz bandwidth with Resource Block allocation 50 while transmitting at 782 MHz.


Measurement Plots for LTE Band 13

See Figures 9-1a to 9-12a for the plots of the conducted spurious emissions.

See Figures 9-13a to 9-24a and 9-37a to 9-39a for the plots of 99% Occupied Bandwidth and -26 dBc Bandwidth.

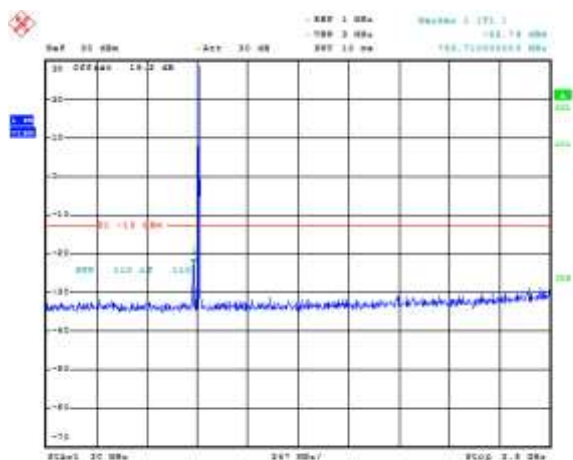
See Figures 9-25a to 9-32a for the plots of the Channel mask.

See Figures 9-33a to 9-36a for the plots of the Peak to Average Ratio.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

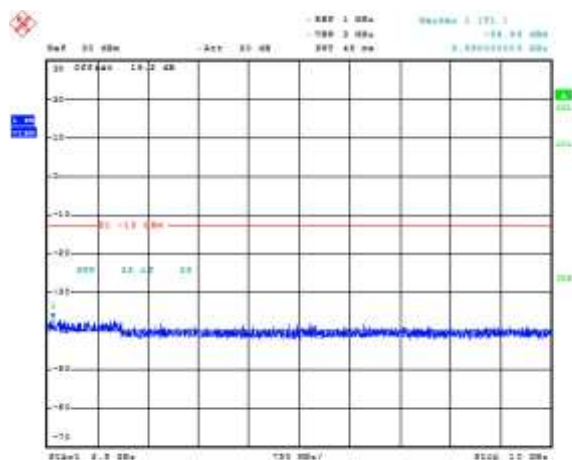
LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-1a: Band 13, Spurious Conducted Emissions, Low channel, 10MHz BW (RB= 1)



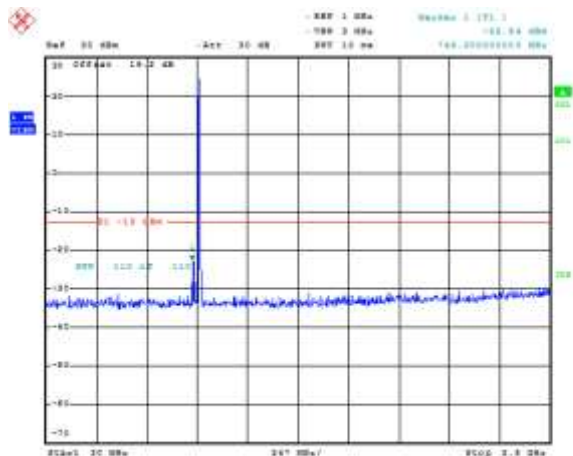
Date: 01-JUL-2015 14:51:05

Figure 9-2a: Band 13, Spurious Conducted Emissions, Low channel, 10MHz BW (RB= 1)



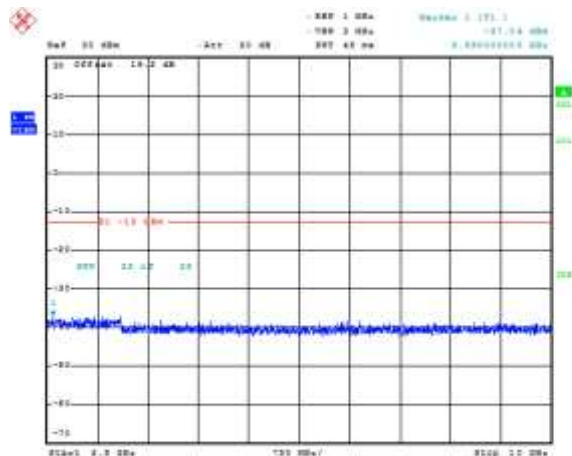
Date: 01-JUL-2015 14:51:10

Figure 9-3a: Band 13, Spurious Conducted Emissions, Middle channel, 10MHz BW (RB= 25)




Date: 01-JUL-2015 14:51:21

Figure 9-4a: Band 13, Spurious Conducted Emissions, Middle channel, 10MHz BW (RB= 25)



Date: 01-JUL-2015 14:51:27

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-5a: Band 13, Spurious Conducted Emissions, High Channel, 10MHz BW (RB= 50)

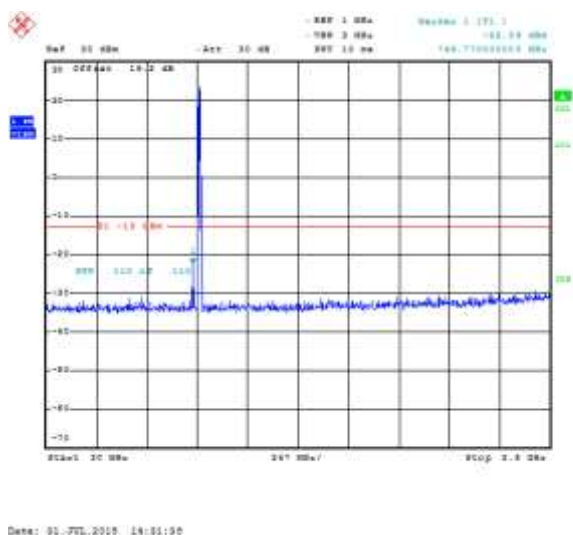


Figure 9-6a: Band 13, Spurious Conducted Emissions, High Channel, 10MHz BW (RB= 50)

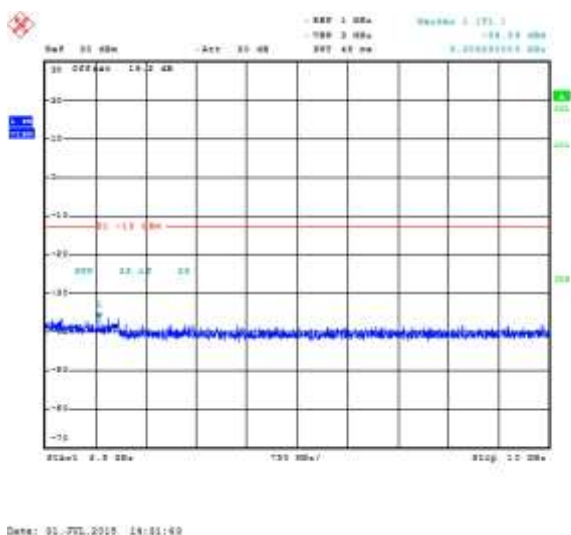


Figure 9-7a: Band 13, Spurious Conducted Emissions, Low channel, 5MHz BW (RB= 1)

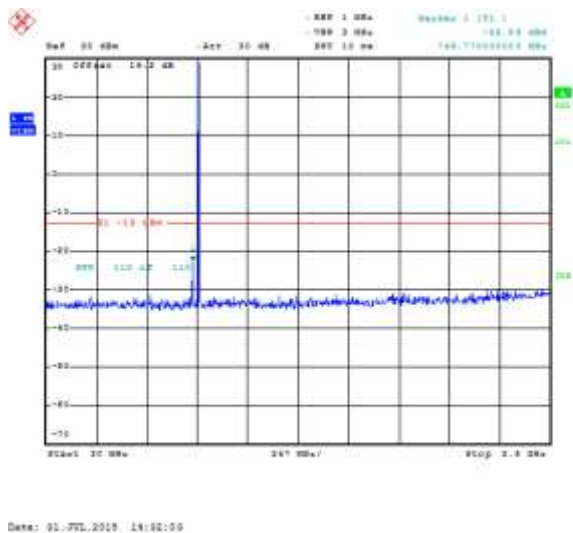
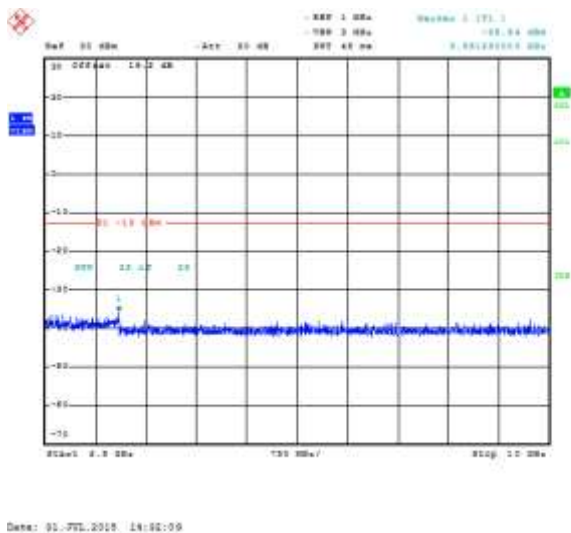



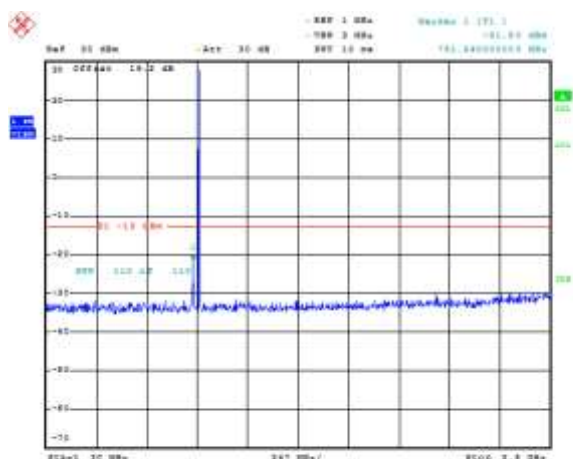
Figure 9-8a: Band 13, Spurious Conducted Emissions, Low channel, 5MHz BW (RB= 1)



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

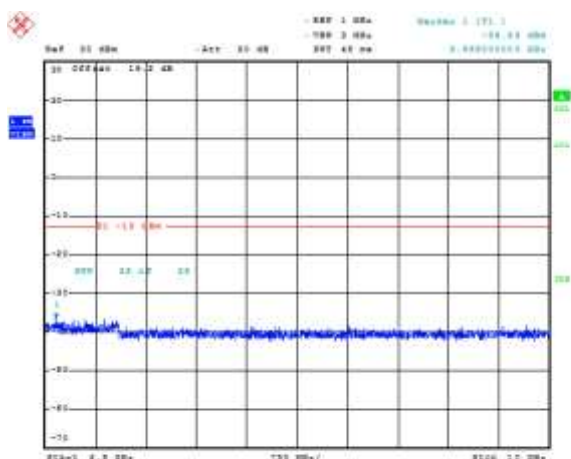
LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-9a: Band 13, Spurious Conducted Emissions, Middle Channel, 5MHz BW (RB= 15)



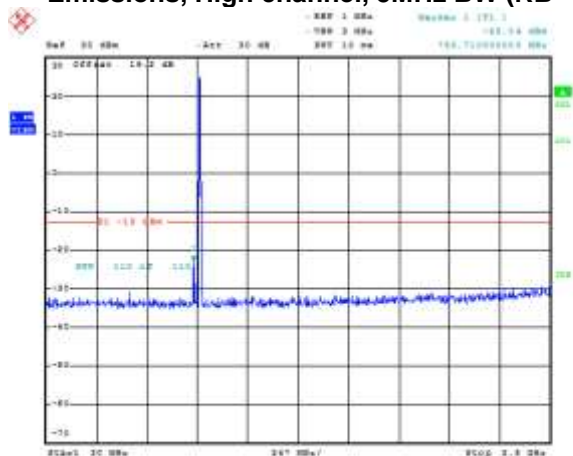
Date: 01-Jul-2015 14:52:20

Figure 9-10a: Band 13, Spurious Conducted Emissions, Middle Channel, 5MHz BW (RB= 15)



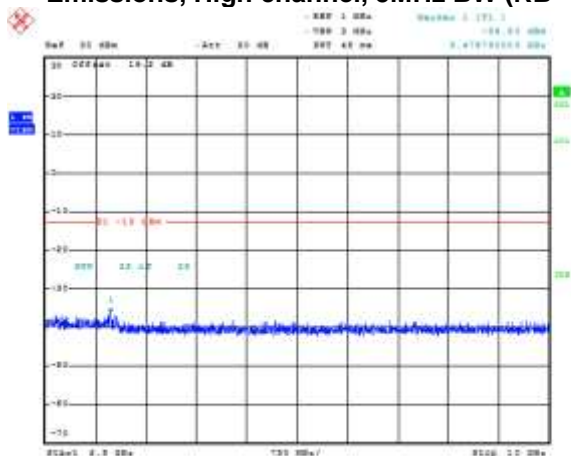
Date: 01-Jul-2015 14:52:26

Figure 9-11a: Band 13, Spurious Conducted Emissions, High channel, 5MHz BW (RB= 25)




Date: 01-Jul-2015 14:52:57

Figure 9-12a: Band 13, Spurious Conducted Emissions, High channel, 5MHz BW (RB= 25)

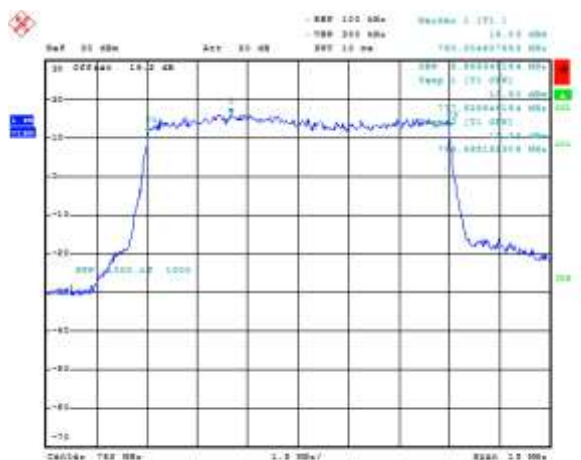


Date: 01-Jul-2015 14:52:59

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

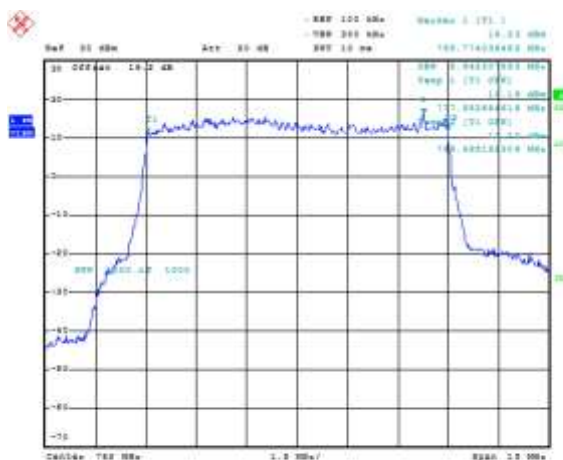
LTE Band 13 Conducted RF Emission Test Data cont'd

**Figure 9-13a: Occupied Bandwidth, Band 13
Middle Channel, 10MHz BW, RB=50**



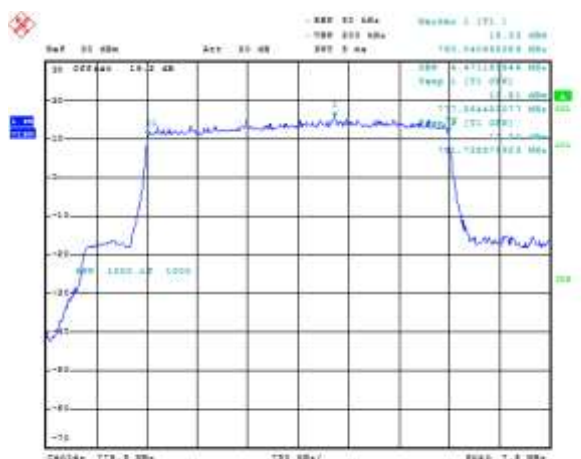
Date: 30, JUL, 2015 05:20:56

**Figure 9-14a: Occupied Bandwidth, Band 13
Middle Channel, 10MHz BW, RB=50**




Date: 30, JUL, 2015 05:31:21

**Figure 9-15a: Occupied Bandwidth, Band 13 Low
Channel, 5MHz BW, RB=50**



Date: 30, JUL, 2015 05:32:11

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

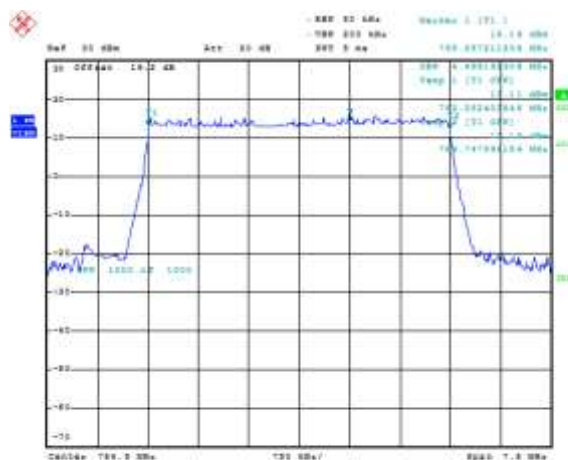
LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-16a: Occupied Bandwidth, Band 5 Middle Channel, 5MHz BW, RB=50




Date: 30 JUL 2015 21:22:40

Figure 9-17a: Occupied Bandwidth, Band 5 High Channel, 5MHz BW, RB=50



Date: 30 JUL 2015 21:20:55

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-19a: -26 dBc Bandwidth, Band 13 Low Channel, 10MHz BW, RB=50

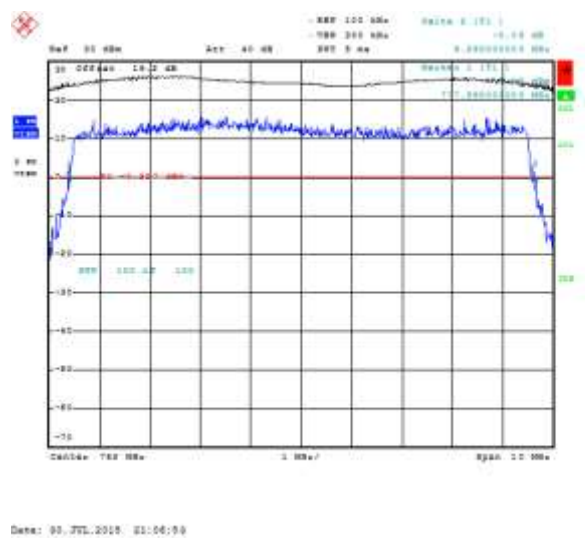


Figure 9-20a: -26 dBc Bandwidth, Band 13 Middle Channel, 10MHz BW, RB=50

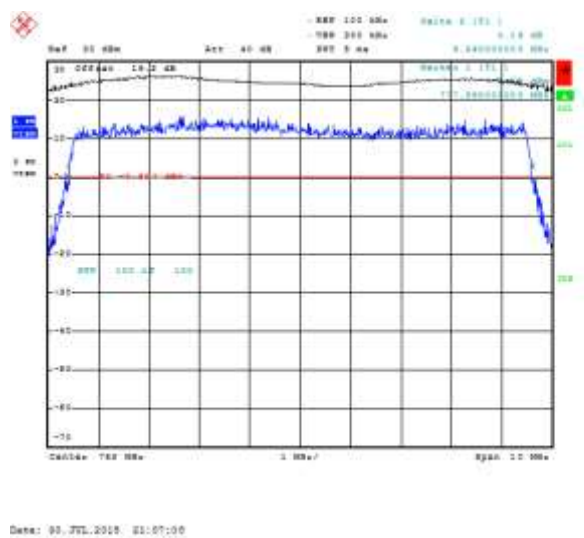


Figure 9-21a: -26 dBc Bandwidth, Band 13 High Channel, 10MHz BW, RB=50

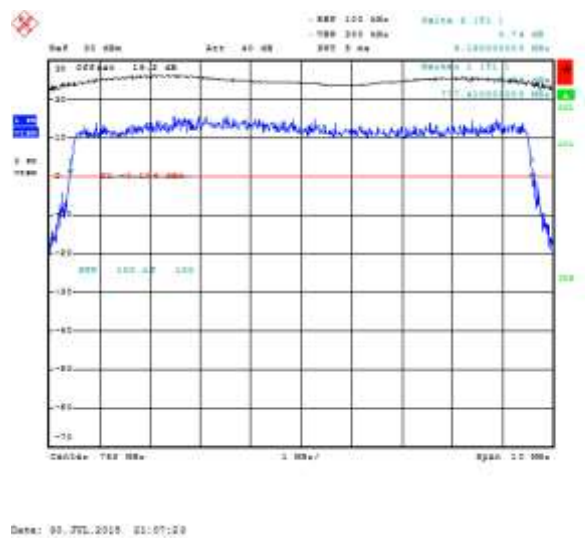
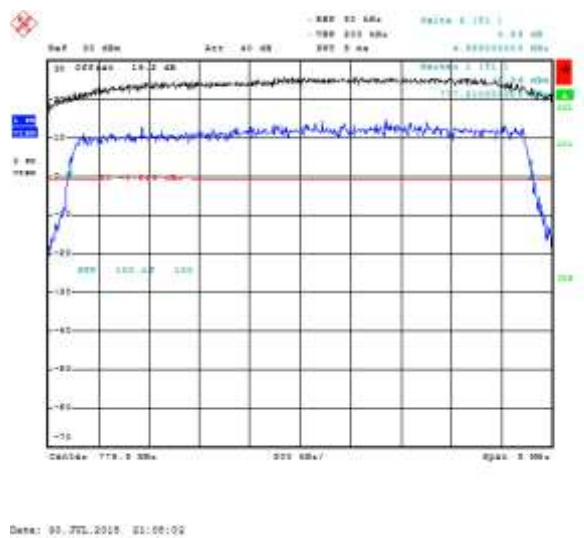



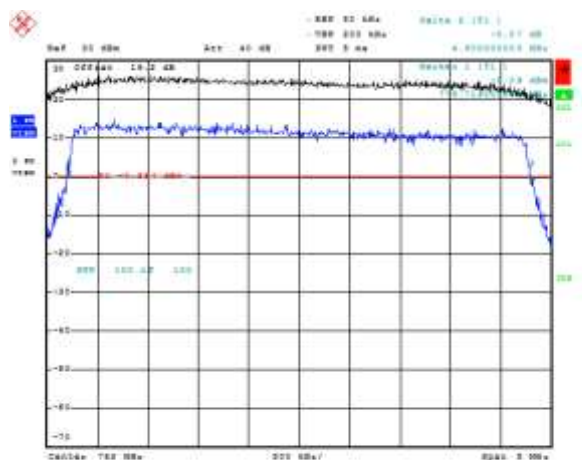
Figure 9-22a: -26 dBc Bandwidth, Band 13 Low Channel, 5MHz BW, RB=25



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

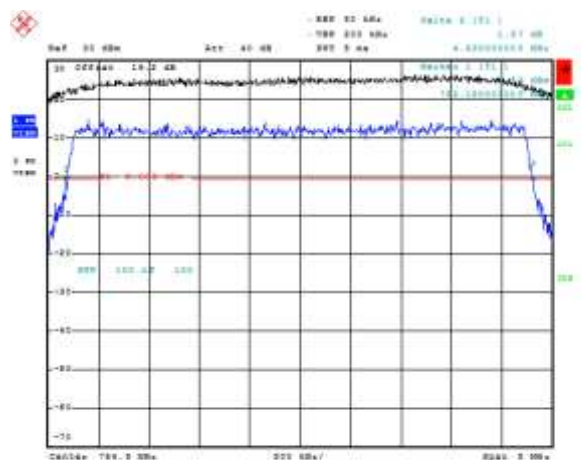
LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-23a: -26 dBc Bandwidth, Band 13 Middle Channel, 5MHz BW, RB=25



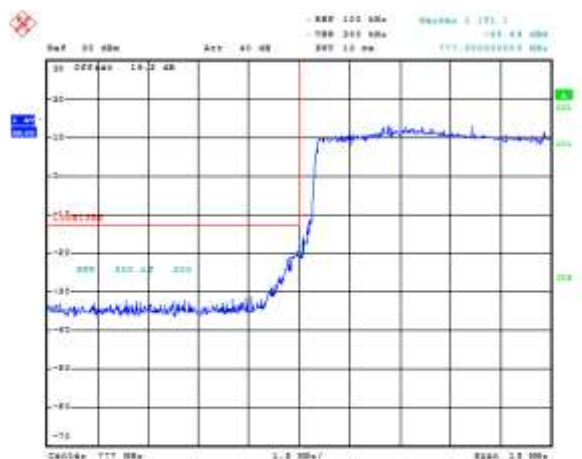
Date: 00_JUL2015 01:00:16

Figure 9-24a: -26 dBc Bandwidth, Band 13 High Channel, 5MHz BW, RB=25



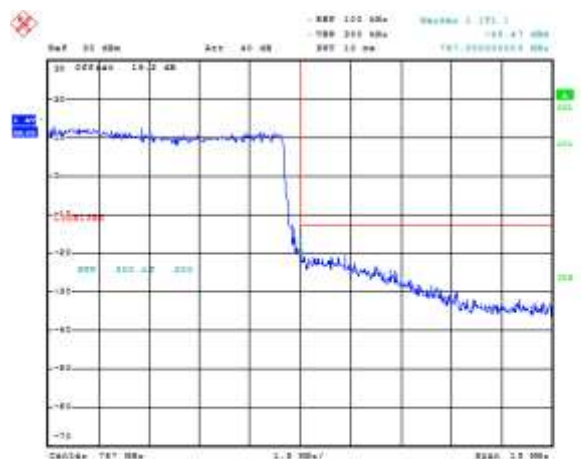
Date: 00_JUL2015 01:00:30

Figure 9-25a: Band 13 Middle Channel Mask, 10MHz BW, RB=50




Date: 00_JUL2015 02:01:30

Figure 9-26a: Band 13 Middle Channel Mask, 10MHz BW, RB=50



Date: 00_JUL2015 02:02:07

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-27a: Band 13 Middle Channel Mask, 10MHz BW, RB=1

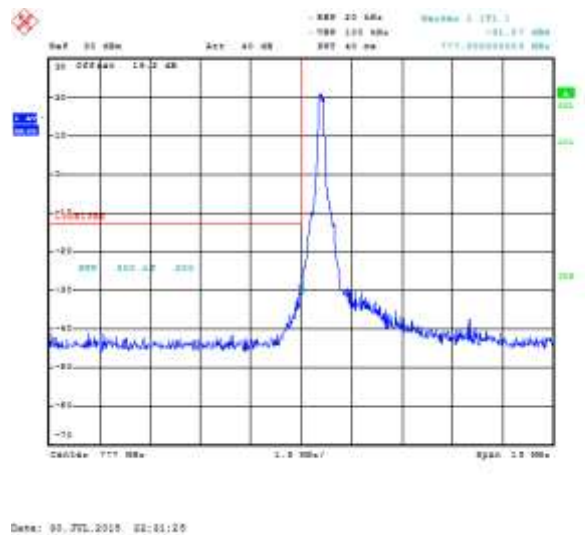


Figure 9-28a: Band 13 Middle Channel Mask, 10MHz BW, RB=1

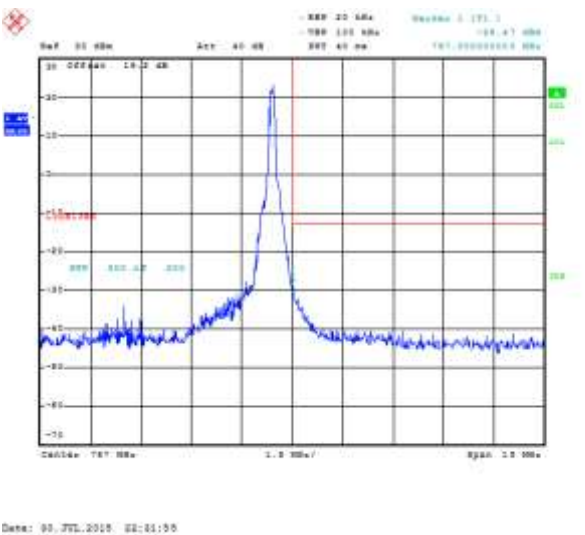


Figure 9-29a: Band 13 Low Channel Mask, 5MHz BW, RB=25

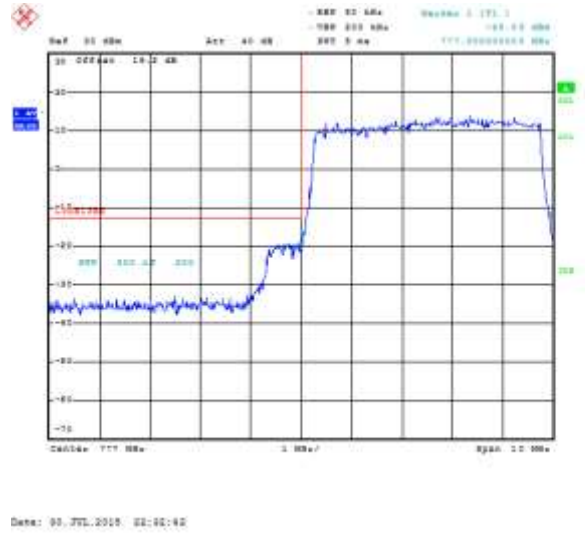
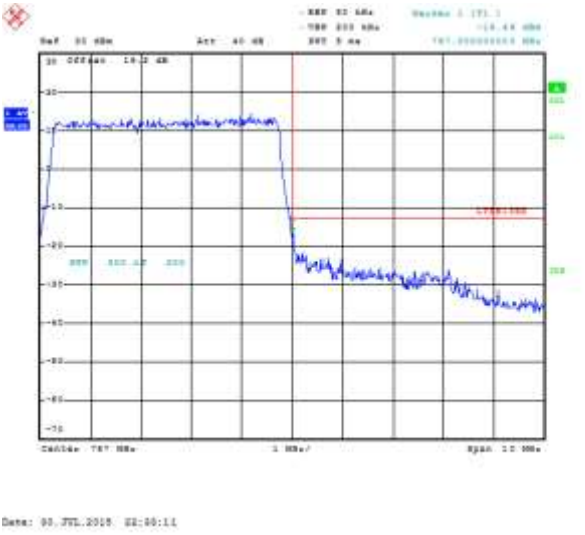



Figure 9-30a: Band 13 High Channel Mask, 5MHz BW, RB=25



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-31a: Band 13 Low Channel Mask, 5MHz BW, RB=1

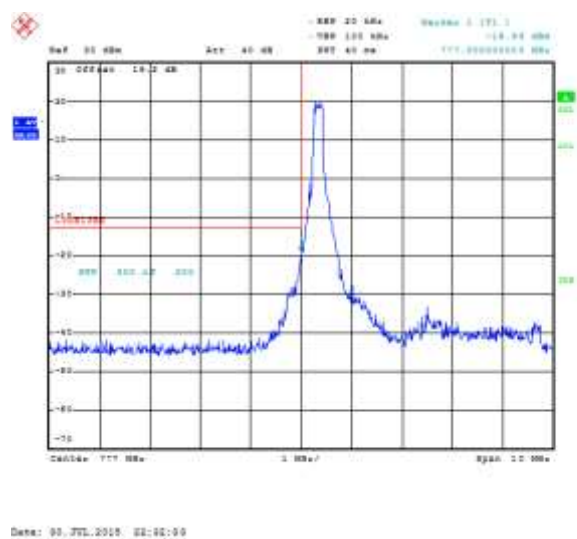


Figure 9-32a: Band 13 High Channel Mask, 5MHz BW, RB=1

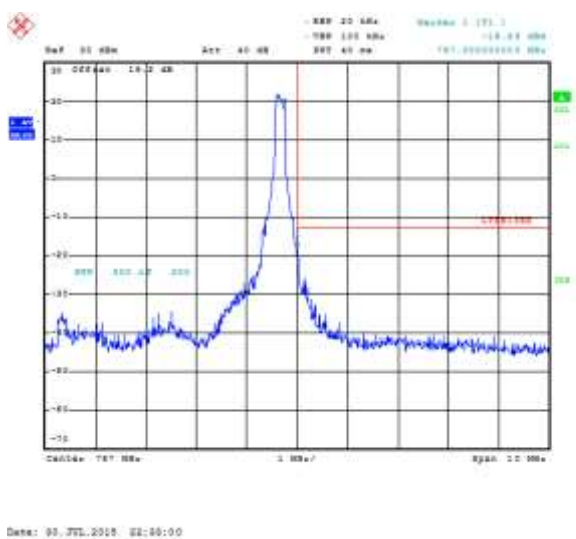


Figure 9-33a: Band 13 Mid Channel PAR, 10MHz BW, RB=25

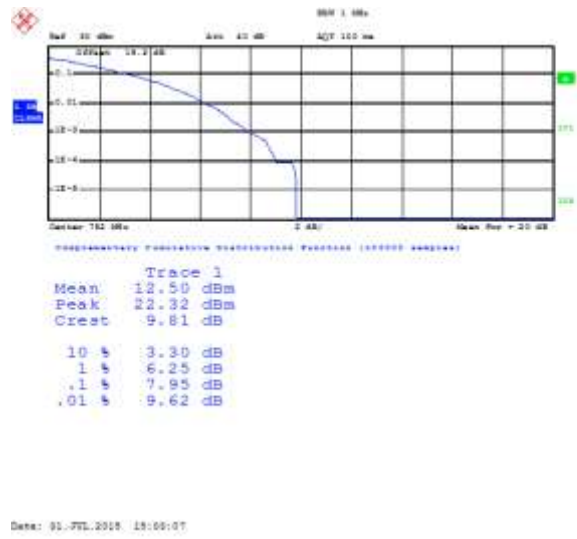
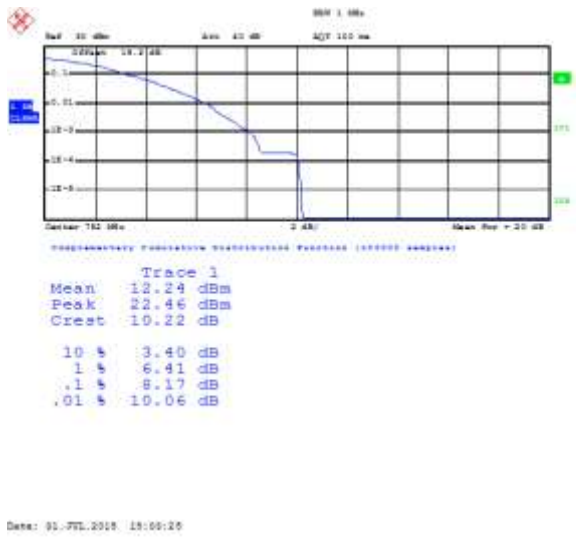



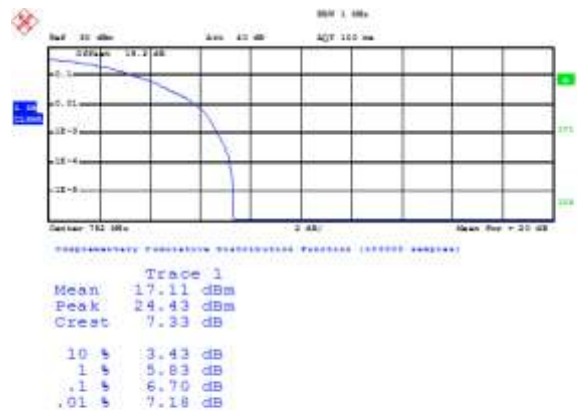
Figure 9-34a: Band 13 Middle Channel PAR, 10MHz BW, RB=50



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-35a: Band 13 Mid Channel PAR, 5MHz BW, RB=15




Date: 91-JUL-2015 15:06:51

Figure 9-36a: Band 13 Mid Channel PAR, 5MHz BW, RB=25

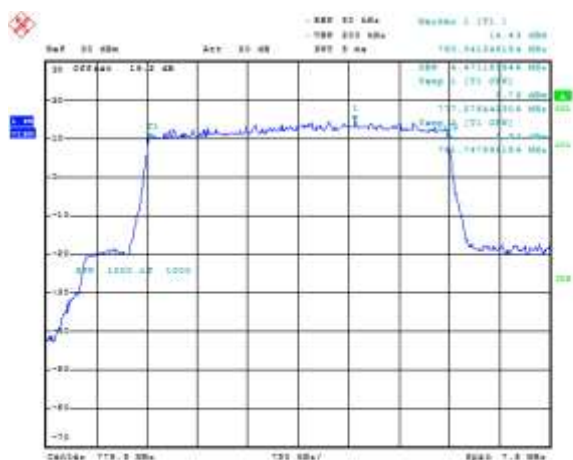


Date: 91-JUL-2015 15:06:59

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

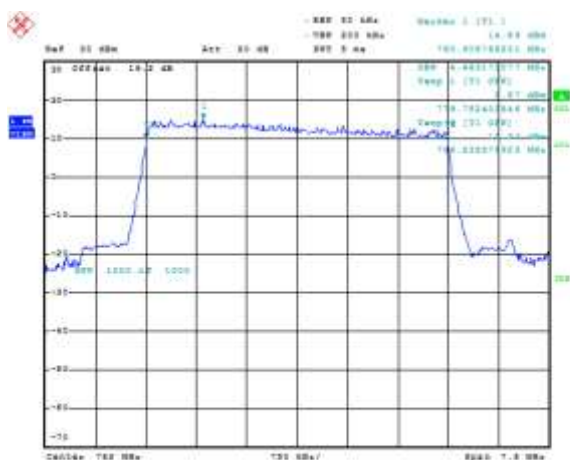
LTE Band 13 Conducted RF Emission Test Data cont'd

Figure 9-37a: Occupied Bandwidth, Band 13 Low Channel, 5MHz BW (RB= 25) 16-QAM



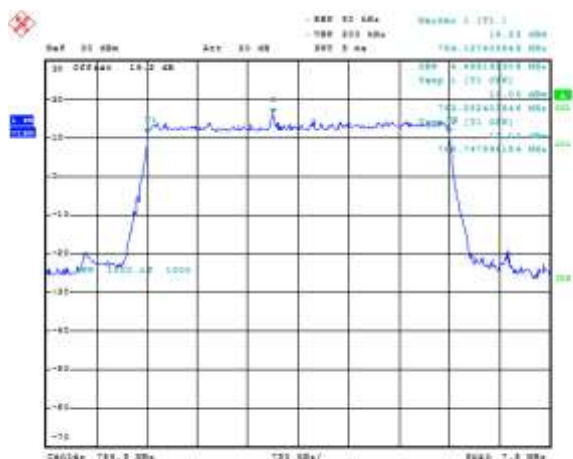
Date: 09_JUL.2015 01:20:42

Figure 9-38a: Occupied Bandwidth, Band 13 Mid Channel, 5MHz BW (RB= 25) 16-QAM



Date: 09_JUL.2015 01:24:11

Figure 9-39a: Occupied Bandwidth, Band 13 High Channel, 5MHz BW (RB= 25) 16-QAM

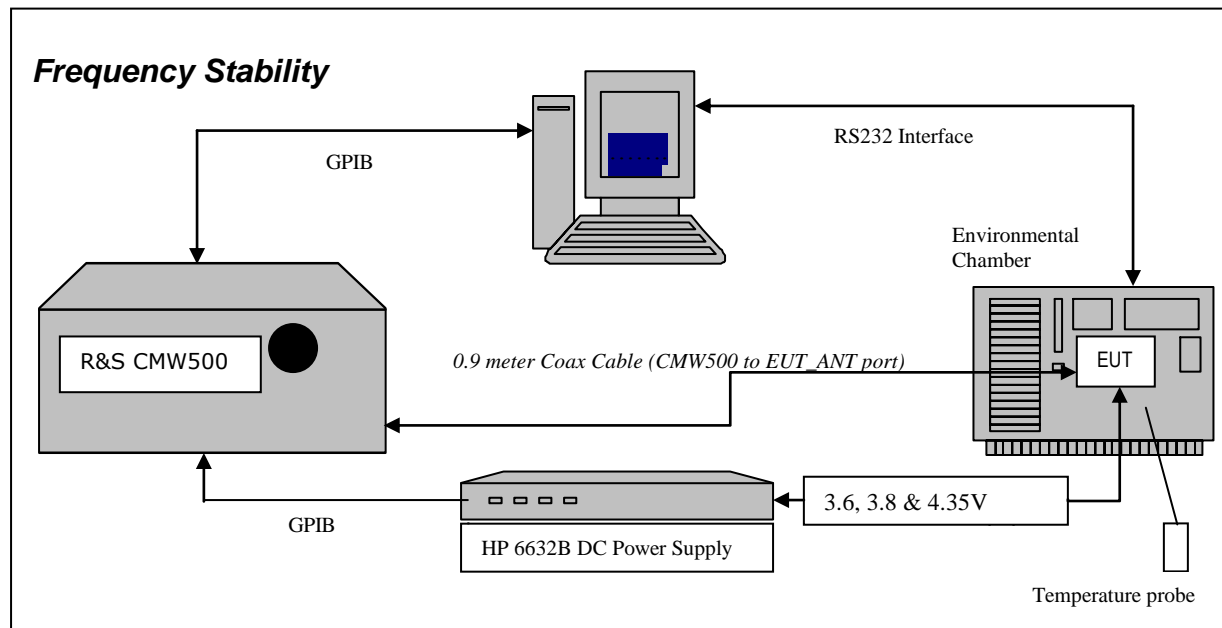


Date: 09_JUL.2015 01:24:46

APPENDIX 9B – LTE Band 13 FREQUENCY STABILITY TEST DATA

BlackBerry	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

LTE Band 13 Frequency Stability Test Data



The following configurations were measured for model RHL211LW (STV100-3):

The following measurements were performed by Landon Martin.

CFR 47 Chapter 1 - Federal Communications Commission Rules

Part 2 Required Measurements


2.1055 Frequency Stability - Procedures

(a,b) Frequency Stability - Temperature Variation

(d) Frequency Stability - Voltage Variation

The EUT meets the requirements as stated in CFR 47 chapter 1, Section 27.54, Frequency Stability.

Frequency Stability measurement devices were configured as presented in the block diagram recording frequency, power, data, temperatures, and stepped voltages controlled via a GPIB interface linked to the Environmental chamber, a DC power supply, and the Communications Test Set. A 0.9-metre coax cable was calibrated to characterize the insertion loss for the transmitted frequencies between the RF input/output of the CMW 500 and the EUT antenna port.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

Test Setup:

The EUT was placed in the Temperature chamber and connected to CMW 500 outside as shown in the figure above. Dry air was pumped inside the temperature chamber to maintain a backpressure during the test. The EUT was kept in the off condition at all times except when the following measurements were to be made.


The chamber was switched on and the temperature was set to -30°C. After the chamber stabilized at -30 °C there was a soak period of one hour to alleviate moisture in the chamber, the EUT voltage was enabled. The system software recorded the frequency, power, and associated measurements.

A Computer system controlled the automated software. This application was given the command of activating all machines intrinsic to the temperature and voltage tests controlling the CMW 500 via the GPIB Bus. The Environmental Chamber was instructed through an RS-232 serial line. The EUT dialogue was passed through a serial connection.

The EUT repetitively transmitted 100 bursts for each set of programmed parameters recording temperature, voltage settings, and systematically selected frequencies. The power supply was cycled from minimum voltage 3.6 volts, 3.8 volts and to 4.35 volts maximum voltage. The frequency error was measured at a maximum output power and recorded by the automated system test software.

The EUT output power and frequency was measured at 3.6 volts, 3.8 volts and 4.35 volts. The transmit frequency was measured on 782MHz for 10MHz bandwidth with maximum (50) RB. The transmit frequency was varied in 3 steps consisting of 779.5 MHz, 782.0 MHz and 784.5 MHz each was measured under 5 MHz bandwidth with maximum (25) RBs. This frequency was recorded in MHz and deviation from nominal, in Parts Per Million.

After the initial one-hour soak at the beginning of the tests, a period of thirty minutes soak was initialized between each ascending temperature step, before proceeding to the next measurement test cycle.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,


Procedure:

The test system software for commencing the Frequency Stability Tests carried through the following cycle.

99. Switch on the HP 6632B power supply; CMW 500 Communications test Set, and Environmental Chamber.
100. Start test program
101. Set the Temperature to –30°C and maintain a period of one- hour soak time, with the EUT supply voltage disabled.
102. Set power supply voltage to 3.6 volts.
103. Set up CMW 500 Radio Communication Tester.
104. Command the CMW 500 to switch to the low channel.
105. Enable the voltage to the EUT, and connect a link to the CMW 500 test set.
106. EUT is commanded to Transmit 100 Bursts.
107. Software logs the following data from the CMW 500, power supply and temperature chamber: Traffic Channel Number, Traffic Channel Frequency, Power Level, Chamber Temperature, Supply Voltage, Power and Frequency Error.
108. The CMW 500 commands the EUT to change frequency to the middle channel and high channel and repeats steps 7 to 9.
109. Repeat steps 5 to 10 changing the supply voltage to 3.8 Volts
110. Increase temperature by 10°C and soak for 1/2 hour.
111. Repeat steps 4 - 12 for temperatures –30°C to 60°C.
112. Repeat steps 5 to 10 changing the supply voltage to 4.35 volts

Procedure 5 to 10 was repeated at room temperature (20°C) with the power supply voltage set to 3.6, 3.8 and 4.35 volts


The maximum frequency error in the LTE Band 13 measured was **0.0099 PPM**.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

Date of test: August 25, 2015

LTE Band 13 results (10MHz Bandwidth): channels 23230 @ 20°C maximum transmitted power

Traffic Channel Number	LTE Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	782.00	3.6	20	6.17	0.0079
23230	782.00	3.8	20	5.97	0.0076
23230	782.00	4.35	20	5.75	0.0074

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,


LTE Band 13 Results (10MHz Bandwidth): channel 23230 @ maximum transmitted power

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	782	3.6	-30	6.77	0.0087
23230	782	3.6	-20	5.28	0.0068
23230	782	3.6	-10	7.30	0.0093
23230	782	3.6	0	5.09	0.0065
23230	782	3.6	10	5.65	0.0072
23230	782	3.6	20	6.17	0.0079
23230	782	3.6	30	-2.65	-0.0034
23230	782	3.6	40	6.55	0.0084
23230	782	3.6	50	2.32	0.0030
23230	782	3.6	60	3.95	0.0050

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	782	3.8	-30	7.22	0.0092
23230	782	3.8	-20	5.06	0.0065
23230	782	3.8	-10	6.32	0.0081
23230	782	3.8	0	5.38	0.0069
23230	782	3.8	10	7.65	0.0098
23230	782	3.8	20	5.97	0.0076
23230	782	3.8	30	-2.90	-0.0037
23230	782	3.8	40	5.22	0.0067
23230	782	3.8	50	4.71	0.0060
23230	782	3.8	60	-3.02	-0.0039

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	782	4.35	-30	7.74	0.0099
23230	782	4.35	-20	6.01	0.0077
23230	782	4.35	-10	6.18	0.0079
23230	782	4.35	0	4.85	0.0062
23230	782	4.35	10	6.01	0.0077
23230	782	4.35	20	5.75	0.0074
23230	782	4.35	30	2.12	0.0027
23230	782	4.35	40	5.74	0.0073
23230	782	4.35	50	-3.30	-0.0042
23230	782	4.35	60	-2.06	-0.0026

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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

Procedure for IC:

The test system software for commencing the Frequency Stability Tests carried through the following cycle.

1. Switch on the HP 6632B power supply; CMW 500 Communications test Set, and Environmental Chamber.
2. Start test program
3. Set the Temperature to –30°C and maintain a period of one- hour soak time, with the EUT supply voltage disabled.
4. Set power supply voltage to 3.6 volts.
5. Set up CMW 500 Radio Communication Tester.
6. Command the CMW 500 to switch to the low channel.
7. Enable the voltage to the EUT, and connect a link to the CMW 500 test set.
8. EUT is commanded to Transmit 100 Bursts.
9. Software logs the following data from the CMW 500, power supply and temperature chamber: Traffic Channel Number, Traffic Channel Frequency, Power Level, Chamber Temperature, Supply Voltage, Power and Frequency Error.
10. Using a resolution bandwidth equal to that permitted within the 1MHz band immediately outside the channel edge, reference points will be selected at the unwanted emission levels which comply with the attenuation $43 + 10 \log_{10} p$, for the type of device under test, on the emission mask of the lowest and highest channels, and the frequency at these points shall be recorded as fL and fH respectively.
11. The frequency stability is calculated by fL minus the frequency offset (frequency error measured in step 9) and fH plus the frequency offset shall be within the frequency range that the equipment is designed to operate (2.5 to 2.57 GHz).
12. The CMW 500 commands the EUT to change frequency to the high channel and repeats steps 7 to 11.
13. Repeat steps 5 to 12 changing the supply voltage to 3.8 Volts
14. Increase temperature to 20 and 50°C and soak for 1/2 hour.
15. Repeat steps 4 - 14 for temperatures –30°C to 60°C.
16. Repeat steps 5 to 15 changing the supply voltage to 4.35 volts

Procedure 5 to 10 was repeated at room temperature (20°C) with the power supply voltage set to 3.6, 3.8 and 4.35 volts

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

Date of test: Sept 2, 2015.


IC RSS – 130, 4.3 LTE Band 13 Frequency Stability.

LTE Band 13 10MHz Bandwidth results: channels 23230 @ 20°C maximum transmitted power

Traffic Channel Number	LTE Band 13 Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	fL (MHz)	fH (MHz)	fL-Freq Offset (MHz)	fH-Freq Offset (MHz)
23230	782	3.6	20	3.018	783.275	N/A	783.275	N/A
23230	782	3.6	20	3.018	N/A	781.235	N/A	781.235

Traffic Channel Number	LTE Band 13 Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	fL (MHz)	fH (MHz)	fL-Freq Offset (MHz)	fH-Freq Offset (MHz)
23230	782	3.8	20	-2.975	782.825	N/A	782.825	N/A
23230	782	3.8	20	-2.975	N/A	781.385	N/A	781.385

Traffic Channel Number	LTE Band 13 Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	fL (MHz)	fH (MHz)	fL-Freq Offset (MHz)	fH-Freq Offset (MHz)
23230	782	4.35	20	-3.948	782.915	N/A	782.915	N/A
23230	782	4.35	20	-3.948	N/A	781.445	N/A	781.445

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 9B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

LTE Band 13 10MHz Bandwidth results: channels 23230 @ -30 and +60°C maximum transmitted power

Traffic Channel Number	LTE Band 13 Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	fL (MHz)	fH (MHz)	fL-Freq Offset (MHz)	fH-Freq Offset (MHz)
23230	782	3.6	-30	-3.233	783.620	N/A	783.620	N/A
23230	782	3.6	-30	-3.233	N/A	781.250	N/A	781.250
23230	782	3.8	-30	-3.877	782.900	N/A	782.900	N/A
23230	782	3.8	-30	-3.877	N/A	781.445	N/A	781.445
23230	782	4.35	-30	-3.719	783.980	N/A	783.980	N/A
23230	782	4.35	-30	-3.719	N/A	781.235	N/A	781.235
23230	782	3.6	60	-4.206	783.050	N/A	783.050	N/A
23230	782	3.6	60	-4.206	N/A	781.400	N/A	781.400
23230	782	3.8	60	-4.520	782.675	N/A	782.675	N/A
23230	782	3.8	60	-4.520	N/A	780.890	N/A	780.890
23230	782	4.35	60	4.821	782.675	N/A	782.675	N/A
23230	782	4.35	60	4.821	N/A	781.250	N/A	781.250

APPENDIX 9C – LTE Band 13 RADIATED EMISSIONS TEST DATA

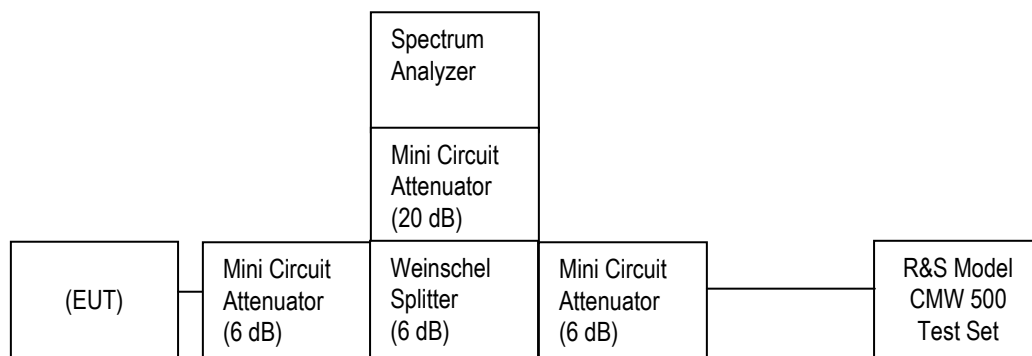
APPENDIX 10A– LTE Band 25 CONDUCTED RF EMISSIONS TEST DATA/PLOTS

BlackBerry	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data

This appendix contains measurement data pertaining to conducted spurious emissions, 99% power bandwidth and the channel mask.

Test Setup Diagram




The following configurations were measured for model RHL211LW (STV100-3):

Date of Test: July 31, 2015

The environmental test conditions were: Temperature: 24.0 °C
 Relative Humidity: 45.3 %

The following measurements were performed by Sijia Li.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Emission Designator Table

Frequency Range (MHz)	Conducted Output Power (dBm)	Emission Designator	Band	Bandwidth (MHz)	Modulation
1850.7-1914.3	25.70	1M09G7D	LTE B25	1.4	QPSK
1850.7-1914.3	24.72	1M09D7W	LTE B25	1.4	16QAM
1851.5-1913.5	25.42	2M70G7D	LTE B25	3	QPSK
1851.5-1913.5	24.61	2M69D7W	LTE B25	3	16QAM
1852.5-1912.5	25.46	4M50G7D	LTE B25	5	QPSK
1852.5-1912.5	24.38	4M48D7W	LTE B25	5	16QAM
1855-1910	25.46	8M97G7D	LTE B25	10	QPSK
1855-1910	25.16	8M97D7W	LTE B25	10	16QAM
1857.5-1907.5	25.19	13M5G7D	LTE B25	15	QPSK
1857.5-1907.5	24.79	13M5D7W	LTE B25	15	16QAM
1860-1905.5	24.92	18M0G7D	LTE B25	20	QPSK
1860-1905.5	24.40	18M0D7W	LTE B25	20	16QAM

The following test configurations were measured on RHL211LW (STV100-3):

The conducted spurious emissions – As per 47 CFR 2.1051, 24.238(a), RSS – 133, 6.5 were measured from 30 MHz to 20 GHz.

–26 dBc Bandwidth and Occupied Bandwidth (99%)

The modulation spectrum was measured by both methods of 99% power bandwidth and – 26 dBc bandwidth for each 1.4MHz, 10MHz and 20MHz with different number of RBs for LTE Band 25.

QPSK and 16-QAM modulations were applied to each of the bandwidths. Only the worst case measurements are documented in this report. A minimum RB condition was also measured (RB = 1). The resolution bandwidth required for out-of-band emissions in the 1 MHz bands immediately outside and adjacent to the frequency block, was determined to be at least 1% of the emission bandwidth.


The worst case –26dBc bandwidth for LTE Band 25 was measured to be 18.72 MHz.

Results were derived in a 100 kHz resolution bandwidth.

On any frequency outside the frequency block and outside the adjacent 1 MHz bands, a resolution bandwidth of at least 1 MHz was applied.

Test Data for LTE Band 25 selected Frequencies in 20MHz BW (RB = 100)

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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
1860	18.56	17.980
1882.5	18.68	17.980
1905	18.72	17.884

Test Data for LTE Band 25 selected Frequencies in 10MHz BW (RB = 50)

LTE Band 25 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
1860	9.15	8.966
1882.5	9.17	8.966
1905	9.18	8.966

Test Data for LTE Band 25 selected Frequencies in 1.4MHz BW (RB = 6)

LTE Band 25 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
1860	1.150	1.090
1882.5	1.141	1.097
1905	1.148	1.087

Peak to Average Ratio (PAR)

For each 1.4MHz, 10MHz and 20MHz with Resource Block allocation 100,50,25, 6 and 3 as per scalable bandwidths for LTE Band 25, the peak to average ratio was measured on the middle channel with QPSK modulation.

On any frequency outside the frequency block and outside the adjacent 1 MHz bands, a resolution bandwidth of at least 1 MHz was applied.

The worst case measured was 10.42dB on 10MHz bandwidth with Resource Block allocation 50 while transmitting at 1882.5 MHz.


Measurement Plots for LTE Band 25

See Figures 10-1a to 10-12a and 10-40a to 10-45a for the plots of the conducted spurious emissions.

See Figures 10-13a to 10-24a and 10-37a to 10-39a for the plots of 99% Occupied Bandwidth and -26 dBc Bandwidth.

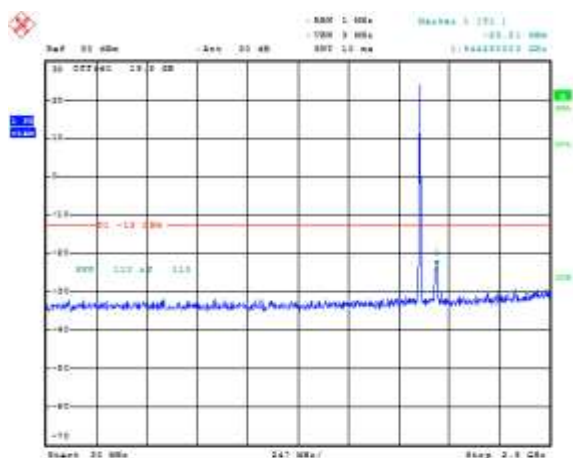
See Figures 10-25a to 10-32a for the plots of the Channel mask.

See Figures 10-33a to 10-36a for the plots of the Peak to Average Ratio.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

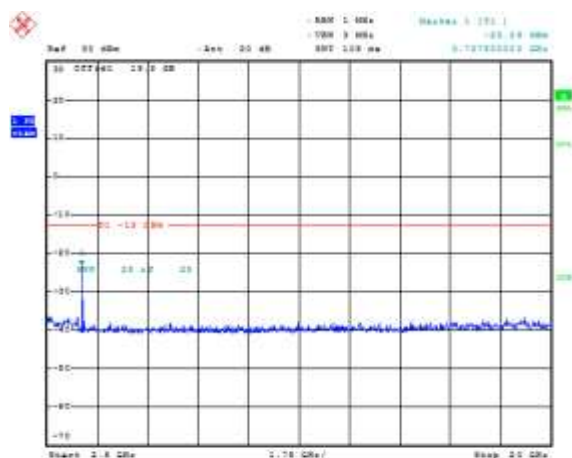
LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-1a: Band 25, Spurious Conducted Emissions, Low channel, 20MHz BW (RB= 1)



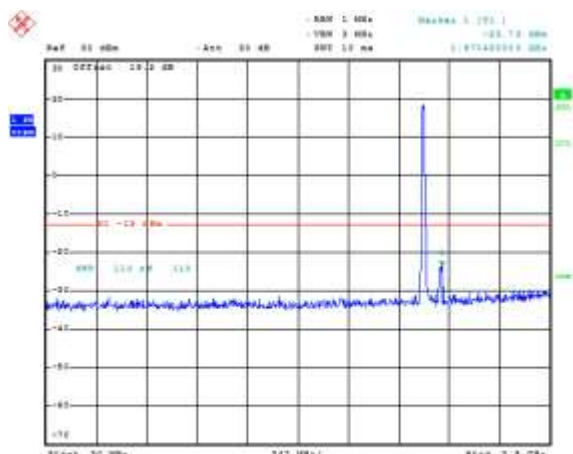
Date: 31.JUL.2015 14:00:11

Figure 10-2a: Band 25, Spurious Conducted Emissions, Low channel, 20MHz BW (RB= 1)



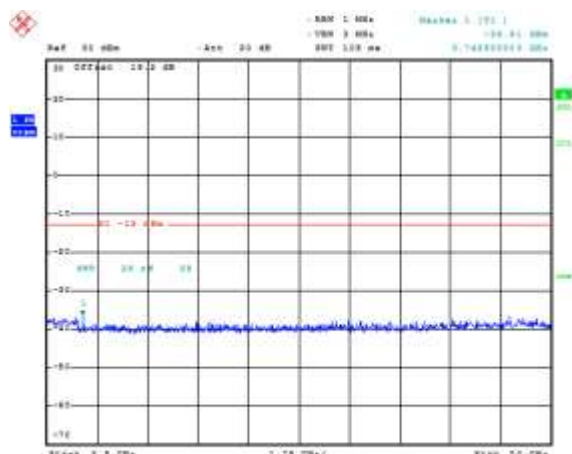
Date: 31.JUL.2015 14:00:28

Figure 10-3a: Band 25, Spurious Conducted Emissions, Middle channel, 20MHz BW (RB= 50)




Date: 31.JUL.2015 14:00:30

Figure 10-4a: Band 25, Spurious Conducted Emissions, Middle channel, 20MHz BW (RB= 50)

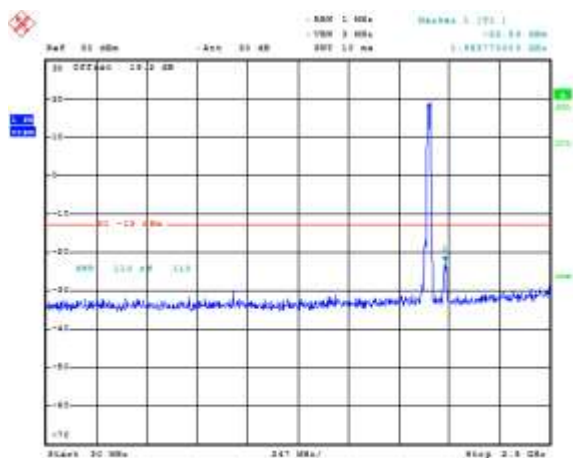


Date: 31.JUL.2015 14:00:38

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

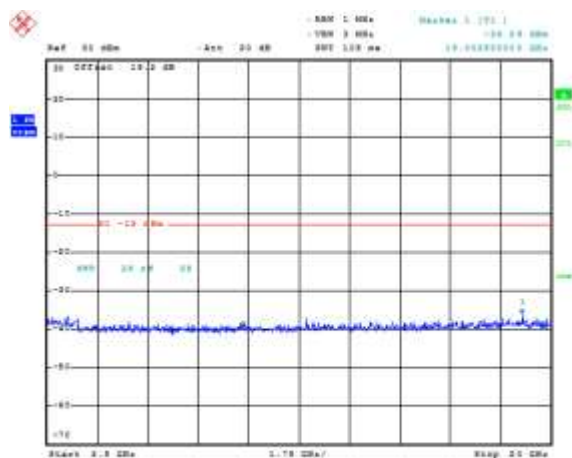
LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-5a: Band 25, Spurious Conducted Emissions, High Channel, 20MHz BW (RB= 100)



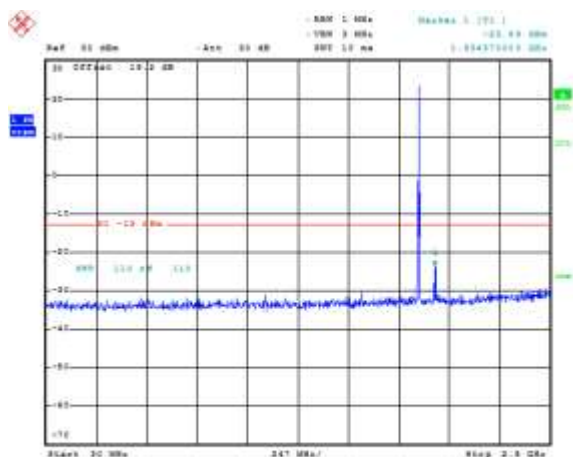
Date: 30-JUL-2015 14:00:49

Figure 10-6a: Band 25, Spurious Conducted Emissions, High Channel, 20MHz BW (RB= 100)



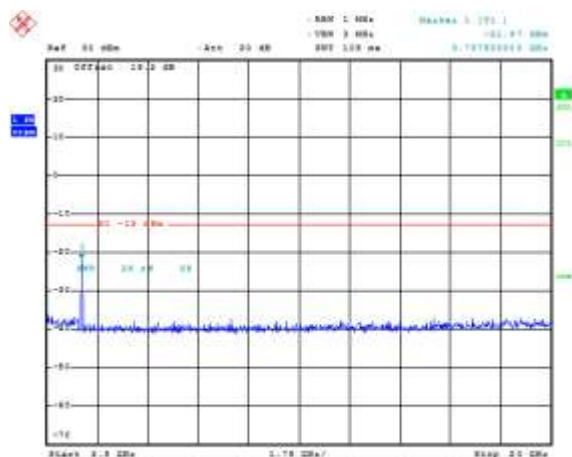
Date: 30-JUL-2015 14:00:57

Figure 10-7a: Band 25, Spurious Conducted Emissions, Low channel, 10MHz BW (RB= 1)




Date: 30-JUL-2015 14:01:17

Figure 10-8a: Band 25, Spurious Conducted Emissions, Low channel, 10MHz BW (RB= 1)

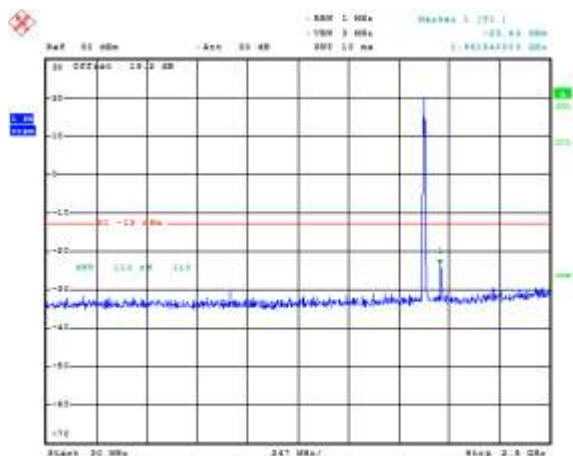


Date: 30-JUL-2015 14:01:29

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

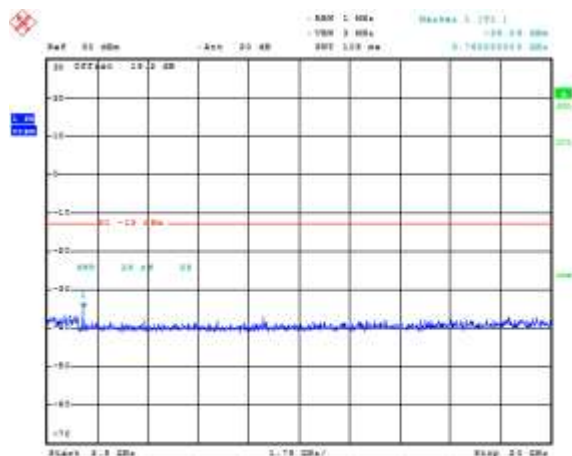
LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-9a: Band 25, Spurious Conducted Emissions, Middle Channel, 10MHz BW (RB= 25)



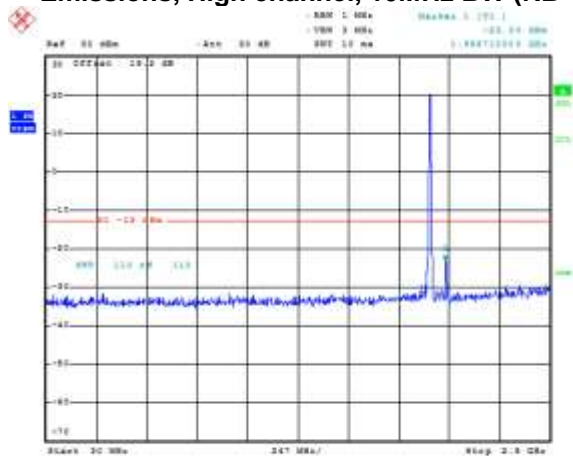
Date: 30-JUL-2015 14:01:37

Figure 10-10a: Band 25, Spurious Conducted Emissions, Middle Channel, 10MHz BW (RB= 25)



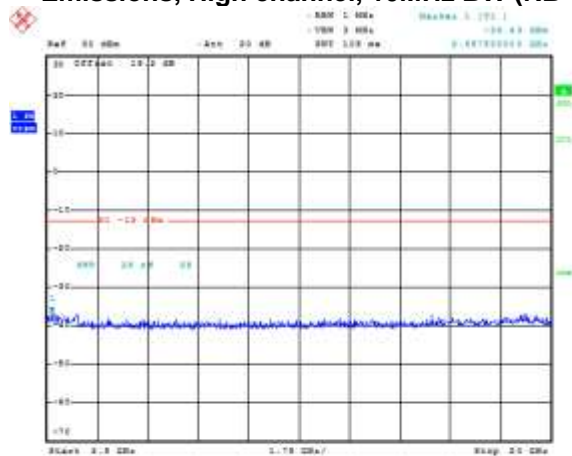
Date: 30-JUL-2015 14:01:44

Figure 10-11a: Band 25, Spurious Conducted Emissions, High channel, 10MHz BW (RB= 50)




Date: 30-JUL-2015 14:01:54

Figure 10-12a: Band 25, Spurious Conducted Emissions, High channel, 10MHz BW (RB= 50)



Date: 30-JUL-2015 14:02:04

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-13a: Band 25, Spurious Conducted Emissions, Low channel, 1.4MHz BW (RB= 1)

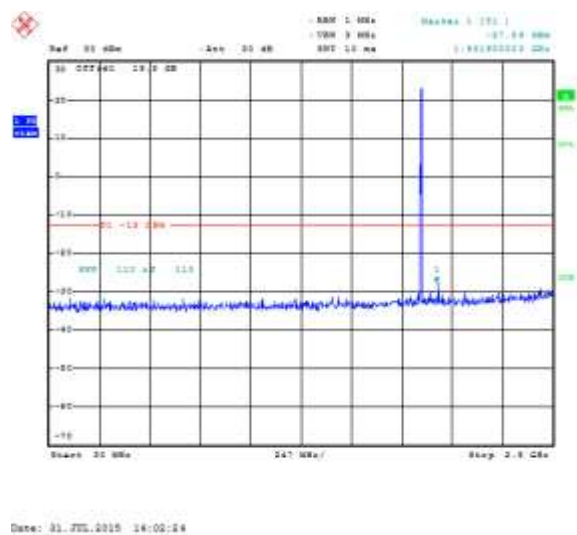
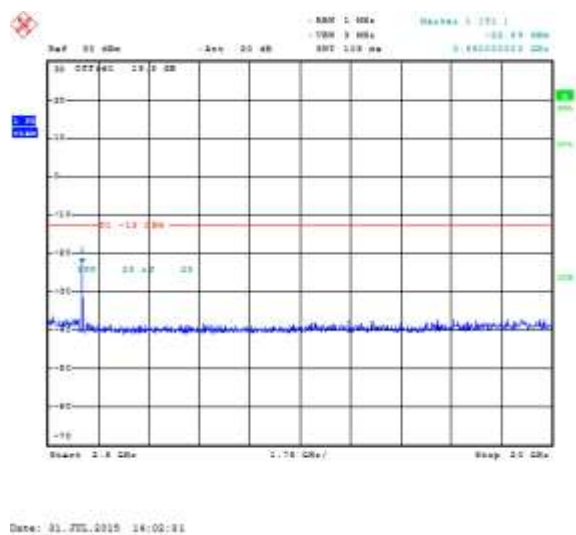



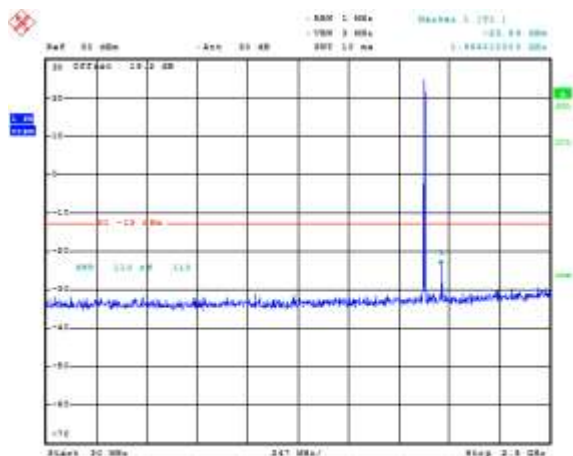
Figure 10-14a: Band 25, Spurious Conducted Emissions, Low channel, 1.4MHz BW (RB= 1)



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

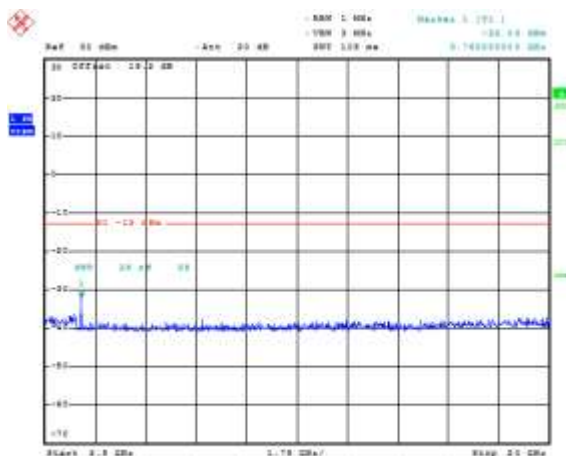
LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-15a: Band 25, Spurious Conducted Emissions, Middle Channel, 1.4MHz BW (RB= 3)



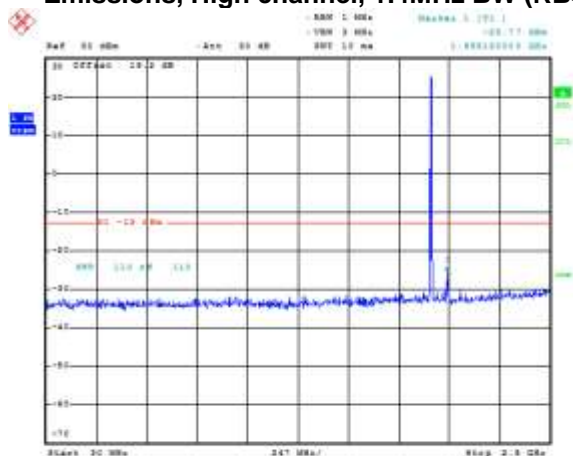
Date: 30-Jul-2015 14:02:49

Figure 10-16a: Band 25, Spurious Conducted Emissions, Middle Channel, 1.4MHz BW (RB= 3)



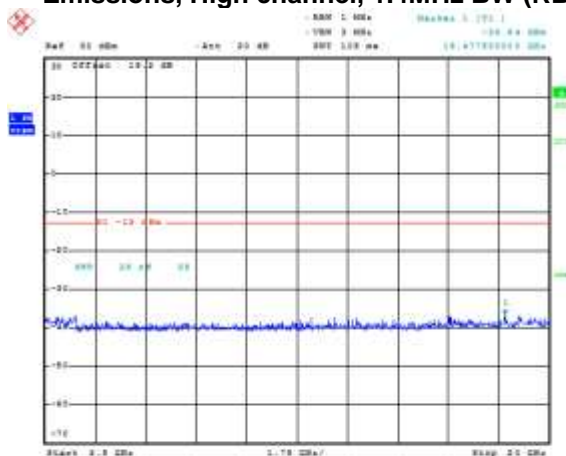
Date: 30-Jul-2015 14:02:51

Figure 10-17a: Band 25, Spurious Conducted Emissions, High channel, 1.4MHz BW (RB= 6)




Date: 30-Jul-2015 14:02:52

Figure 10-18a: Band 25, Spurious Conducted Emissions, High channel, 1.4MHz BW (RB= 6)



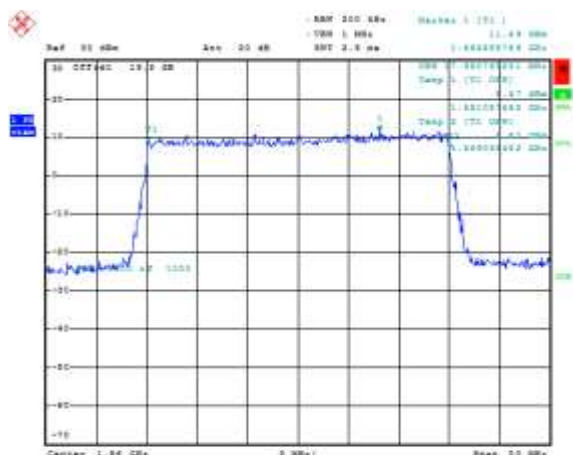
Date: 30-Jul-2015 14:02:53

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-19a: Occupied Bandwidth, Band 25

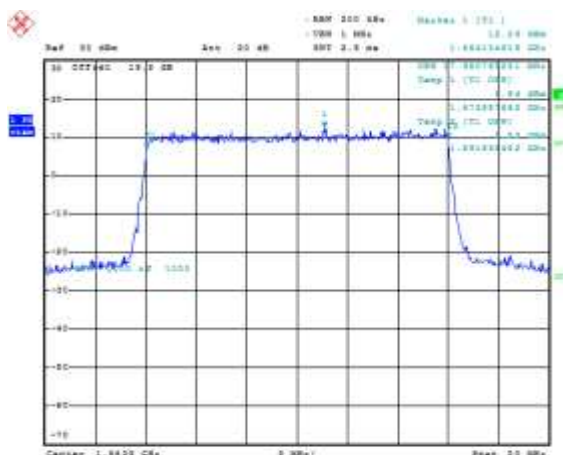
Low Channel, 20MHz BW, RB=100



Date: 31-Jul-2015 18:00:37

Figure 10-20a: Occupied Bandwidth, Band 25

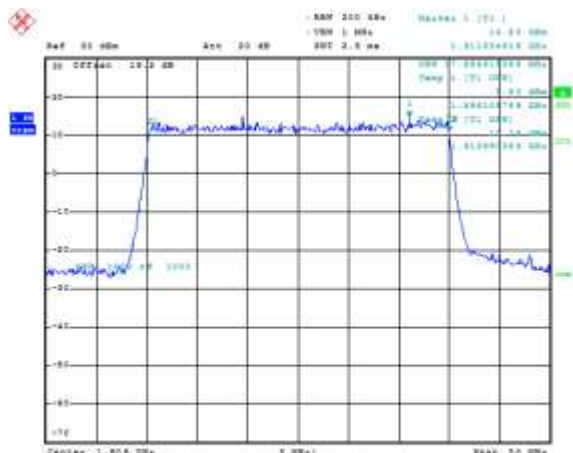
Middle Channel, 20MHz BW, RB=100



Date: 31-Jul-2015 18:00:37

Figure 10-21a: Occupied Bandwidth, Band 25 High

Channel, 20MHz BW, RB=100




Date: 31-Jul-2015 18:01:29

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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-22a: Occupied Bandwidth, Band 25

Low Channel, 20MHz BW, RB=100

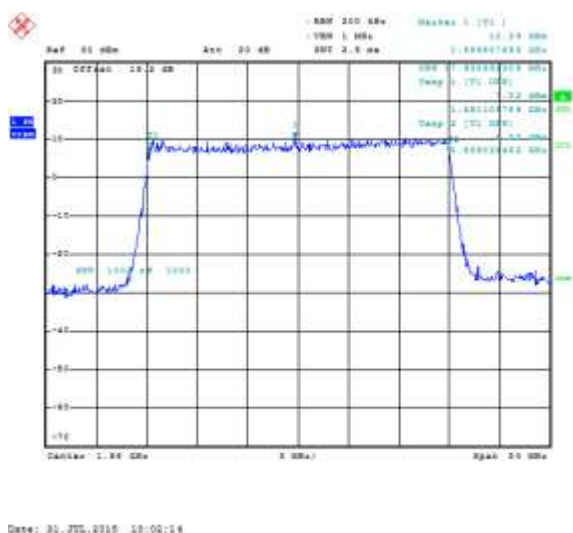


Figure 10-23a: Occupied Bandwidth, Band 25

Middle Channel, 20MHz BW, RB=100

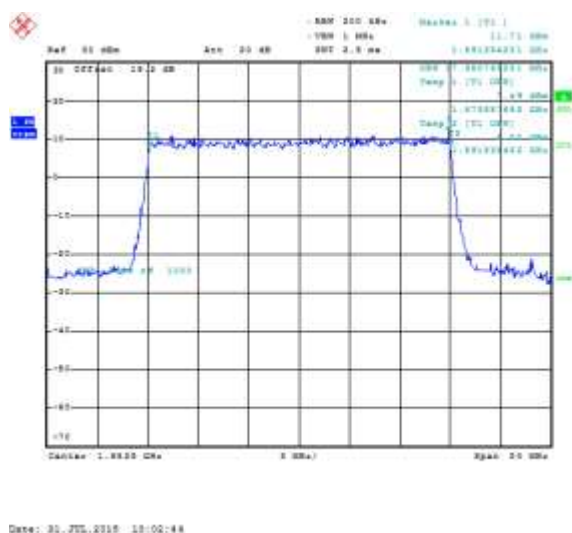
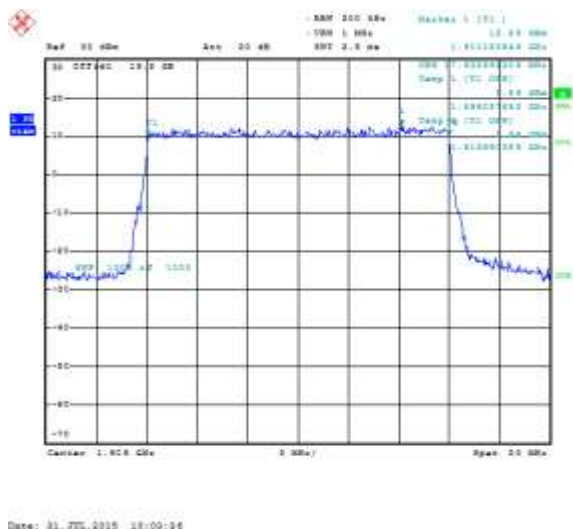



Figure 10-24a: Occupied Bandwidth, Band 25 High Channel, 20MHz BW, RB=100

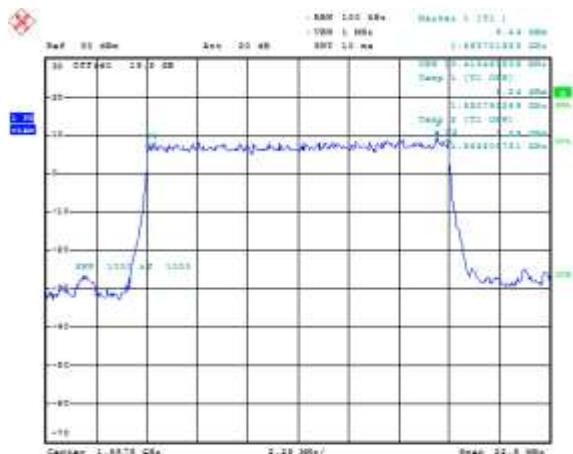


	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-25a: Occupied Bandwidth, Band 25

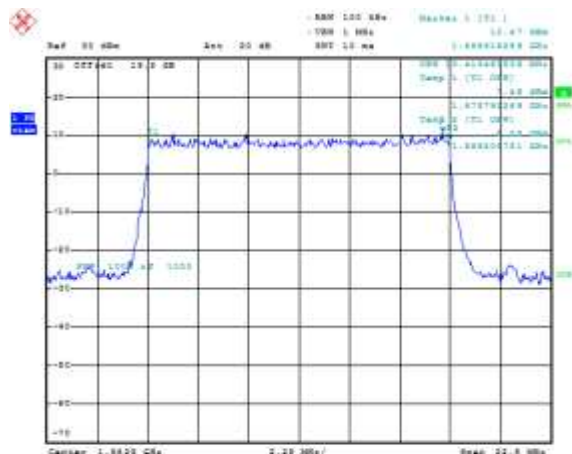
Low Channel, 15MHz BW, RB=75



Date: 31-Jul-2015 18:04:33

Figure 10-26a: Occupied Bandwidth, Band 25

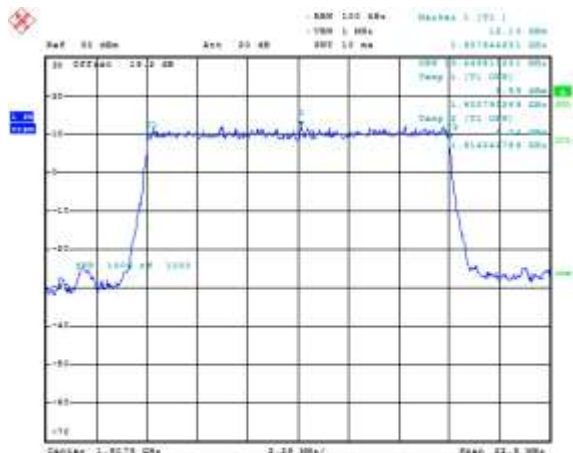
Middle Channel, 15MHz BW, RB=75




Date: 31-Jul-2015 18:05:33

Figure 10-27a: Occupied Bandwidth, Band 25 High

Channel, 15MHz BW, RB=75



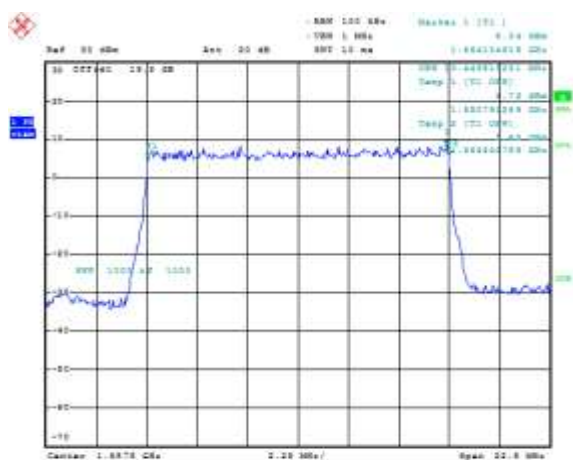
Date: 31-Jul-2015 18:06:33

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

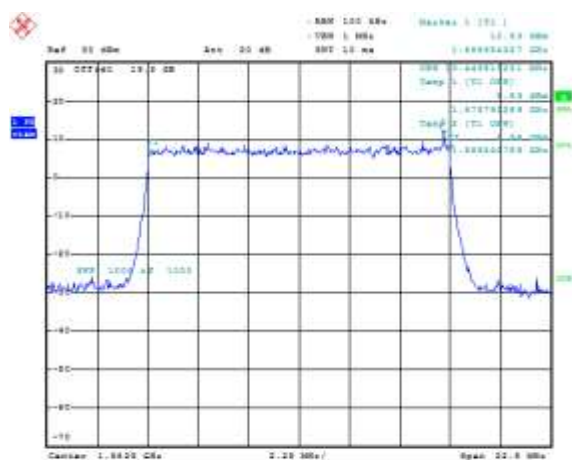
Figure 10-28a: Occupied Bandwidth, Band 25

Low Channel, 15MHz BW, RB=75



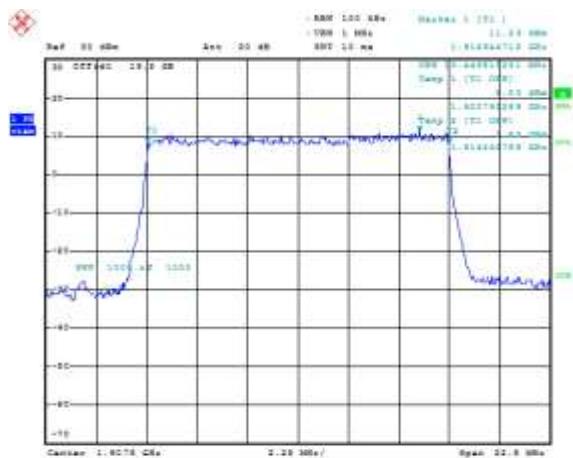
Date: 31. JUL. 2015 18:06:10

Figure 10-29a: Occupied Bandwidth, Band 25 Middle Channel, 15MHz BW, RB=75




Date: 31. JUL. 2015 18:07:10

Figure 10-30a: Occupied Bandwidth, Band 25 High Channel, 15MHz BW, RB=75



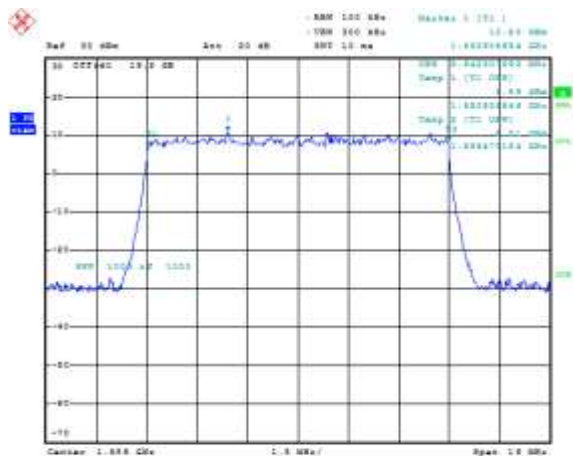
Date: 31. JUL. 2015 18:08:10

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-31a: Occupied Bandwidth, Band 25

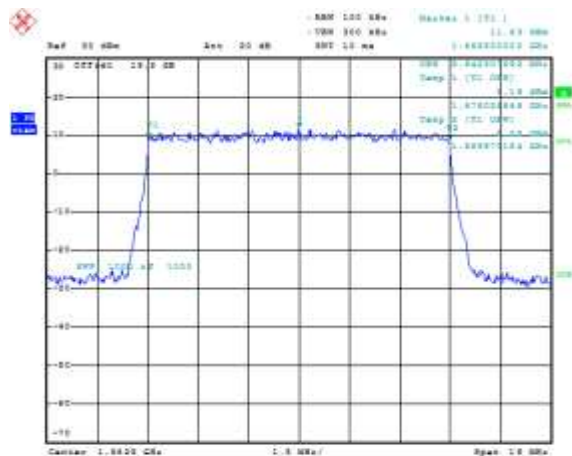
Low Channel, 10MHz BW, RB=50



Date: 31-Jul-2015 18:09:16

Figure 10-32a: Occupied Bandwidth, Band 25

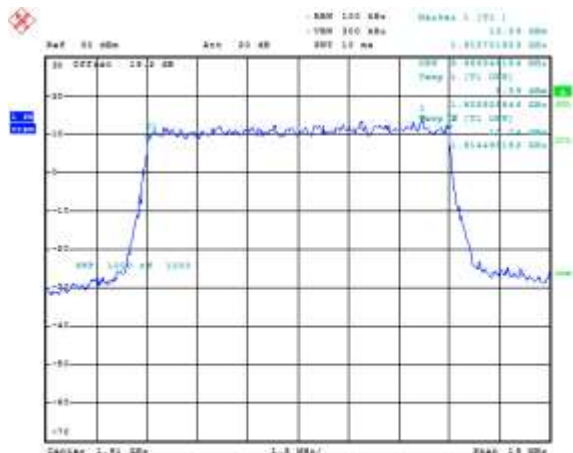
Middle Channel, 10MHz BW, RB=50




Date: 31-Jul-2015 18:09:42

Figure 10-33a: Occupied Bandwidth, Band 25 High

Channel, 10MHz BW, RB=50



Date: 31-Jul-2015 18:10:38

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-34a: Occupied Bandwidth, Band 25

Low Channel, 10MHz BW, RB=50

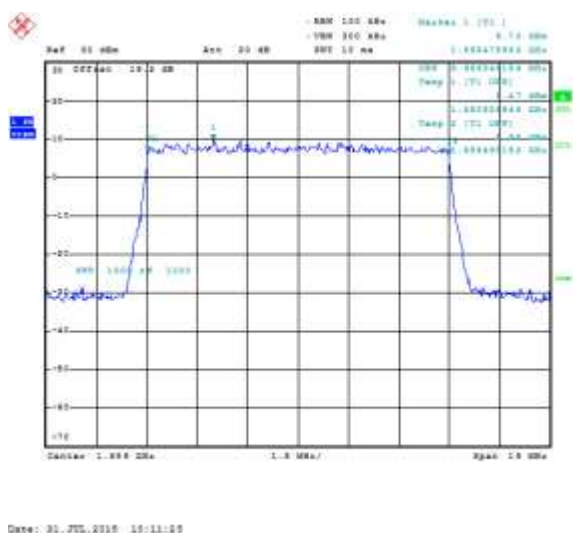


Figure 10-35a: Occupied Bandwidth, Band 25

Middle Channel, 10MHz BW, RB=50

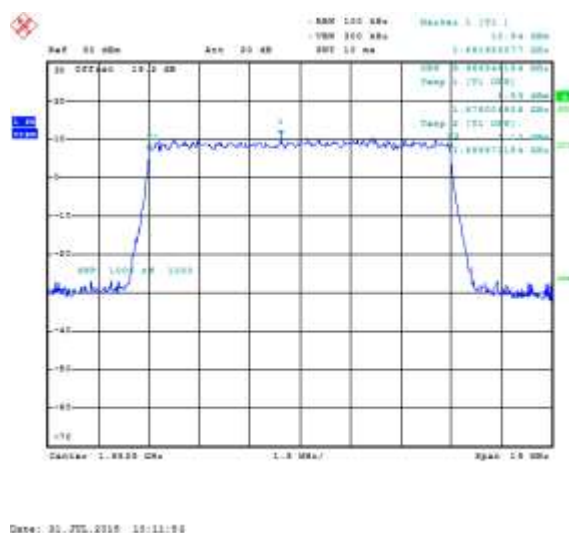
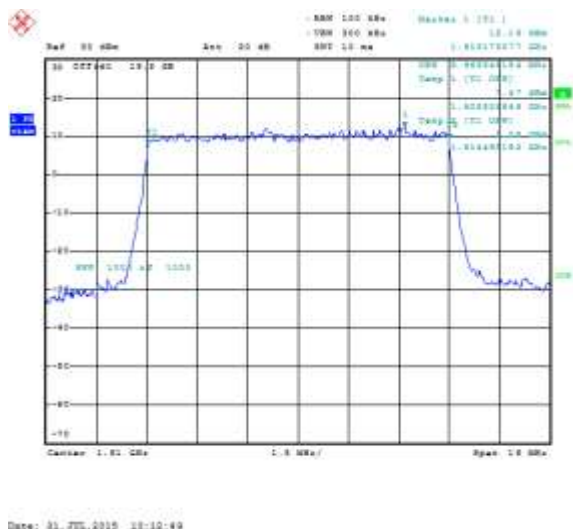


Figure 10-36a: Occupied Bandwidth, Band 25 High


Channel, 10MHz BW, RB=50



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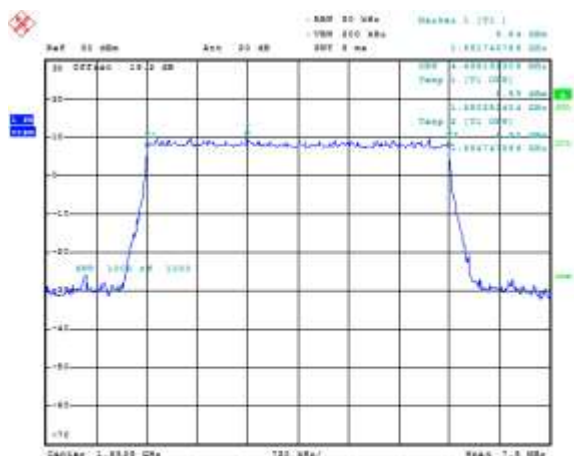
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Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-37a: Occupied Bandwidth, Band 25

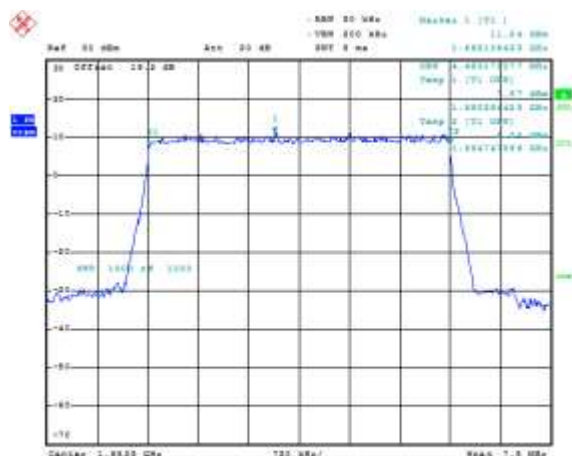
Low Channel, 5MHz BW, RB=25



Date: 31.JUL.2015 15:13:40

Figure 10-38a: Occupied Bandwidth, Band 25

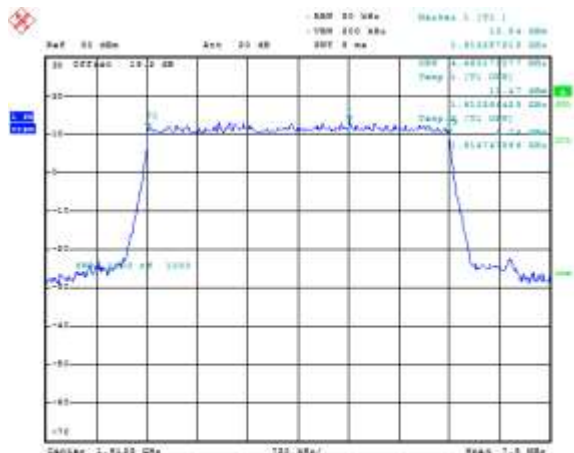
Middle Channel, 5MHz BW, RB=25




Date: 31.JUL.2015 15:14:00

Figure 10-39a: Occupied Bandwidth, Band 25 High

Channel, 5MHz BW, RB=25



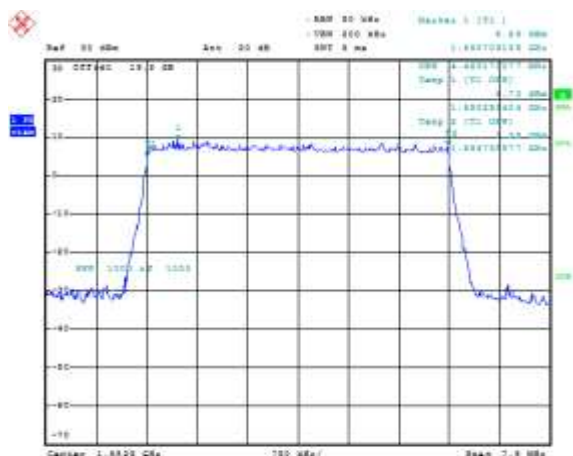
Date: 31.JUL.2015 15:14:40

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-40a: Occupied Bandwidth, Band 25

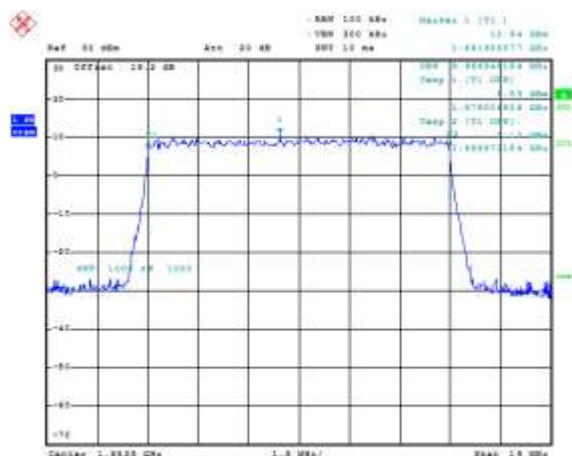
Low Channel, 5MHz BW, RB=25



Date: 31-Jul-2015 15:15:14

Figure 10-41a: Occupied Bandwidth, Band 25

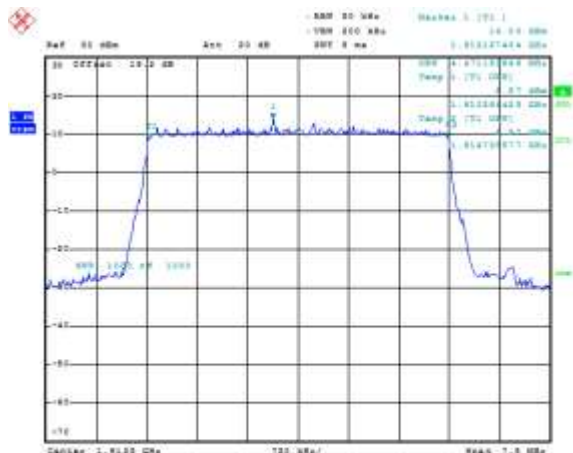
Middle Channel, 5MHz BW, RB=25




Date: 31-Jul-2015 15:15:15

Figure 10-42a: Occupied Bandwidth, Band 25 High

Channel, 5MHz BW, RB=25



Date: 31-Jul-2015 15:15:16

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-43a: Occupied Bandwidth, Band 25

Low Channel, 3MHz BW, RB=15

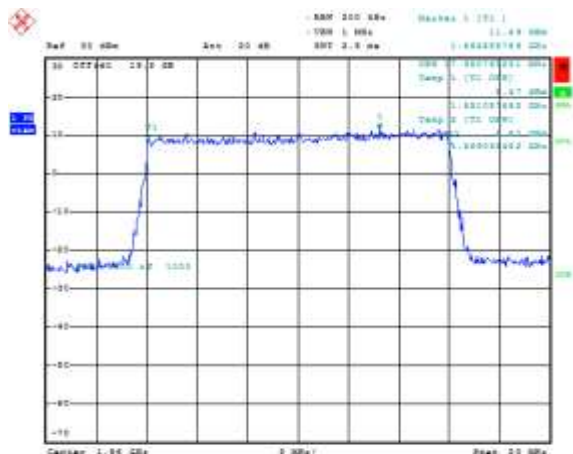


Figure 10-44a: Occupied Bandwidth, Band 25

Middle Channel, 3MHz BW, RB=15

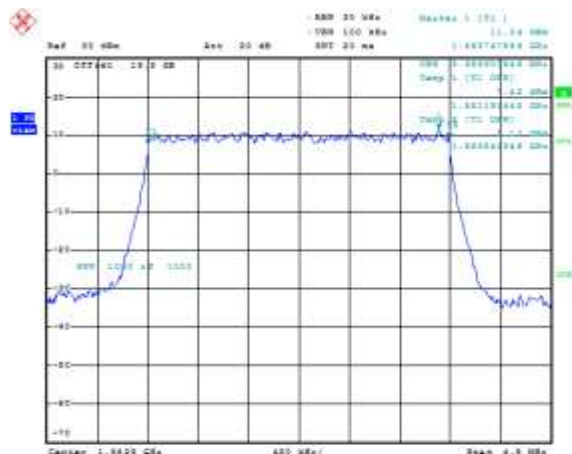
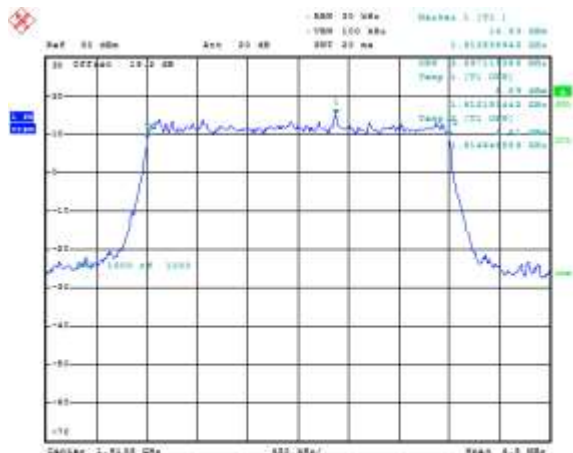



Figure 10-45a: Occupied Bandwidth, Band 25 High

Channel, 3MHz BW, RB=15



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-46a: Occupied Bandwidth, Band 25

Low Channel, 3MHz BW, RB=15

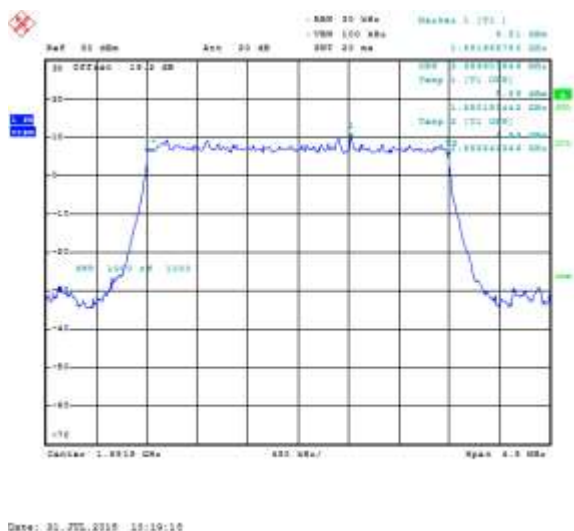


Figure 10-47a: Occupied Bandwidth, Band 25

Middle Channel, 3MHz BW, RB=15

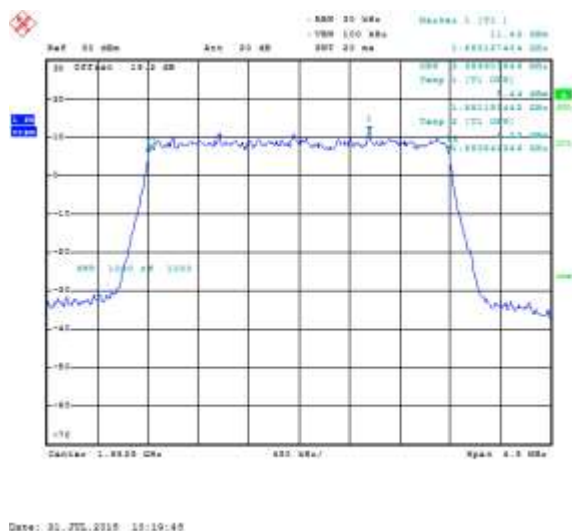
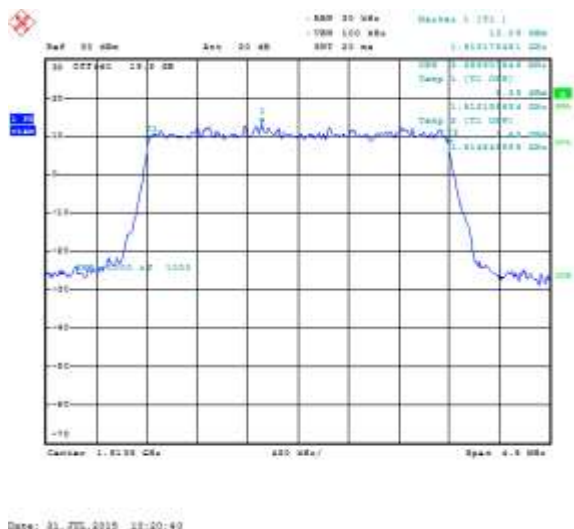


Figure 10-48a: Occupied Bandwidth, Band 25 High


Channel, 3MHz BW, RB=15



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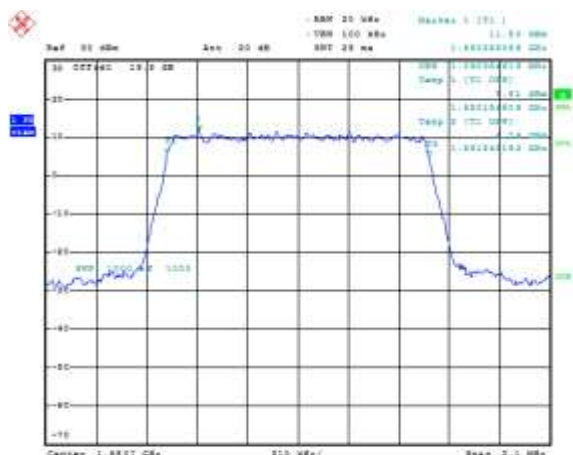
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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-49a: Occupied Bandwidth, Band 25

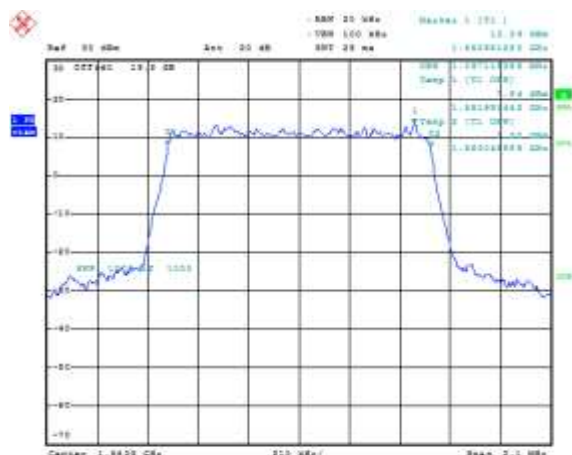
Low Channel, 1.4MHz BW, RB=6



Date: 31-Jul-2015 18:21:42

Figure 10-50a: Occupied Bandwidth, Band 25

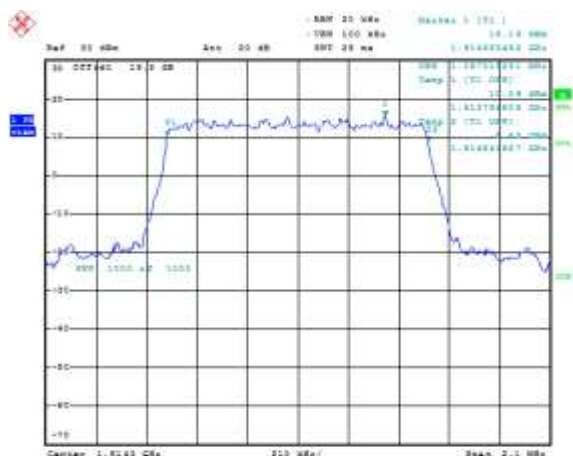
Middle Channel, 1.4MHz BW, RB=6



Date: 31-Jul-2015 18:22:20

Figure 10-51a: Occupied Bandwidth, Band 25 High

Channel, 1.4MHz BW, RB=60




Date: 31-Jul-2015 18:23:12

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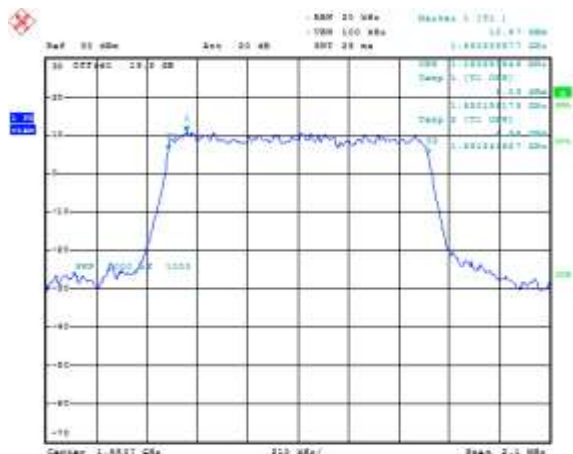
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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-52a: Occupied Bandwidth, Band 25

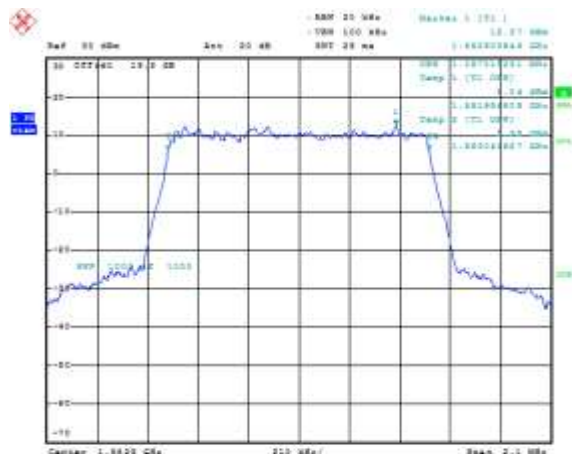
Low Channel, 1.4MHz BW, RB=6



Date: 31-Jul-2015 18:29:50

Figure 10-53a: Occupied Bandwidth, Band 25

Middle Channel, 1.4MHz BW, RB=6




Date: 31-Jul-2015 18:24:27

Figure 10-54a: Occupied Bandwidth, Band 25 High

Channel, 1.4MHz BW, RB=6

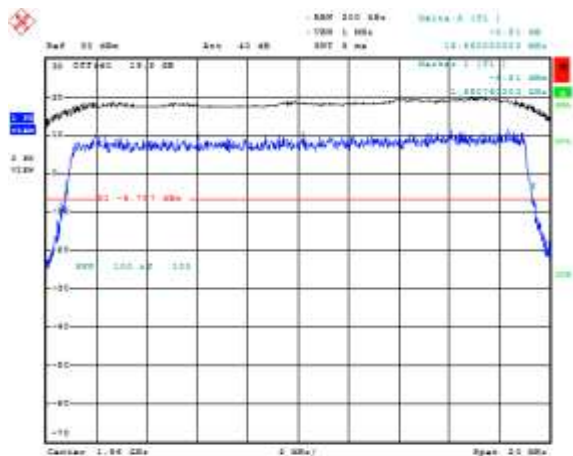


Date: 31-Jul-2015 18:29:50

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

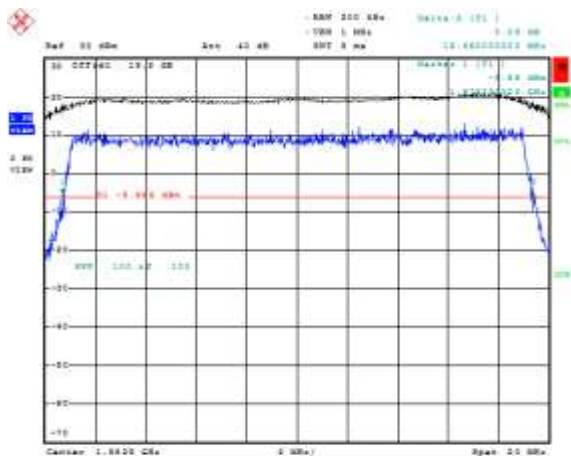
LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-55a: -26 dBc Bandwidth, Band 25 Low Channel, 20MHz BW, RB=100



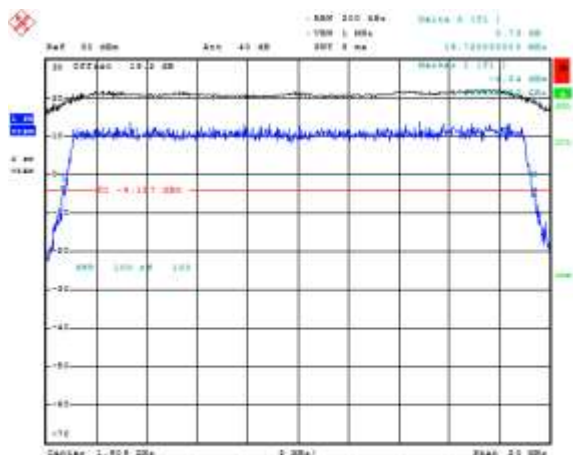
Date: 31.JUL.2015 11:02:28

Figure 10-56a: -26 dBc Bandwidth, Band 25 Middle Channel, 20MHz BW, RB=100



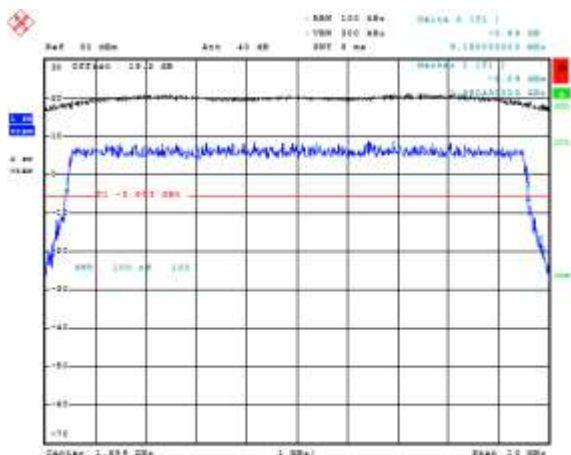
Date: 31.JUL.2015 11:02:36

Figure 10-57a: -26 dBc Bandwidth, Band 25 High Channel, 20MHz BW, RB=100




Date: 31.JUL.2015 11:02:38

Figure 10-58a: -26 dBc Bandwidth, Band 25 Low Channel, 10MHz BW, RB=50

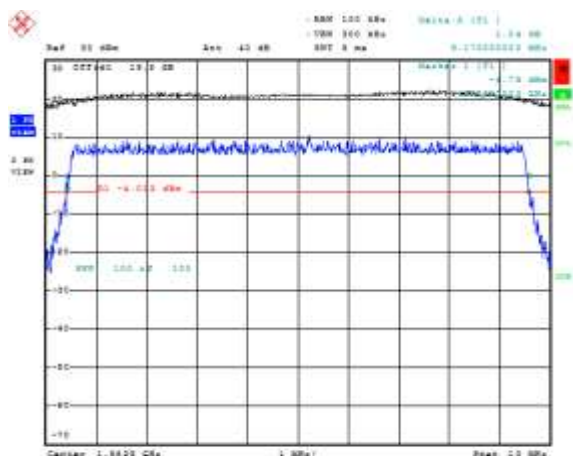


Date: 31.JUL.2015 11:09:18

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

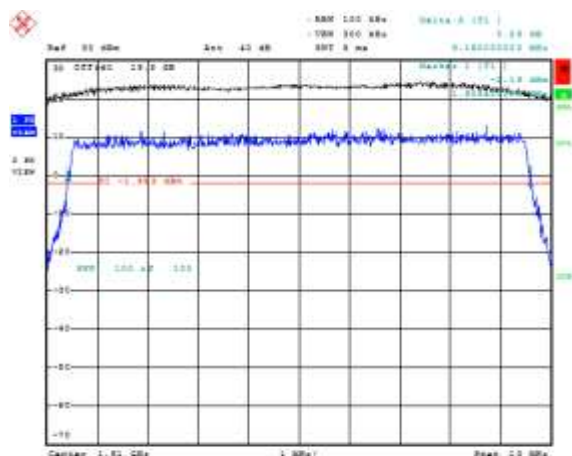
LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-59a: -26 dBc Bandwidth, Band 25 Middle Channel, 10MHz BW, RB=50



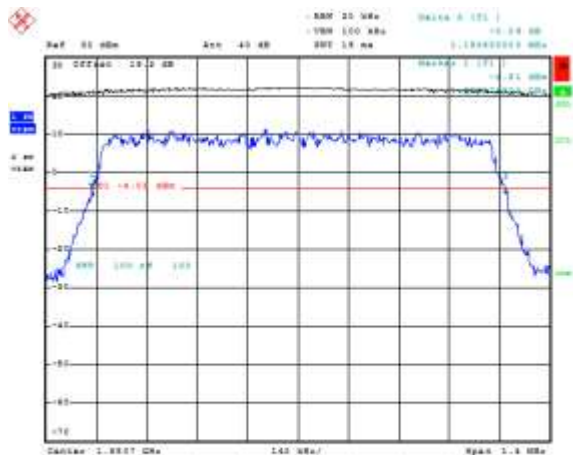
Date: 31.JUL.2015 11:09:55

Figure 10-60a: -26 dBc Bandwidth, Band 25 High Channel, 10MHz BW, RB=50



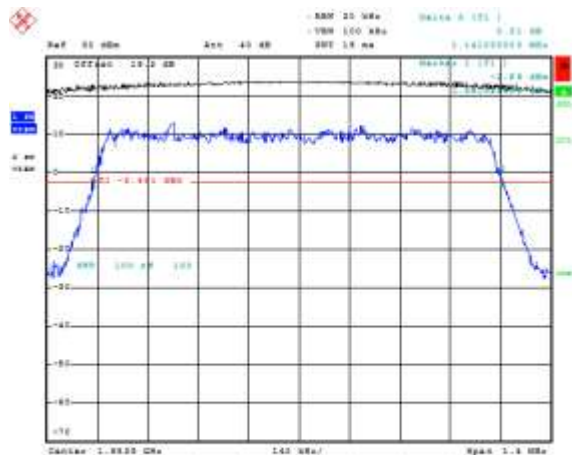
Date: 31.JUL.2015 11:09:58

Figure 10-61a: -26 dBc Bandwidth, Band 25 Low Channel, 1.4MHz BW, RB=6



Date: 31.JUL.2015 11:04:57

Figure 10-62a: -26 dBc Bandwidth, Band 25 Middle Channel, 1.4MHz BW, RB=6



Date: 31.JUL.2015 11:04:58


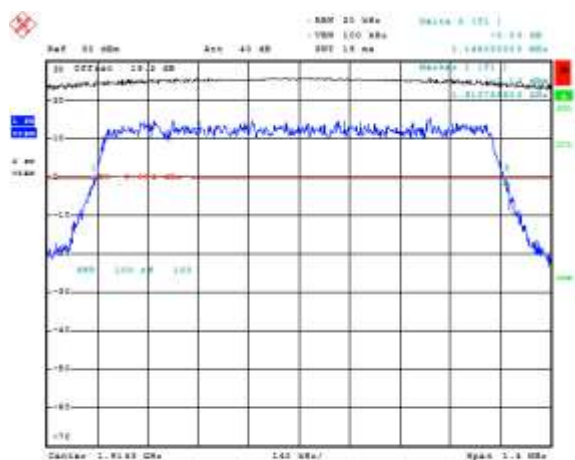
	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Figure 10-63a: -26 dBc Bandwidth, Band 25 High Channel, 1.4MHz BW, RB=6



Date: 30.07.2015 11:06:39


	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Figure 10-64a: Band 25 Low Channel Mask, 20MHz BW, RB=100

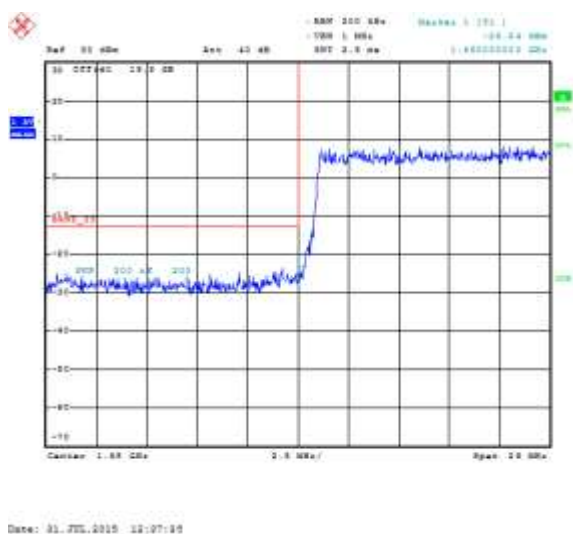


Figure 10-65a: Band 25 High Channel Mask, 20MHz BW, RB=100

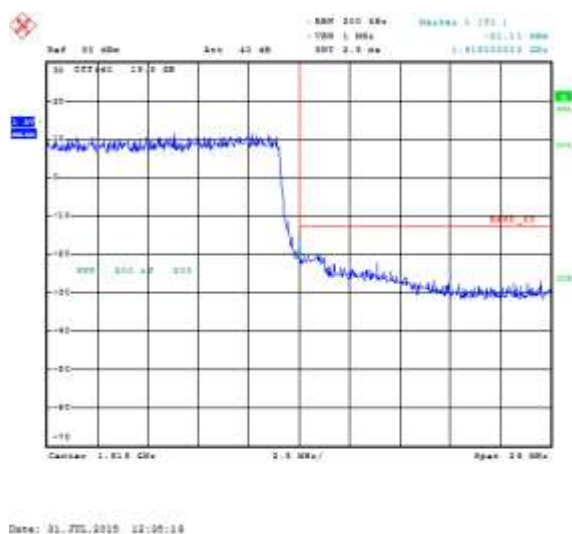


Figure 10-66a: Band 25 Low Channel Mask, 20MHz BW, RB=1

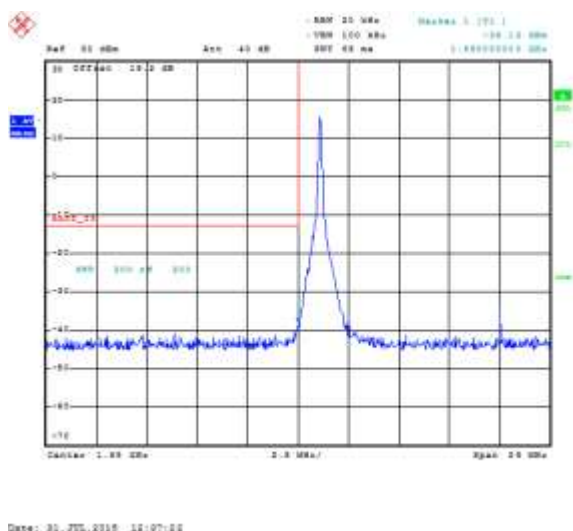
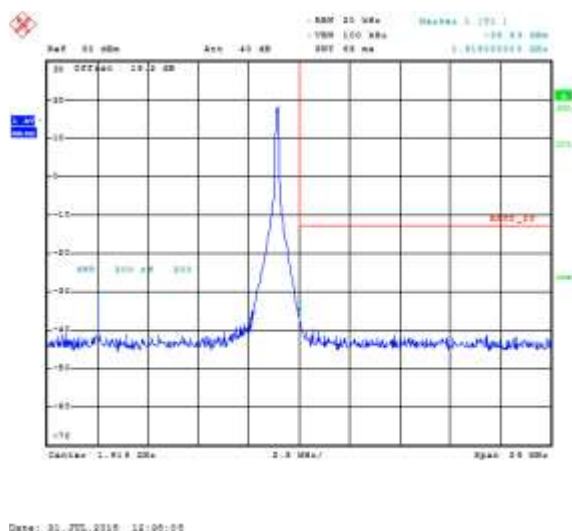


Figure 10-67a: Band 25 High Channel Mask, 20MHz BW, RB=1




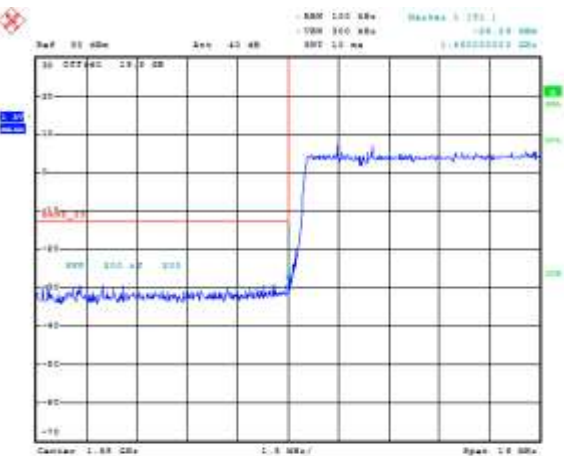
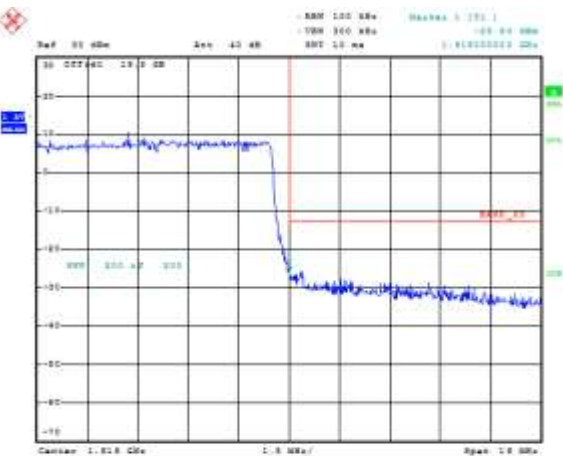
	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Figure 10-68a: Band 25 Low Channel Mask, 10MHz BW, RB=50




Date: 31.JUL.2015 12:09:00

Figure 10-69a: Band 25 High Channel Mask, 10MHz BW, RB=50

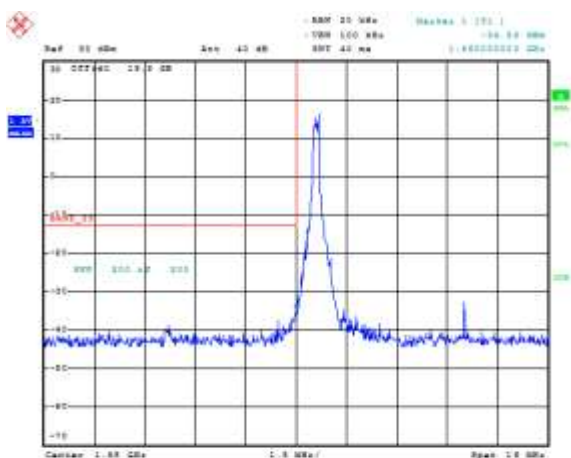


Date: 31.JUL.2015 12:09:00

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

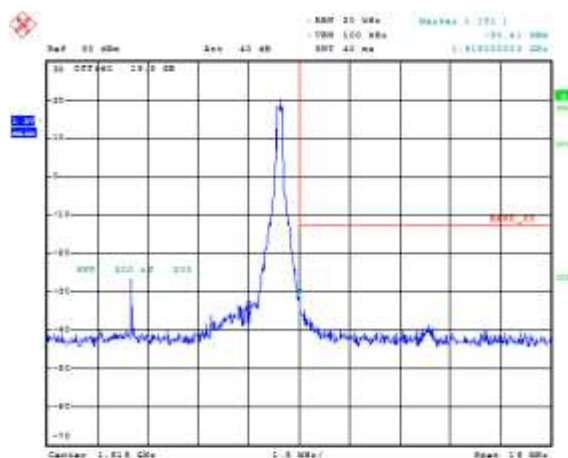
LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-70a: Band 25 Low Channel Mask, 10MHz BW, RB=1



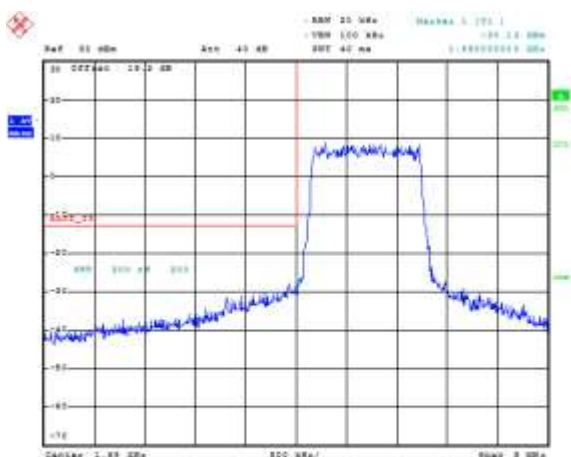
Date: 31-Jul-2015 12:00:46

Figure 10-71a: Band 25 High Channel Mask, 10MHz BW, RB=1



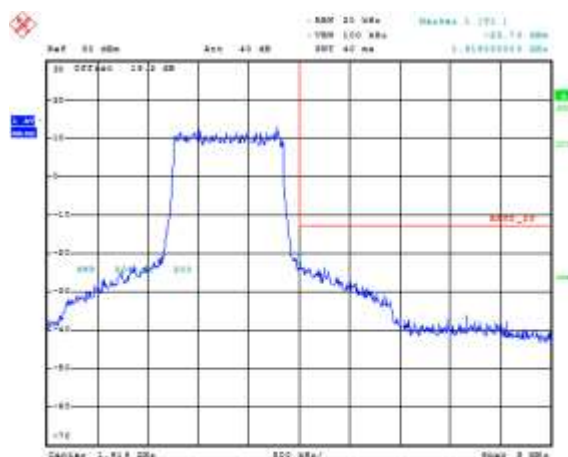
Date: 31-Jul-2015 12:00:52

Figure 10-72a: Band 25 Low Channel Mask, 1.4MHz BW, RB=6



Date: 31-Jul-2015 12:00:58

Figure 10-73a: Band 25 High Channel Mask, 1.4MHz BW, RB=6



Date: 31-Jul-2015 12:00:58


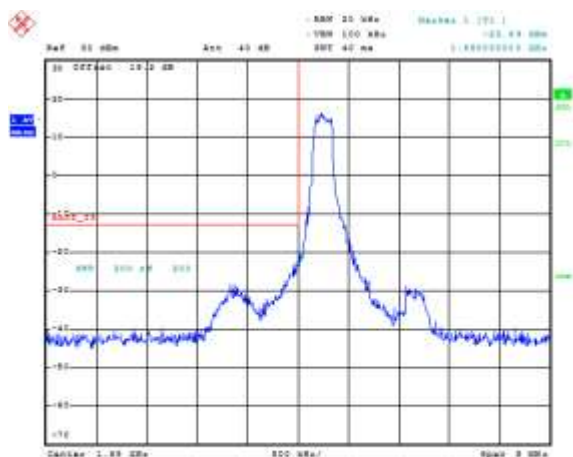
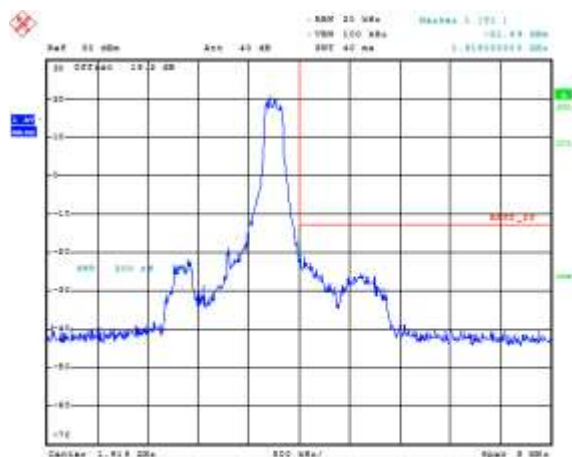
	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Figure 10-74a: Band 25 Low Channel Mask, 1.4MHz BW, RB=1



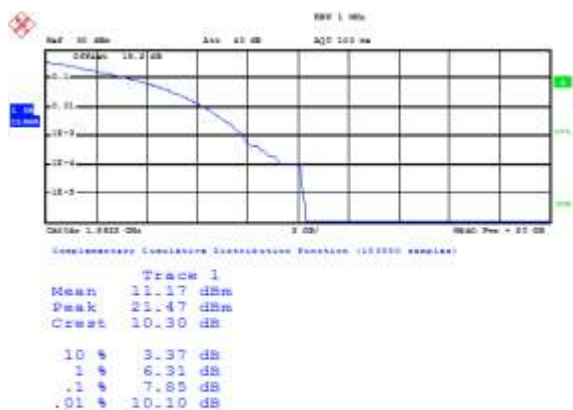
Date: 31.JUL.2015 12:40:50

Figure 10-75a: Band 25 High Channel Mask, 1.4MHz BW, RB=1



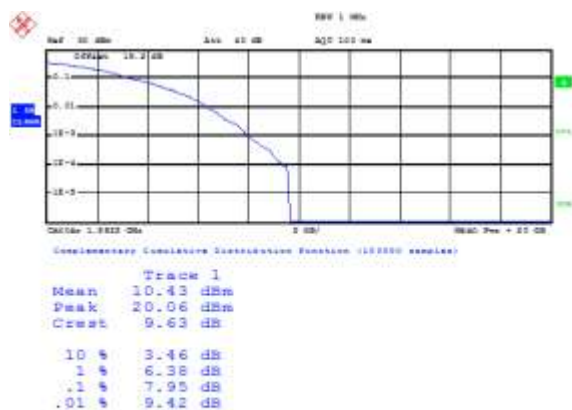
Date: 31.JUL.2015 12:40:54

Figure 10-76a: Band 25 Mid Channel PAR, 20MHz BW, RB=50




Date: 31.JUL.2015 15:16:51

Figure 10-77a: Band 25 Middle Channel PAR, 20MHz BW, RB=100



Date: 31.JUL.2015 15:17:11

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 25 Conducted RF Emission Test Data cont'd

Figure 10-78a: Band 25 Mid Channel PAR, 10MHz BW, RB=25



Figure 10-79a: Band 25 Mid Channel PAR, 10MHz BW, RB=50



Figure 10-80a: Band 25 Mid Channel PAR, 1.4MHz BW, RB=3

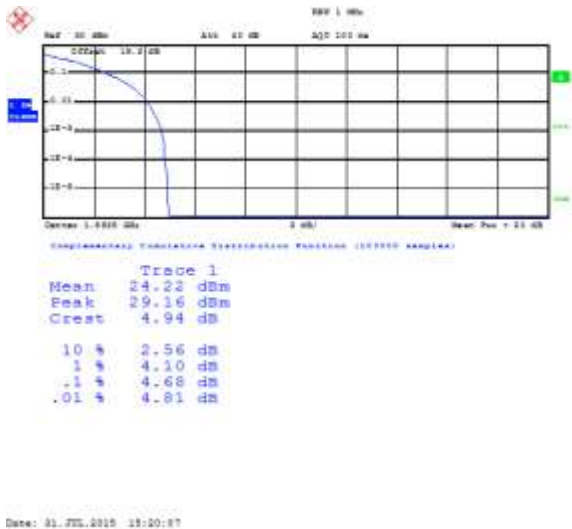


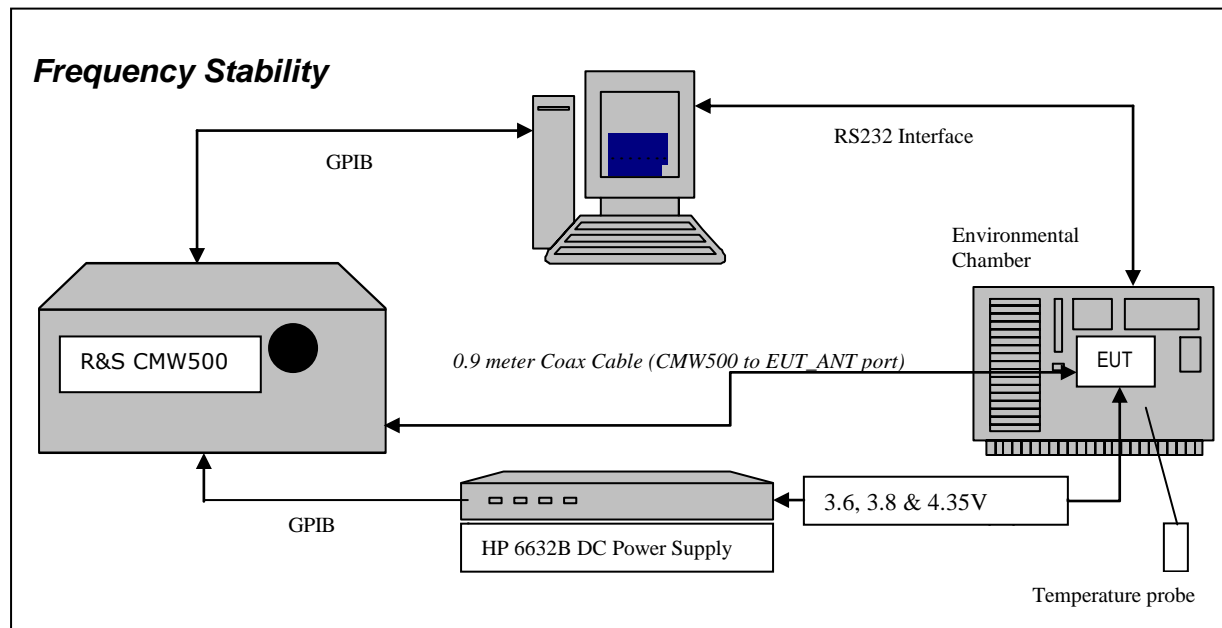
Figure 10-81a: Band 25 Mid Channel PAR, 1.4MHz BW, RB=6



APPENDIX 10B – LTE Band 25 FREQUENCY STABILITY TEST DATA

BlackBerry	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

LTE Band 25 Frequency Stability Test Data



The following configurations were measured for model RHL211LW (STV100-3):

The following measurements were performed by Landon Martin.

CFR 47 Chapter 1 - Federal Communications Commission Rules

Part 2 Required Measurements


2.1055 Frequency Stability - Procedures

(a,b) Frequency Stability - Temperature Variation

(d) Frequency Stability - Voltage Variation

The EUT meets the requirements as stated in CFR 47 chapter 1, Section 27.54, Frequency Stability.

Frequency Stability measurement devices were configured as presented in the block diagram recording frequency, power, data, temperatures, and stepped voltages controlled via a GPIB interface linked to the Environmental chamber, a DC power supply, and the Communications Test Set. A 0.9-metre coax cable was calibrated to characterize the insertion loss for the transmitted frequencies between the RF input/output of the CMW 500 and the EUT antenna port.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

Test Setup:

The EUT was placed in the Temperature chamber and connected to CMW 500 outside as shown in the figure above. Dry air was pumped inside the temperature chamber to maintain a backpressure during the test. The EUT was kept in the off condition at all times except when the following measurements were to be made.


The chamber was switched on and the temperature was set to -30°C. After the chamber stabilized at -30 °C there was a soak period of one hour to alleviate moisture in the chamber, the EUT voltage was enabled. The system software recorded the frequency, power, and associated measurements.

A Computer system controlled the automated software. This application was given the command of activating all machines intrinsic to the temperature and voltage tests controlling the CMW 500 via the GPIB Bus. The Environmental Chamber was instructed through an RS-232 serial line. The EUT dialogue was passed through a serial connection.

The EUT repetitively transmitted 100 bursts for each set of programmed parameters recording temperature, voltage settings, and systematically selected frequencies. The power supply was cycled from minimum voltage 3.6 volts, 3.8 volts and to 4.35 volts maximum voltage. The frequency error was measured at a maximum output power and recorded by the automated system test software.

The EUT output power and frequency was measured at 3.6 volts, 3.8 volts and 4.35 volts. The transmit frequency was measured on 1882.5MHz for 10MHz bandwidth with maximum (50) RB. The transmit frequency was varied in 3 steps consisting of 779.5 MHz, 1882.5.0 MHz and 784.5 MHz each was measured under 5 MHz bandwidth with maximum (25) RBs. This frequency was recorded in MHz and deviation from nominal, in Parts Per Million.

After the initial one-hour soak at the beginning of the tests, a period of thirty minutes soak was initialized between each ascending temperature step, before proceeding to the next measurement test cycle.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,


Procedure:

The test system software for commencing the Frequency Stability Tests carried through the following cycle.

113. Switch on the HP 6632B power supply; CMW 500 Communications test Set, and Environmental Chamber.
114. Start test program
115. Set the Temperature to –30°C and maintain a period of one- hour soak time, with the EUT supply voltage disabled.
116. Set power supply voltage to 3.6 volts.
117. Set up CMW 500 Radio Communication Tester.
118. Command the CMW 500 to switch to the low channel.
119. Enable the voltage to the EUT, and connect a link to the CMW 500 test set.
120. EUT is commanded to Transmit 100 Bursts.
121. Software logs the following data from the CMW 500, power supply and temperature chamber: Traffic Channel Number, Traffic Channel Frequency, Power Level, Chamber Temperature, Supply Voltage, Power and Frequency Error.
122. The CMW 500 commands the EUT to change frequency to the middle channel and high channel and repeats steps 7 to 9.
123. Repeat steps 5 to 10 changing the supply voltage to 3.8 Volts
124. Increase temperature by 10°C and soak for 1/2 hour.
125. Repeat steps 4 - 12 for temperatures –30°C to 60°C.
126. Repeat steps 5 to 10 changing the supply voltage to 4.35 volts

Procedure 5 to 10 was repeated at room temperature (20°C) with the power supply voltage set to 3.6, 3.8 and 4.35 volts


The maximum frequency error in the LTE Band 25 measured was **0.0099 PPM**.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

Date of test: August 25, 2015

LTE Band 25 results (10MHz Bandwidth): channels 23230 @ 20°C maximum transmitted power

Traffic Channel Number	LTE Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	1882.5.00	3.6	20	6.17	0.0079
23230	1882.5.00	3.8	20	5.97	0.0076
23230	1882.5.00	4.35	20	5.75	0.0074

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

LTE Band 25 Results (10MHz Bandwidth): channel 23230 @ maximum transmitted power

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	1882.5	3.6	-30	6.77	0.0087
23230	1882.5	3.6	-20	5.28	0.0068
23230	1882.5	3.6	-10	7.30	0.0093
23230	1882.5	3.6	0	5.09	0.0065
23230	1882.5	3.6	10	5.65	0.0072
23230	1882.5	3.6	20	6.17	0.0079
23230	1882.5	3.6	30	-2.65	-0.0034
23230	1882.5	3.6	40	6.55	0.0084
23230	1882.5	3.6	50	2.32	0.0030
23230	1882.5	3.6	60	3.95	0.0050

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	1882.5	3.8	-30	7.22	0.0092
23230	1882.5	3.8	-20	5.06	0.0065
23230	1882.5	3.8	-10	6.32	0.0081
23230	1882.5	3.8	0	5.38	0.0069
23230	1882.5	3.8	10	7.65	0.0098
23230	1882.5	3.8	20	5.97	0.0076
23230	1882.5	3.8	30	-2.90	-0.0037
23230	1882.5	3.8	40	5.22	0.0067
23230	1882.5	3.8	50	4.71	0.0060
23230	1882.5	3.8	60	-3.02	-0.0039

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
23230	1882.5	4.35	-30	7.74	0.0099
23230	1882.5	4.35	-20	6.01	0.0077
23230	1882.5	4.35	-10	6.18	0.0079
23230	1882.5	4.35	0	4.85	0.0062
23230	1882.5	4.35	10	6.01	0.0077
23230	1882.5	4.35	20	5.75	0.0074
23230	1882.5	4.35	30	2.12	0.0027
23230	1882.5	4.35	40	5.74	0.0073
23230	1882.5	4.35	50	-3.30	-0.0042
23230	1882.5	4.35	60	-2.06	-0.0026

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APPENDIX 10C – LTE Band 25 RADIATED EMISSIONS TEST DATA

BlackBerry	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 10C	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Radiated Power Test Data Results

The following configurations were measured for model RHL211LW (STV100-3):

The following measurements were performed by Shiva Kumbham.

Date of Test: August 14, 2015

The environmental tests conditions were: Temperature: 26.0 °C
Relative Humidity: 35.4 %

The BlackBerry® smartphone was standalone, with horizontal top pointing up the RX antenna when the turntable is at 0 degree position.


LTE Band 25, 1.4MHz BW, RB=1, QPSK modulation

EUT				Rx Antenna		Spectrum Analyzer		Substitution Method					
						Analyzer		Tracking Generator					
Type	Ch	Frequency (MHz)	Band	Type	Pol.	Read ing (dBm)	Max (V, H) (dBm)	Pol. Tx-Rx	Reading (dBm)	Corrected Reading (relative to Dipole)		Li mit (dBm)	Diff. To Limit (dB)
										(dB m)	(W)		
F0	26047	1850.70	25	Horn	V	-25.81	-24.16	V-V	-12.49	27.84	0.61	33.00	5.16
F0	26047	1850.70	25	Horn	H	-24.16		H-H	-11.66				
F0	26365	1882.50	25	Horn	V	-25.97	-25.10	V-V	-13.36	27.13	0.52	33.00	5.87
F0	26365	1882.50	25	Horn	H	-25.10		H-H	-12.31				
F0	26683	1914.30	25	Horn	V	-27.24	-25.49	V-V	-12.42	27.32	0.54	33.00	5.68
F0	26683	1914.30	25	Horn	H	-25.49		H-H	-12.07				

LTE Band 25, 10MHz BW, RB=1, 16QAM modulation

EUT				Rx Antenna		Spectrum Analyzer		Substitution Method					
								Tracking Generator					
Type	Ch	Frequency (MHz)	Band	Type	Pol.	Reading (dBm)	Max (V, H) (dBm)	Pol. Tx-Rx	Reading (dBm)	Corrected Reading (relative to Dipole)		Limit (dBm)	Diff. To Limit (dB)
										(dBm)	(W)		
F0	26090	1855.00	25	Horn	V	-26.70	-25.81	V-V	-14.25	26.22	0.42	33.00	6.78
F0	26090	1855.00	25	Horn	H	-25.81		H-H	-13.28				
F0	26365	1882.50	25	Horn	V	-26.58	-25.95	V-V	-14.14	26.31	0.43	33.00	6.69
F0	26365	1882.50	25	Horn	H	-25.95		H-H	-13.13				
F0	26640	1910.00	25	Horn	V	-27.96	-26.55	V-V	-13.51	26.28	0.42	33.00	6.72
F0	26640	1910.00	25	Horn	H	-26.55		H-H	-13.11				

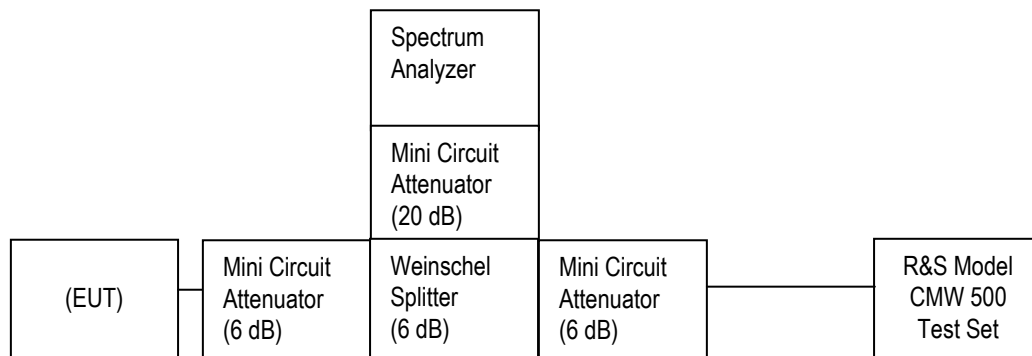
APPENDIX 11A – LTE Band 41 CONDUCTED RF EMISSIONS TEST DATA/PLOTS

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data

This appendix contains measurement data pertaining to conducted spurious emissions, 99% power bandwidth and the channel mask.

Test Setup Diagram




The following configurations were measured for model RHL211LW (STV100-3):

Date of Test: July 31, 2015

The environmental test conditions were: Temperature: 25.7 °C
 Relative Humidity: 35.6 %

The following measurements were performed by Sijia Li.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Emission Designator Table

Frequency Range (MHz)	Conducted Output Power (dBm)	Emission Designator	Band	Bandwidth (MHz)	Modulation
2498.5-2687.5	25.81	4M51G7D	LTE B41	5	QPSK
2498.5-2687.5	25.07	4M48D7W	LTE B41	5	16QAM
2501-2685	25.79	8M97G7D	LTE B41	10	QPSK
2501-2685	25.20	8M97D7W	LTE B41	10	16QAM
2503.5-2682.5	25.77	13M5G7D	LTE B41	15	QPSK
2503.5-2682.5	24.98	13M5D7W	LTE B41	15	16QAM
2506-2680	25.92	17M9G7D	LTE B41	20	QPSK
2506-2680	25.40	17M9D7W	LTE B41	20	16QAM

The following test configurations were measured on RHL211LW (STV100-3):

The conducted spurious emissions – As per 47 CFR 2.1051, 27.53(m), RSS-199, 4.6 were measured from 30 MHz to 20 GHz.

–26 dBc Bandwidth and Occupied Bandwidth (99%)

The modulation spectrum was measured by both methods of 99% power bandwidth and – 26 dBc bandwidth for each 5MHz, 10MHz and 20MHz with different number of RBs for LTE Band 41.


QPSK and 16-QAM modulations were applied to each of the bandwidths. Only the worst case measurements are documented in this report.

A minimum RB condition was also measured (RB = 1).

The resolution bandwidth required for out-of-band emissions in the 1 MHz bands immediately outside and adjacent to the frequency block, was determined to be at least 1% of the emission bandwidth.

The worst case –26dBc bandwidth for LTE Band 41 was measured to be 18.54 MHz.

Results were derived in a 100 kHz resolution bandwidth. On any frequency outside the frequency block and outside the adjacent 1 MHz bands, a resolution bandwidth of at least 1 MHz was applied.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Test Data for LTE Band 41 selected Frequencies in 20MHz BW (RB = 100)

LTE Band 41 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
2506	18.42	17.932
2593	18.54	17.932
2680	18.44	17.884

Test Data for LTE Band 41 selected Frequencies in 10MHz BW (RB = 50)

LTE Band 41 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
2506	9.17	8.966
2593	9.18	8.966
2680	9.17	8.966

Test Data for LTE Band 41 selected Frequencies in 5MHz BW (RB = 25)

LTE Band 41 Frequency (MHz)	26dBc Occupied Bandwidth (MHz)	99% Occupied Bandwidth (MHz)
2506	4.625	4.507
2593	4.68	4.483
2680	4.64	4.495

Peak to Average Ratio (PAR)

For each 1.4MHz, 10MHz and 20MHz with Resource Block allocation 100,50,25, 6 and 3 as per scalable bandwidths for LTE Band 41, the peak to average ratio was measured on the middle channel with QPSK modulation.

On any frequency outside the frequency block and outside the adjacent 1 MHz bands, a resolution bandwidth of at least 1 MHz was applied.

The worst case measured was 12.67dB on 20MHz bandwidth with Resource Block allocation 100 while transmitting at 2535 MHz.


Measurement Plots for LTE Band 41

See Figures 11-1a to 11-18a for the plots of the conducted spurious emissions.

See Figures 11-19a to 11-51a for the plots of 99% Occupied Bandwidth and -26 dBc Bandwidth.

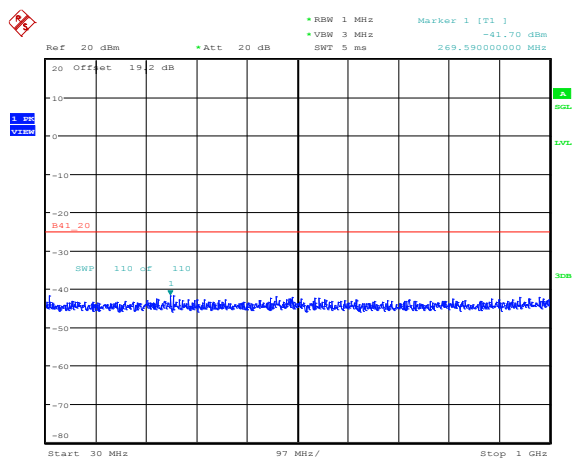
See Figures 11-52a to 11-63a for the plots of the Channel mask.

See Figures 11-64a to 11-69a for the plots of the Peak to Average Ratio.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

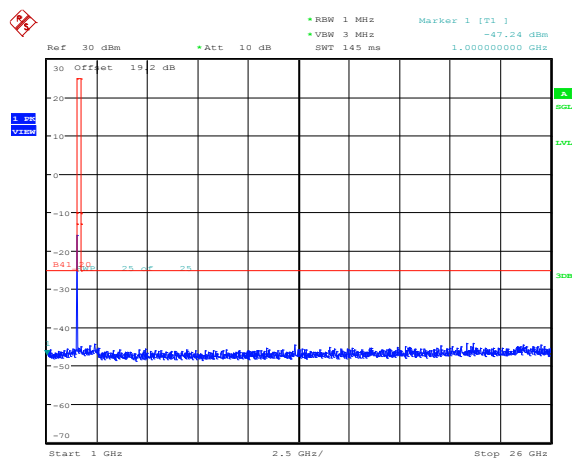
LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-1a: Band 41, Spurious Conducted Emissions, Low channel, 20MHz BW (RB= 1)



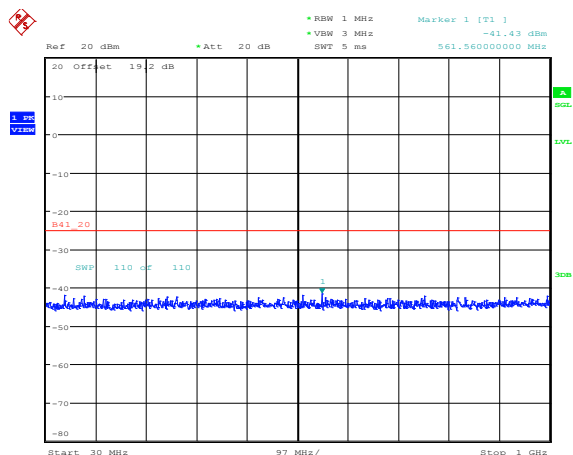
Date: 25.SEP.2015 19:28:45

Figure 11-2a: Band 41, Spurious Conducted Emissions, Low channel, 20MHz BW (RB= 1)



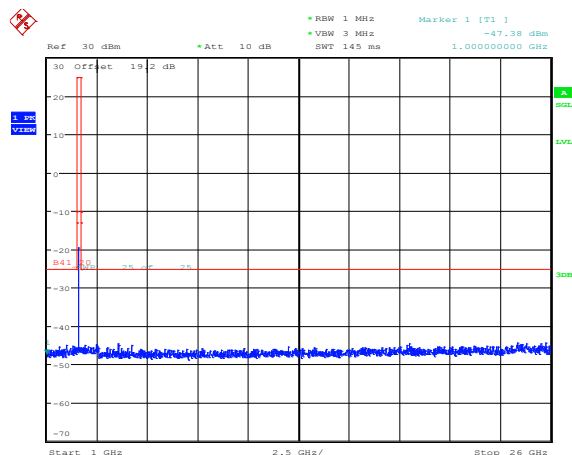
Date: 25.SEP.2015 19:28:56

Figure 11-3a: Band 41, Spurious Conducted Emissions, Middle channel, 20MHz BW (RB= 50)




Date: 25.SEP.2015 19:29:03

Figure 11-4a: Band 41, Spurious Conducted Emissions, Middle channel, 20MHz BW (RB= 50)

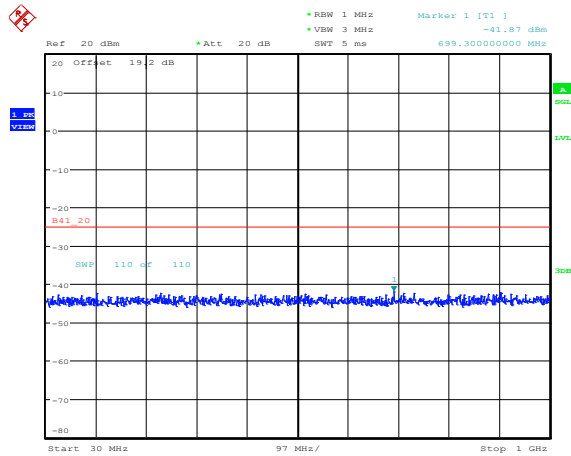


Date: 25.SEP.2015 19:29:14

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

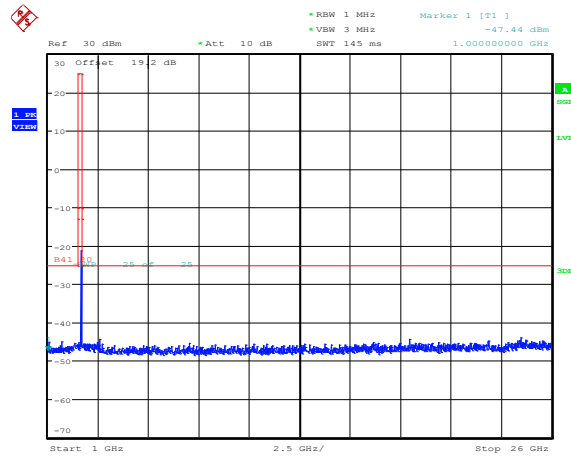
LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-5a: Band 41, Spurious Conducted Emissions, High Channel, 20MHz BW (RB= 100)



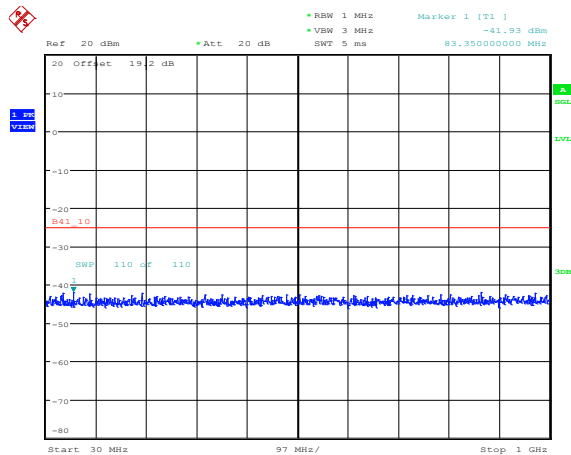
Date: 25.SEP.2015 19:29:22

Figure 11-6a: Band 41, Spurious Conducted Emissions, High Channel, 20MHz BW (RB= 100)



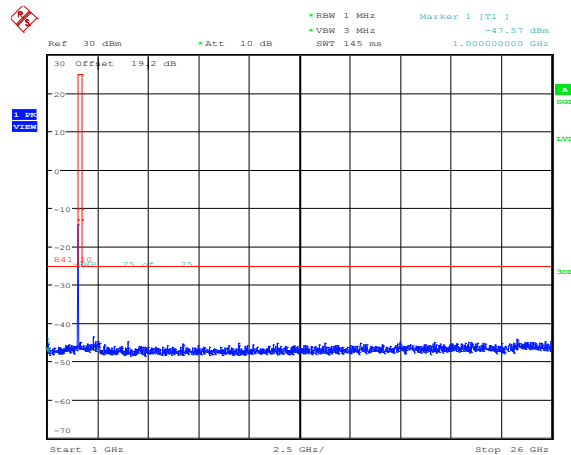
Date: 25.SEP.2015 19:29:32

Figure 11-7a: Band 41, Spurious Conducted Emissions, Low channel, 10MHz BW (RB= 1)




Date: 25.SEP.2015 19:31:53

Figure 11-8a: Band 41, Spurious Conducted Emissions, Low channel, 10MHz BW (RB= 1)

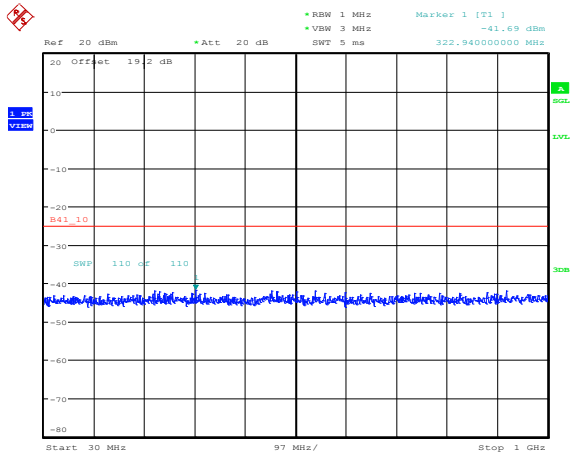


Date: 25.SEP.2015 19:32:03

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3)	
	APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

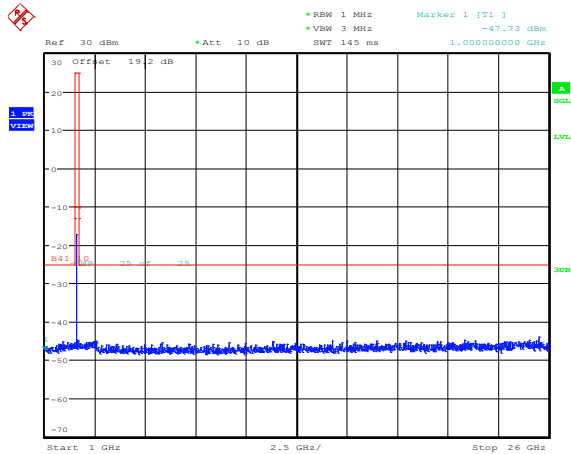
LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-9a: Band 41, Spurious Conducted Emissions, Middle Channel, 10MHz BW (RB= 30)



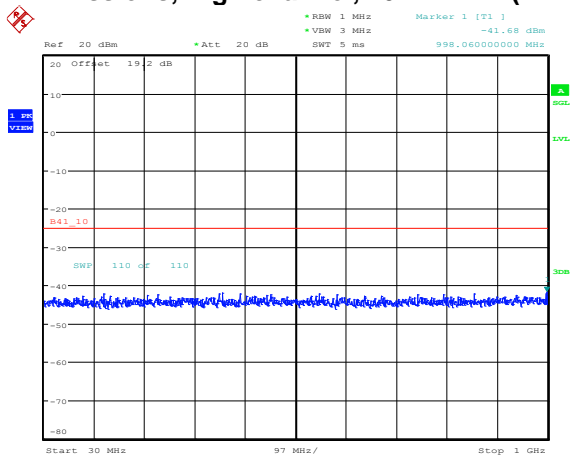
Date: 25.SEP.2015 19:32:11

Figure 11-10a: Band 41, Spurious Conducted Emissions, Middle Channel, 10MHz BW (RB= 30)



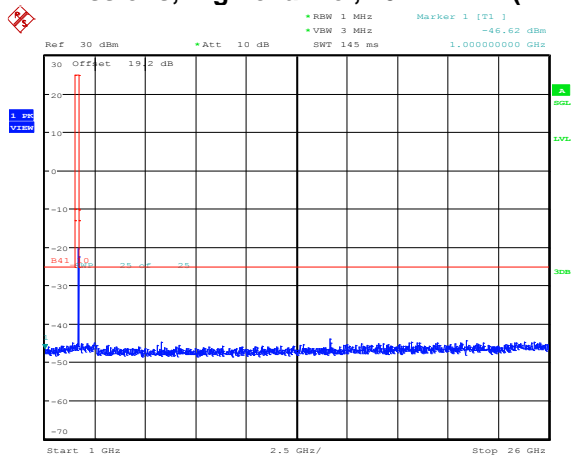
Date: 25.SEP.2015 19:32:22

Figure 11-11a: Band 41, Spurious Conducted Emissions, High channel, 10MHz BW (RB= 50)




Date: 25.SEP.2015 19:32:29

Figure 11-12a: Band 41, Spurious Conducted Emissions, High channel, 10MHz BW (RB= 50)



Date: 25.SEP.2015 19:32:40

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-13a: Band 41, Spurious Conducted Emissions, Low channel, 1.4MHz BW (RB= 1)

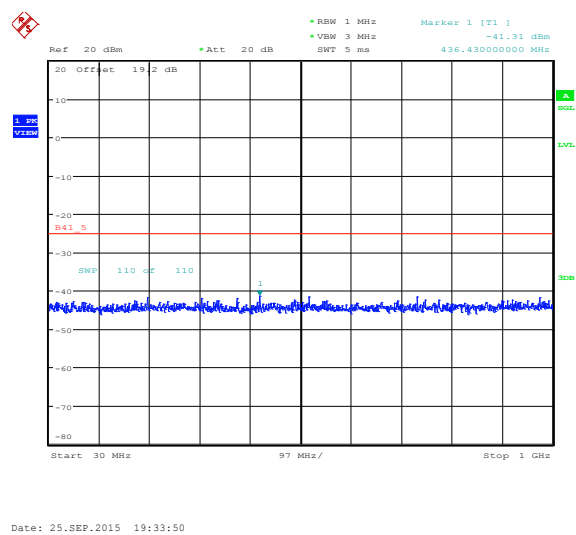
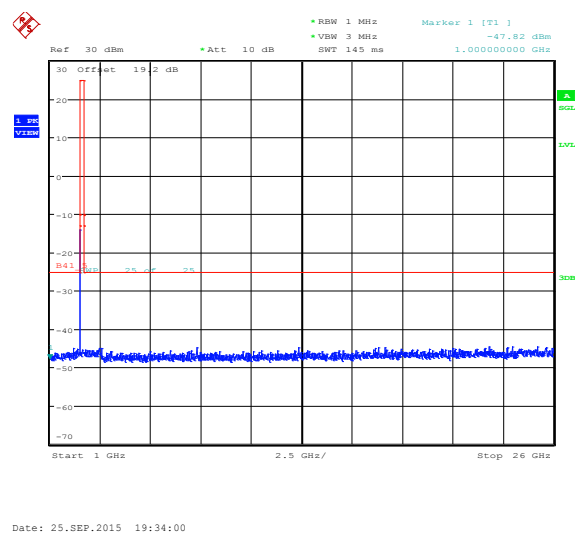



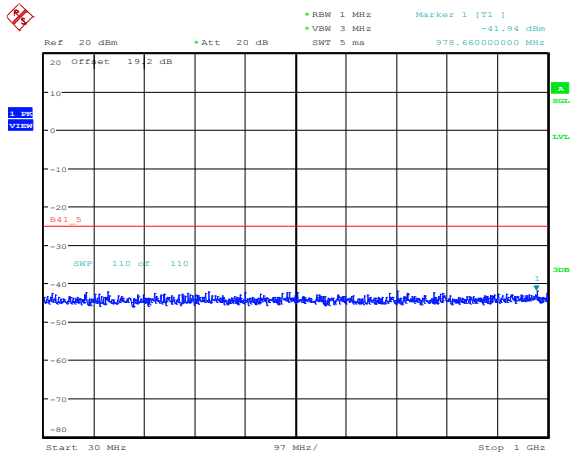
Figure 11-14a: Band 41, Spurious Conducted Emissions, Low channel, 1.4MHz BW (RB= 1)



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3)	
	APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

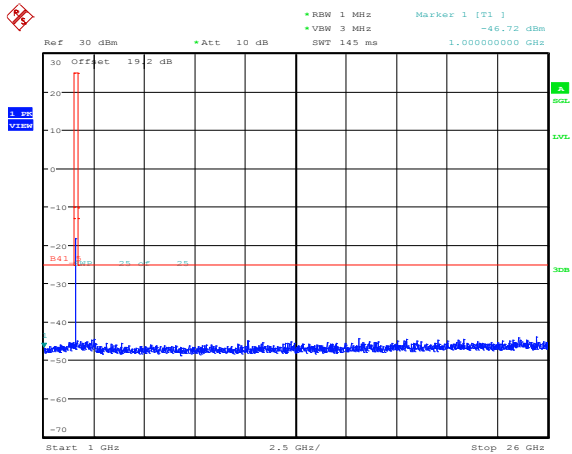
LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-15a: Band 41, Spurious Conducted Emissions, Middle Channel, 1.4MHz BW (RB= 15)



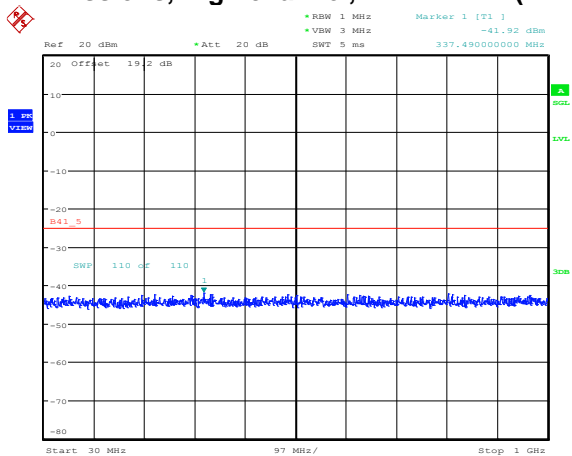
Date: 25.SEP.2015 19:34:08

Figure 11-16a: Band 41, Spurious Conducted Emissions, Middle Channel, 1.4MHz BW (RB= 15)



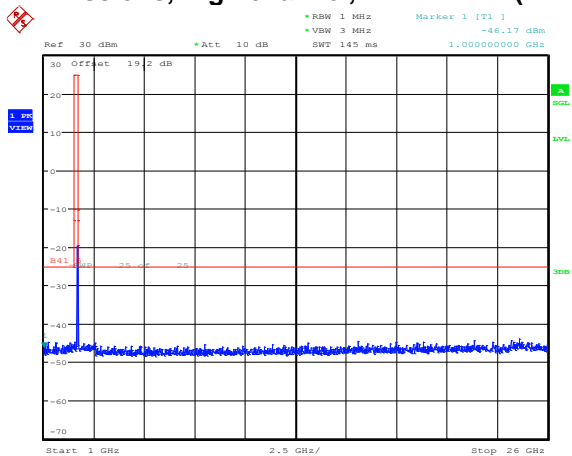
Date: 25.SEP.2015 19:34:19

Figure 11-17a: Band 41, Spurious Conducted Emissions, High channel, 1.4MHz BW (RB= 25)




Date: 25.SEP.2015 19:34:27

Figure 11-18a: Band 41, Spurious Conducted Emissions, High channel, 1.4MHz BW (RB= 25)



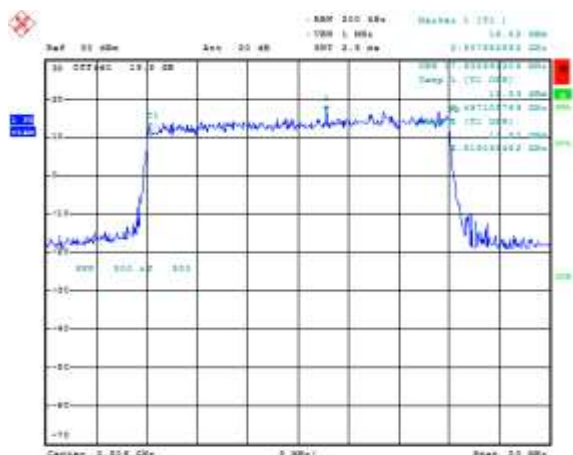
Date: 25.SEP.2015 19:34:37

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-19a: Occupied Bandwidth, Band 41

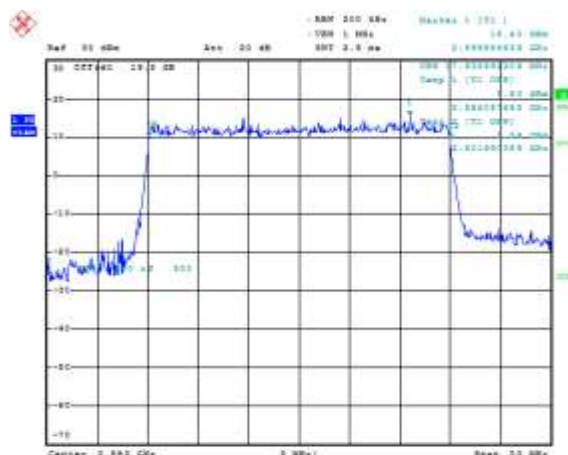
Low Channel, 20MHz BW, RB=100



Date: 8/26/2015 13:40:59

Figure 11-20a: Occupied Bandwidth, Band 41

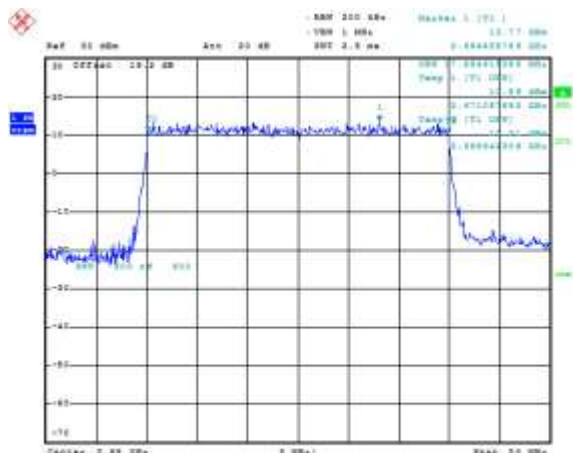
Middle Channel, 20MHz BW, RB=100



Date: 8/26/2015 13:40:59

Figure 11-21a: Occupied Bandwidth, Band 41 High

Channel, 20MHz BW, RB=100




Date: 8/26/2015 13:40:59

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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-22a: Occupied Bandwidth, Band 41

Low Channel, 20MHz BW, RB=100

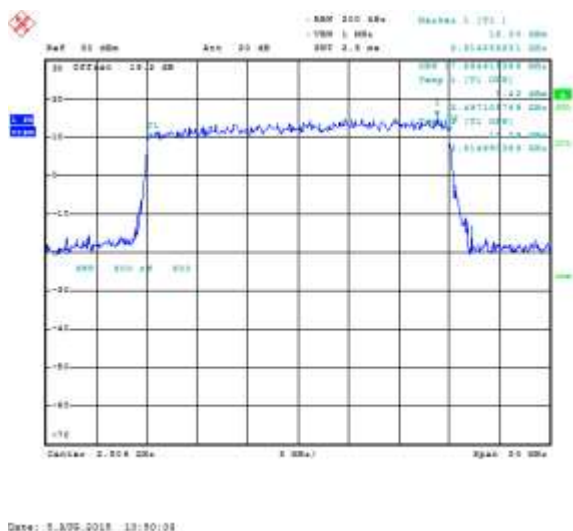


Figure 11-23a: Occupied Bandwidth, Band 41
Middle Channel, 20MHz BW, RB=100

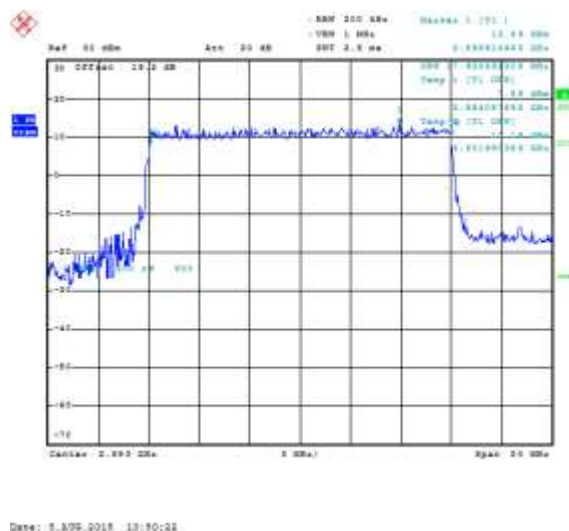
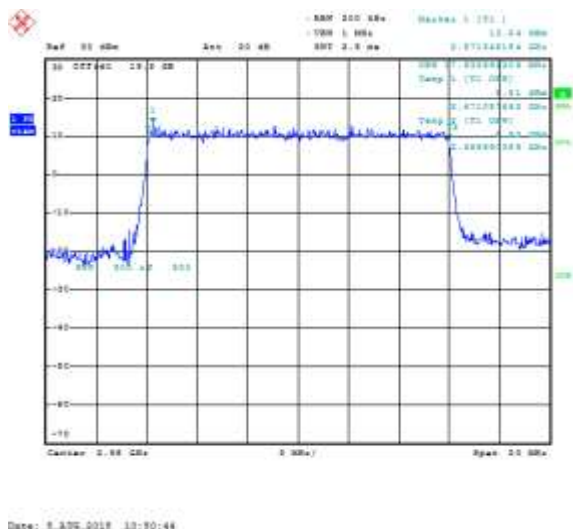



Figure 11-24a: Occupied Bandwidth, Band 41 High
Channel, 20MHz BW, RB=100



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-25a: Occupied Bandwidth, Band 41

Low Channel, 15MHz BW, RB=75

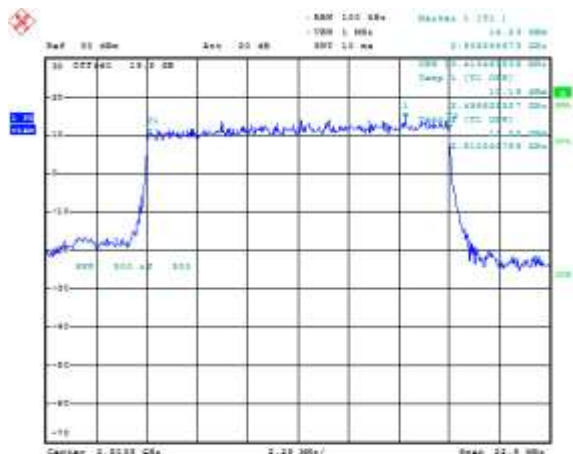


Figure 11-26a: Occupied Bandwidth, Band 41

Middle Channel, 15MHz BW, RB=75

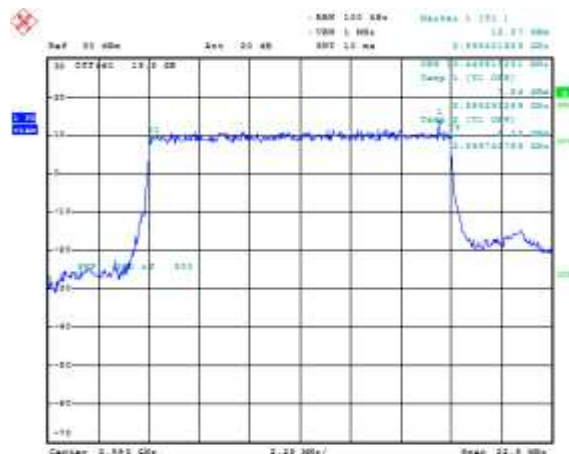
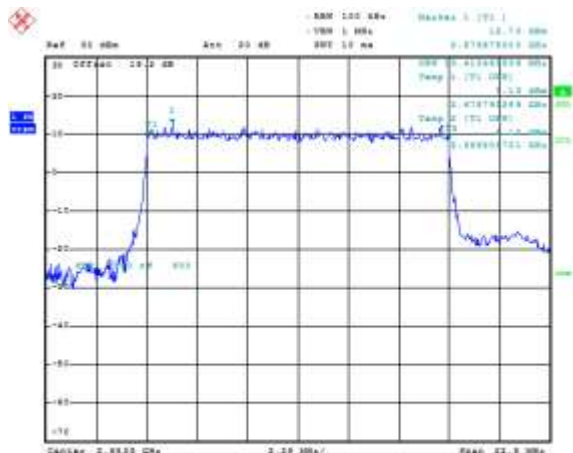



Figure 11-27a: Occupied Bandwidth, Band 41 High

Channel, 15MHz BW, RB=75



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-28a: Occupied Bandwidth, Band 41

Low Channel, 15MHz BW, RB=75

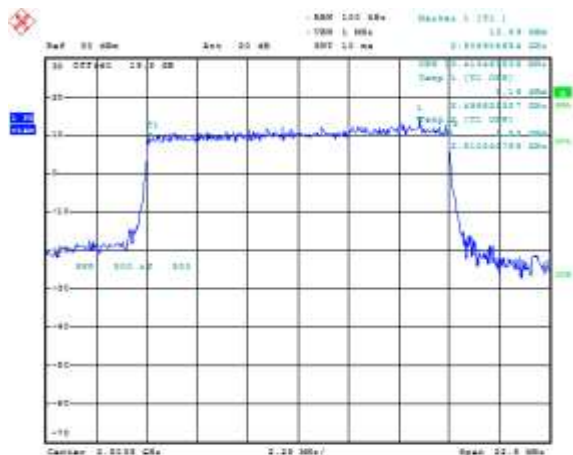


Figure 11-29a: Occupied Bandwidth, Band 41

Middle Channel, 15MHz BW, RB=75

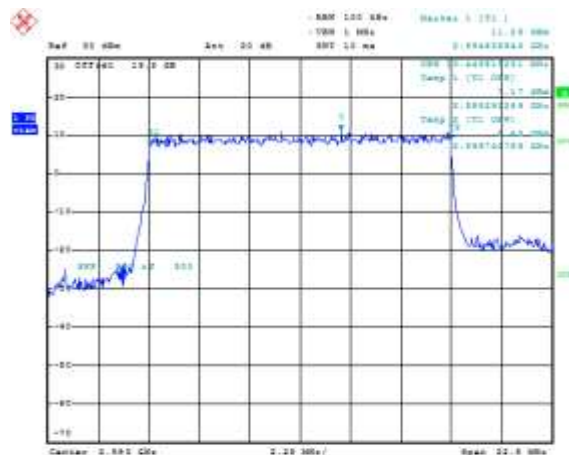
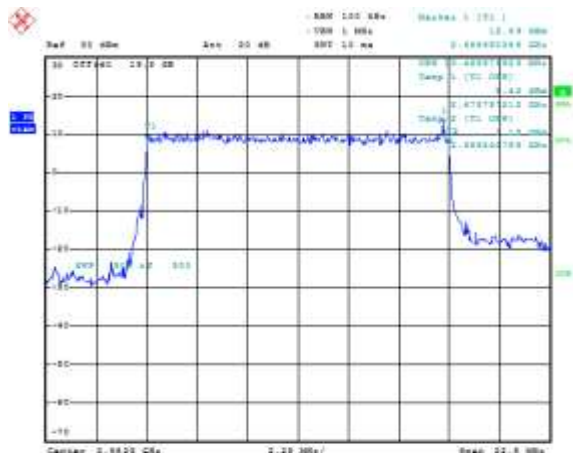



Figure 11-30a: Occupied Bandwidth, Band 41 High

Channel, 15MHz BW, RB=75



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-31a: Occupied Bandwidth, Band 41

Low Channel, 10MHz BW, RB=50

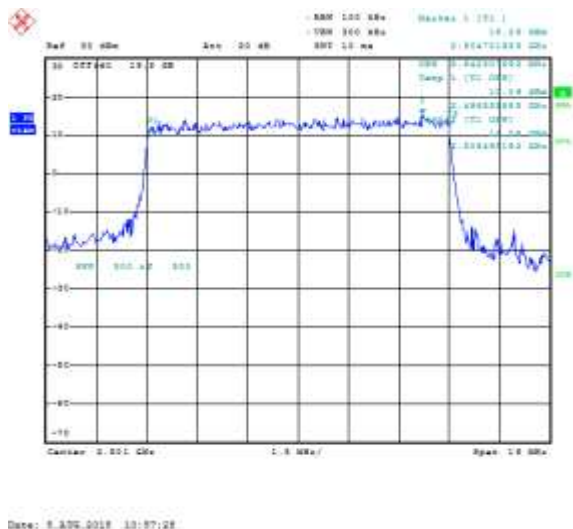


Figure 11-32a: Occupied Bandwidth, Band 41

Middle Channel, 10MHz BW, RB=50

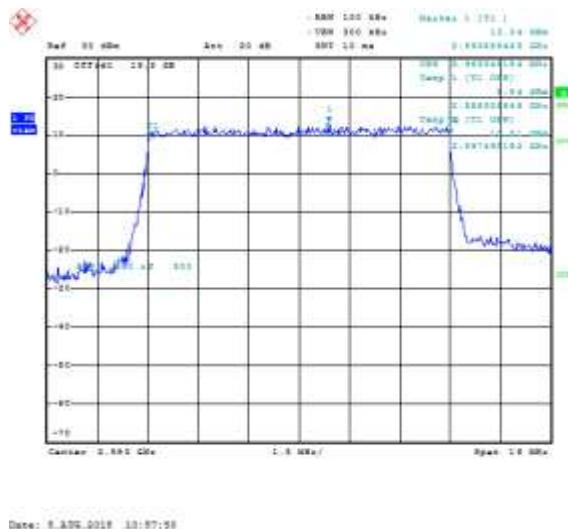
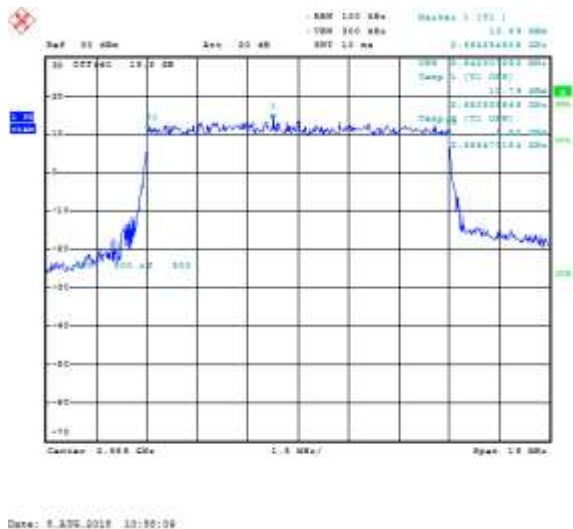



Figure 11-33a: Occupied Bandwidth, Band 41 High

Channel, 10MHz BW, RB=50



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-34a: Occupied Bandwidth, Band 41

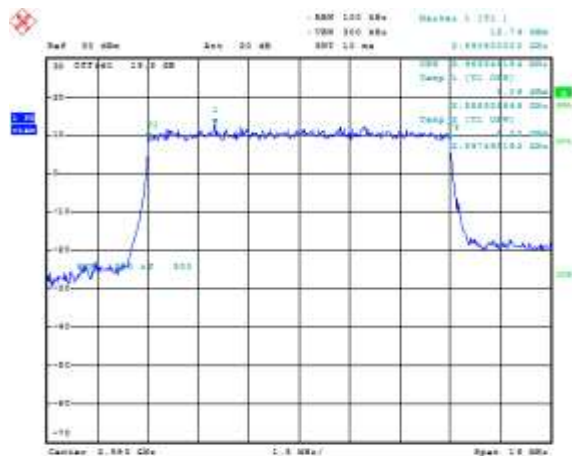
Low Channel, 10MHz BW, RB=50



Date: 9/29/2015 13:50:34

Figure 11-35a: Occupied Bandwidth, Band 41

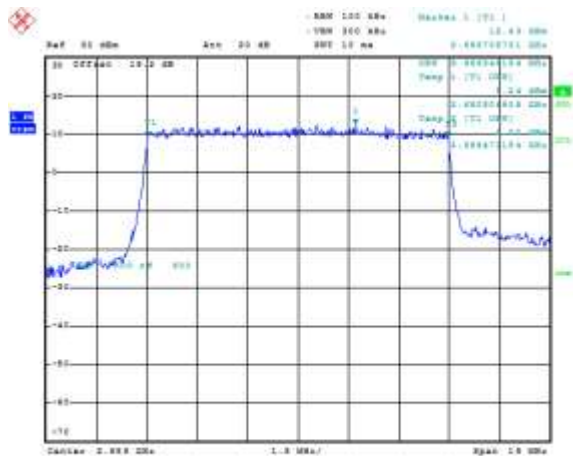
Middle Channel, 10MHz BW, RB=50




Date: 9/29/2015 13:50:36

Figure 11-36a: Occupied Bandwidth, Band 41 High

Channel, 10MHz BW, RB=50



Date: 9/29/2015 13:50:38

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-37a: Occupied Bandwidth, Band 41

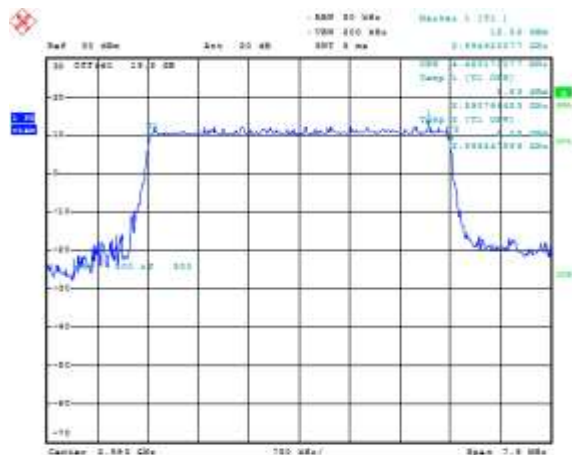
Low Channel, 5MHz BW, RB=25



Date: 9.AUG.2015 11:01:42

Figure 11-38a: Occupied Bandwidth, Band 41

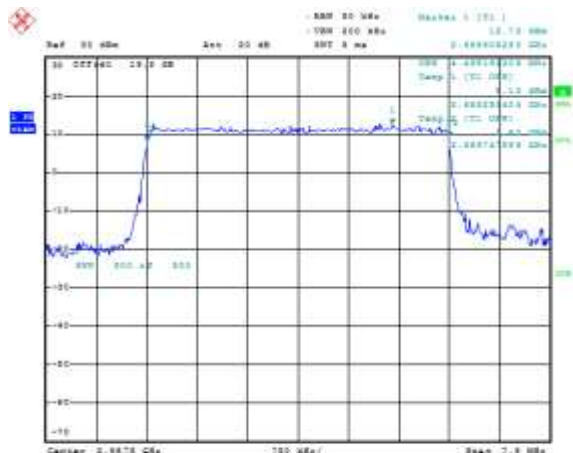
Middle Channel, 5MHz BW, RB=25



Date: 9.AUG.2015 11:02:08

Figure 11-39a: Occupied Bandwidth, Band 41 High

Channel, 5MHz BW, RB=25




Date: 9.AUG.2015 11:02:18

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	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-40a: Occupied Bandwidth, Band 41

Low Channel, 5MHz BW, RB=25

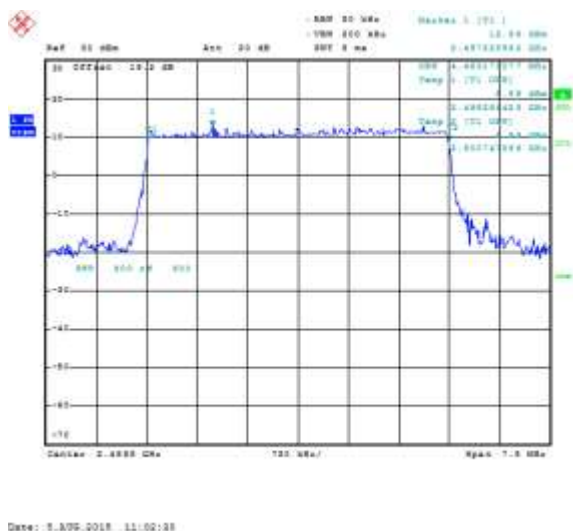


Figure 11-41a: Occupied Bandwidth, Band 41
Middle Channel, 5MHz BW, RB=25

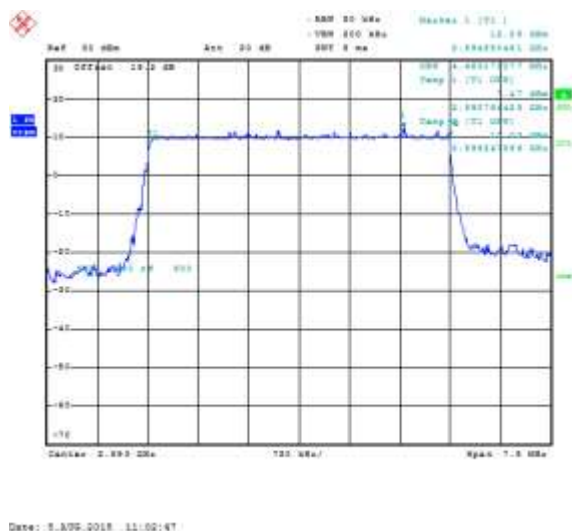
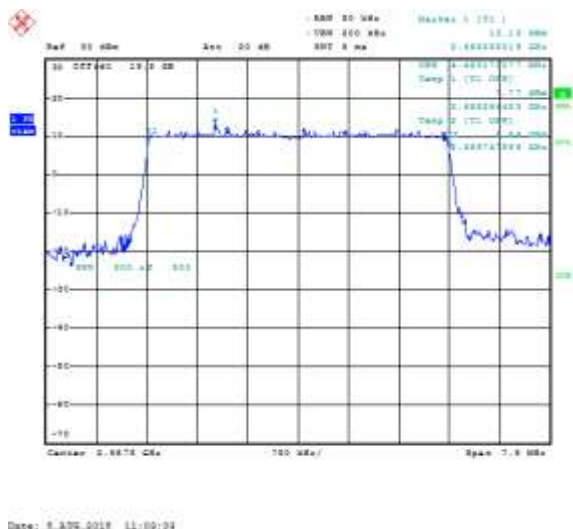



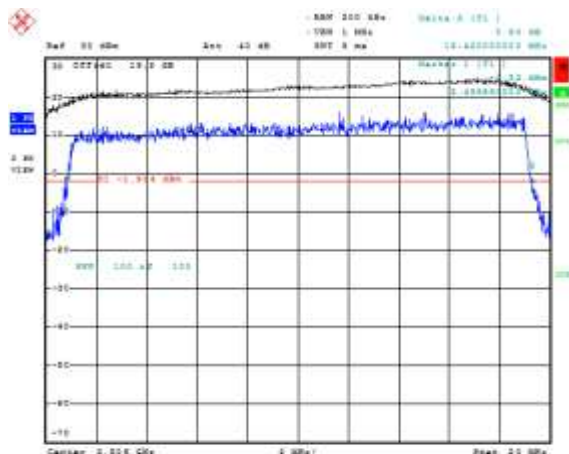
Figure 11-42a: Occupied Bandwidth, Band 41 High Channel, 5MHz BW, RB=25



	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

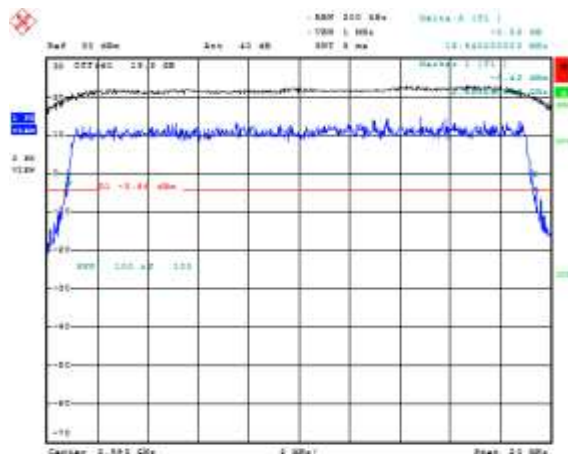
LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-43a: -26 dBc Bandwidth, Band 41 Low Channel, 20MHz BW, RB=100



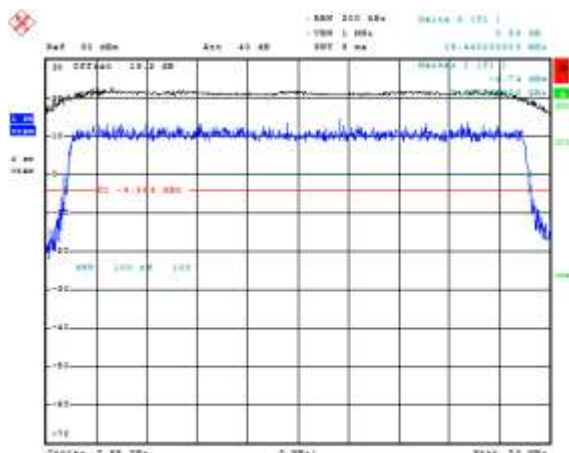
Date: 8/29/2015 13:40:11

Figure 11-44a: -26 dBc Bandwidth, Band 41 Middle Channel, 20MHz BW, RB=100



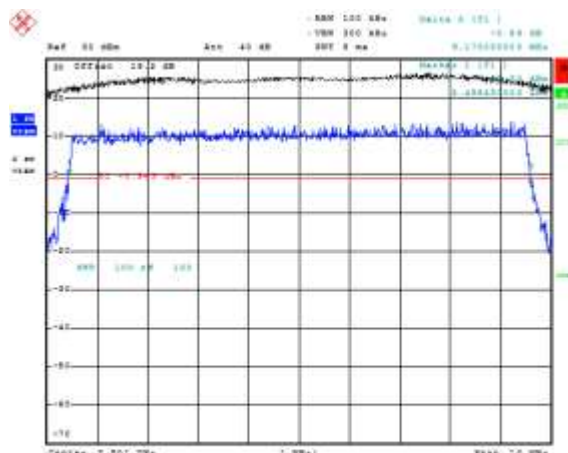
Date: 8/29/2015 13:40:27

Figure 11-45a: -26 dBc Bandwidth, Band 41 High Channel, 20MHz BW, RB=100




Date: 8/29/2015 13:40:42

Figure 11-46a: -26 dBc Bandwidth, Band 41 Low Channel, 10MHz BW, RB=50

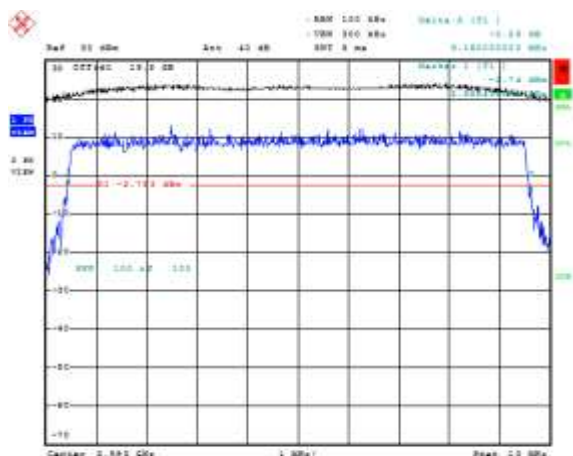


Date: 8/29/2015 13:42:28

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

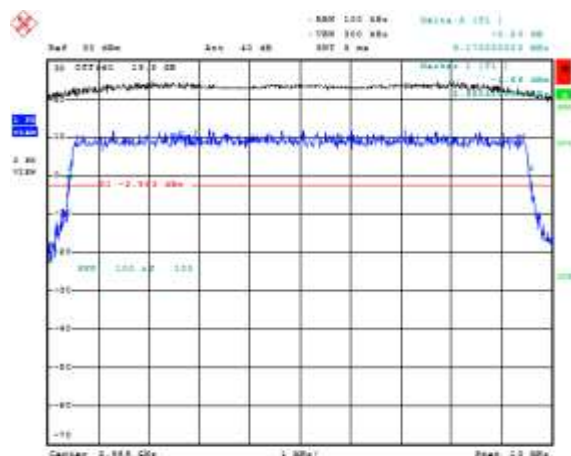
LTE Band 41 Conducted RF Emission Test Data cont'd

Figure 11-47a: -26 dBc Bandwidth, Band 41 Middle Channel, 10MHz BW, RB=50



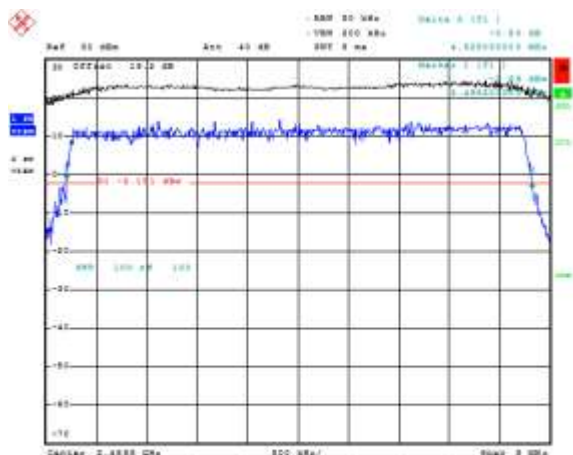
Date: 8/29/2015 13:42:33

Figure 11-48a: -26 dBc Bandwidth, Band 41 High Channel, 10MHz BW, RB=50



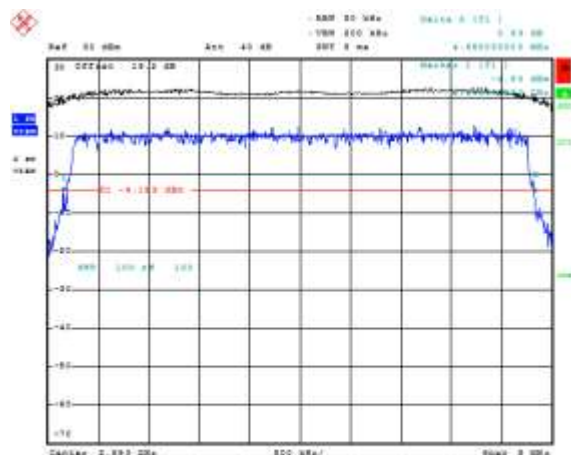
Date: 8/29/2015 13:42:47

Figure 11-49a: -26 dBc Bandwidth, Band 41 Low Channel, 5MHz BW, RB=6




Date: 8/29/2015 13:44:40

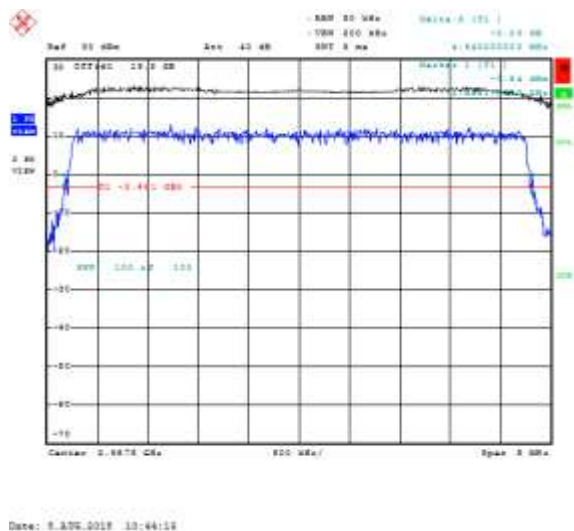
Figure 11-50a: -26 dBc Bandwidth, Band 41 Middle Channel, 5MHz BW, RB=6



Date: 8/29/2015 13:44:58

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

**Figure 11-51a: -26 dBc Bandwidth, Band 41 High
Channel, 5MHz BW, RB=6**




	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Figure 11-52a: Band 41 Low Channel Mask, 20MHz BW, RB=100

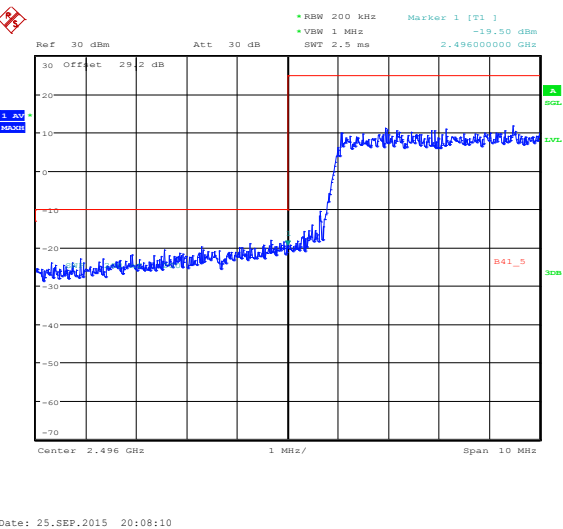


Figure 11-53a: Band 41 High Channel Mask, 20MHz BW, RB=100

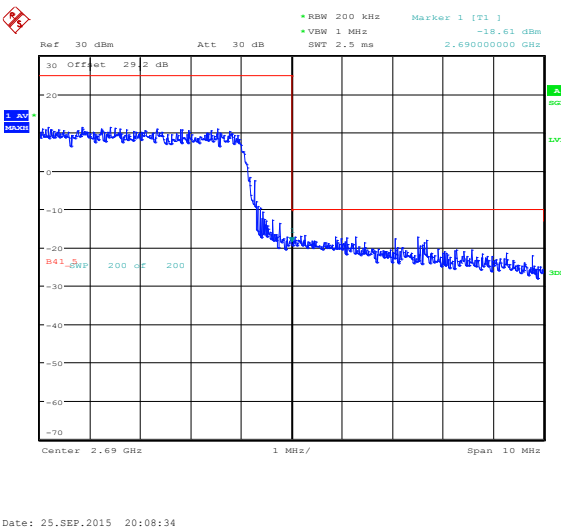


Figure 11-54a: Band 41 Low Channel Mask, 20MHz BW, RB=1

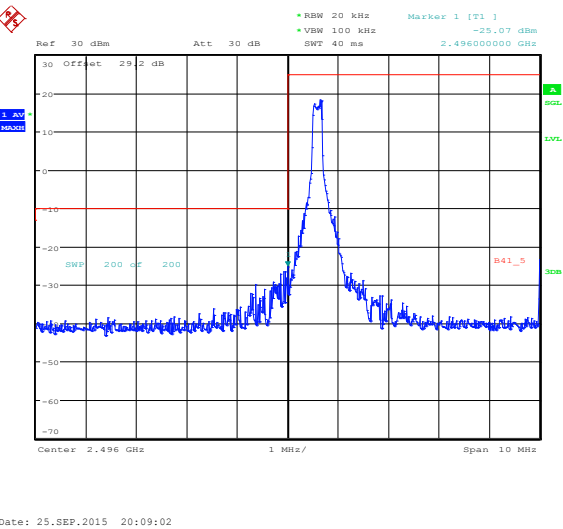
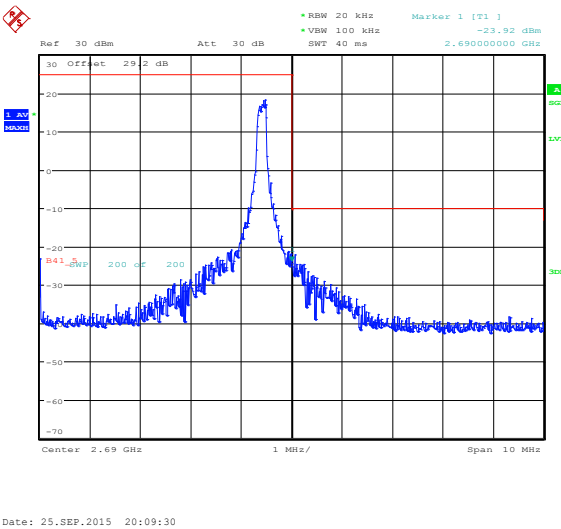


Figure 11-55a: Band 41 High Channel Mask, 20MHz BW, RB=1




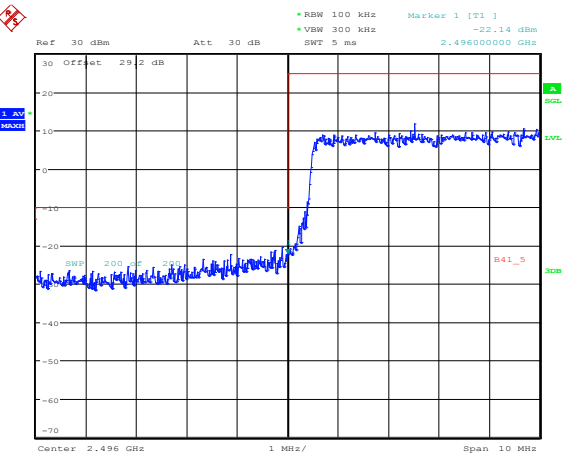
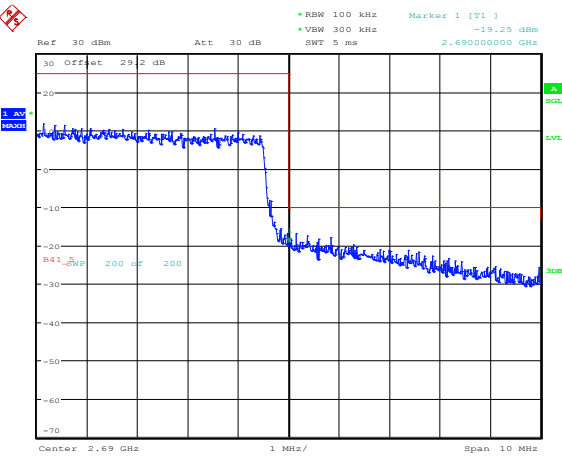
	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Figure 11-56a: Band 41 Low Channel Mask, 10MHz BW, RB=50




Date: 25.SEP.2015 20:09:12

Figure 11-57a: Band 41 High Channel Mask, 10MHz BW, RB=50

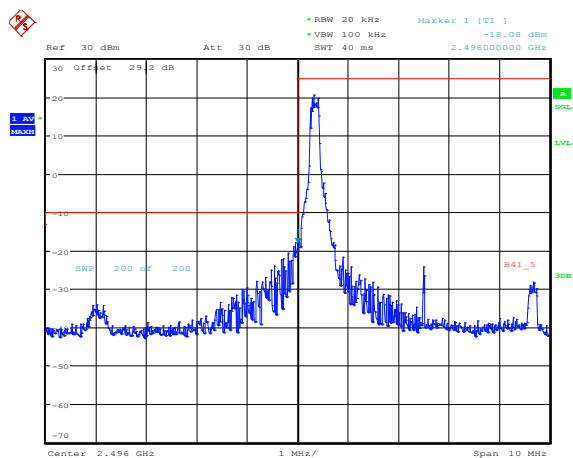


Date: 25.SEP.2015 20:09:41

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

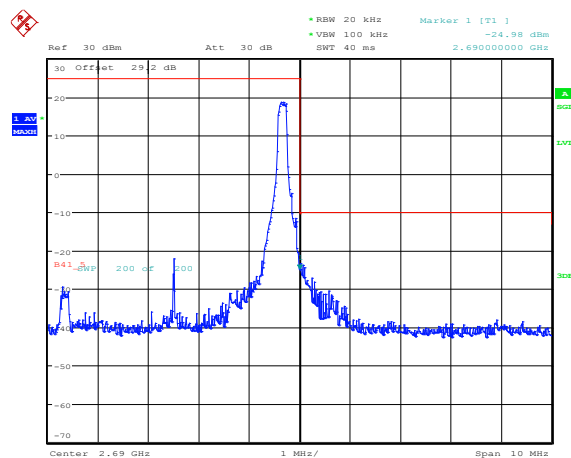
LTE Band 41 Conducted RF Emission Test Data cont'd

**Figure 11-58a: Band 41 Low Channel Mask, 10MHz
BW, RB=1**



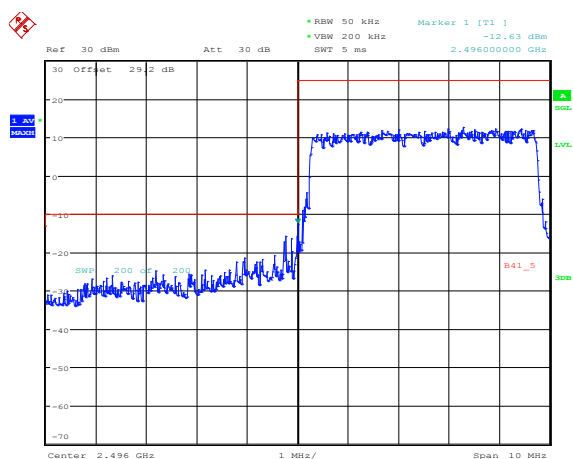
Date: 25.SEP.2015 20:10:05

**Figure 11-59a: Band 41 High Channel Mask, 10MHz
BW, RB=1**



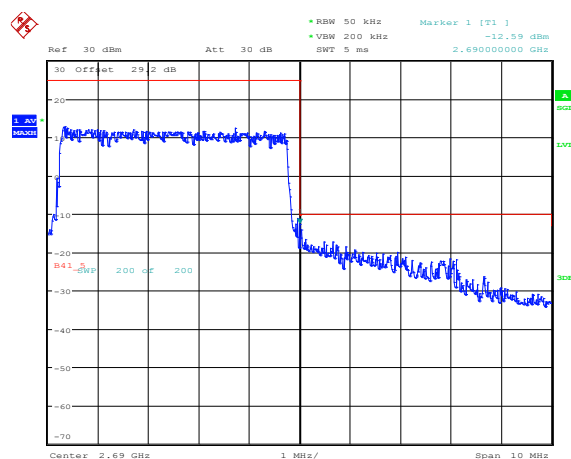
Date: 25.SEP.2015 20:10:31

**Figure 11-60a: Band 41 Low Channel Mask, 5MHz
BW, RB=25**



Date: 25.SEP.2015 20:10:16

**Figure 11-61a: Band 41 High Channel Mask, 5MHz
BW, RB=25**



Date: 25.SEP.2015 20:10:43


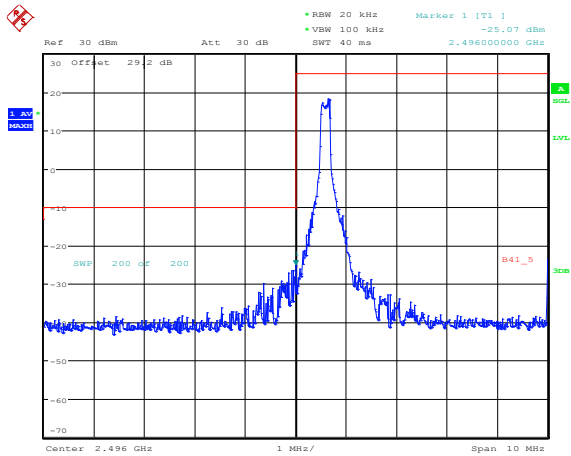
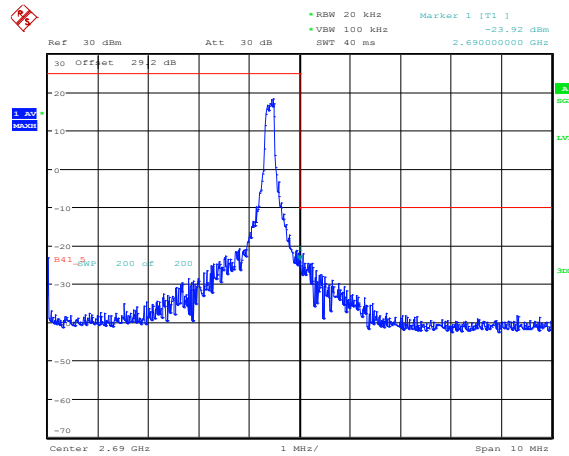
	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Figure 11-62a: Band 41 Low Channel Mask, 5MHz BW, RB=1



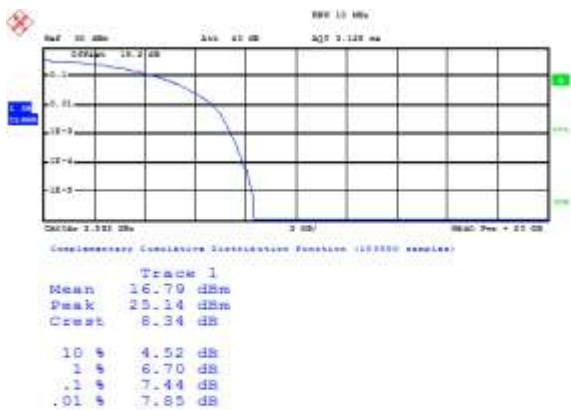
Date: 25.SEP.2015 20:09:02

Figure 11-63a: Band 41 High Channel Mask, 5MHz BW, RB=1



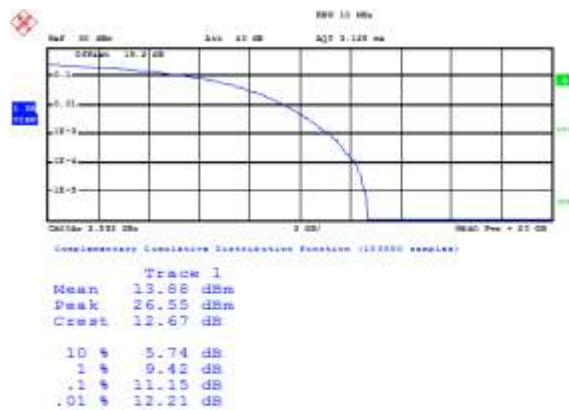
Date: 25.SEP.2015 20:09:30

Figure 11-64a: Band 41 Mid Channel PAR, 20MHz BW, RB=50




Date: 1.AUG.2018 11:00:18

Figure 11-65a: Band 41 Middle Channel PAR, 20MHz BW, RB=100

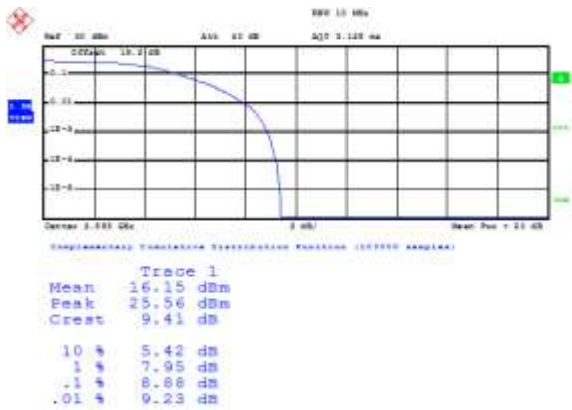


Date: 1.AUG.2018 11:00:41

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11A	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Conducted RF Emission Test Data cont'd

**Figure 11-66a: Band 41 Mid Channel PAR, 10MHz
BW, RB=25**



Date: 8.AUG.2015 11:50:19

**Figure 11-67a: Band 41 Mid Channel PAR, 10MHz
BW, RB=50**



Date: 8.AUG.2015 11:50:41

**Figure 11-68a: Band 41 Mid Channel PAR, 5MHz
BW, RB=10**




Date: 8.AUG.2015 11:51:19

**Figure 11-69a: Band 41 Mid Channel PAR, 5MHz
BW, RB=25**

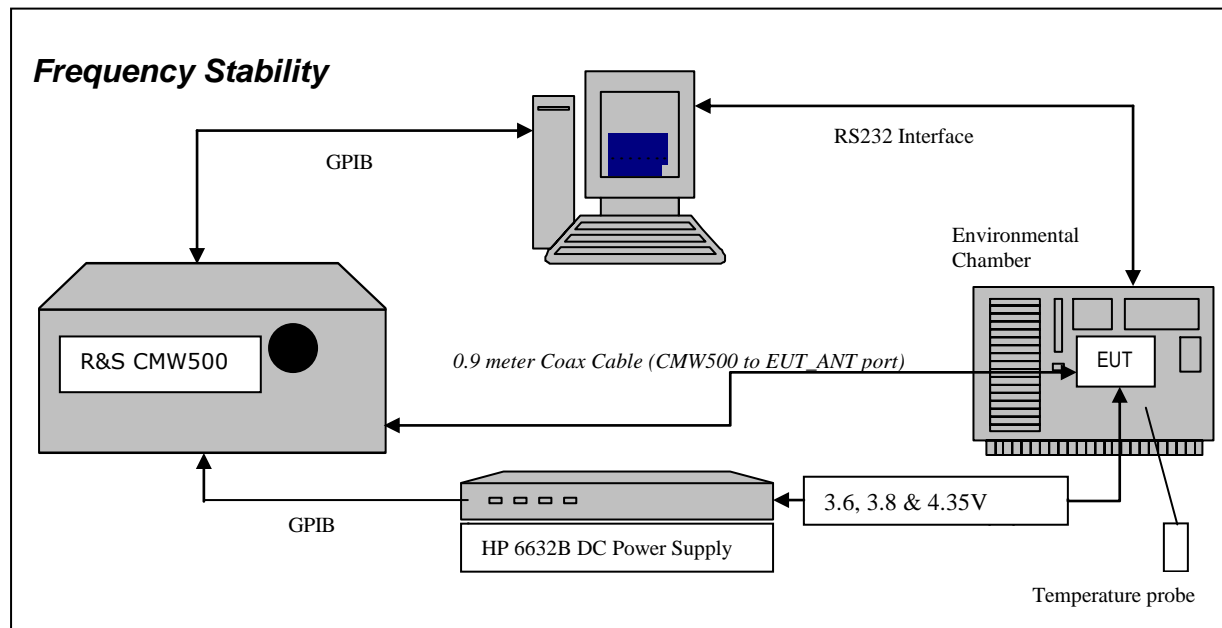


Date: 8.AUG.2015 11:51:42

APPENDIX 11B – LTE Band 41 FREQUENCY STABILITY TEST DATA

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

LTE Band 41 Frequency Stability Test Data



The following configurations were measured for model RHL211LW (STV100-3):

The following measurements were performed by Landon Martin.

CFR 47 Chapter 1 - Federal Communications Commission Rules

Part 2 Required Measurements


2.1055 Frequency Stability - Procedures

(a,b) Frequency Stability - Temperature Variation

(d) Frequency Stability - Voltage Variation

The EUT meets the requirements as stated in CFR 47 chapter 1, Section 27.54, Frequency Stability.

Frequency Stability measurement devices were configured as presented in the block diagram recording frequency, power, data, temperatures, and stepped voltages controlled via a GPIB interface linked to the Environmental chamber, a DC power supply, and the Communications Test Set. A 0.9-metre coax cable was calibrated to characterize the insertion loss for the transmitted frequencies between the RF input/output of the CMW 500 and the EUT antenna port.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Test Setup:

The EUT was placed in the Temperature chamber and connected to CMW 500 outside as shown in the figure above. Dry air was pumped inside the temperature chamber to maintain a backpressure during the test. The EUT was kept in the off condition at all times except when the following measurements were to be made.


The chamber was switched on and the temperature was set to -30°C. After the chamber stabilized at -30 °C there was a soak period of one hour to alleviate moisture in the chamber, the EUT voltage was enabled. The system software recorded the frequency, power, and associated measurements.

A Computer system controlled the automated software. This application was given the command of activating all machines intrinsic to the temperature and voltage tests controlling the CMW 500 via the GPIB Bus. The Environmental Chamber was instructed through an RS-232 serial line. The EUT dialogue was passed through a serial connection.

The EUT repetitively transmitted 100 bursts for each set of programmed parameters recording temperature, voltage settings, and systematically selected frequencies. The power supply was cycled from minimum voltage 3.6 volts, 3.8 volts and to 4.35 volts maximum voltage. The frequency error was measured at a maximum output power and recorded by the automated system test software.

The EUT output power and frequency was measured at 3.6 volts, 3.8 volts and 4.35 volts. The transmit frequency was measured on 2593MHz for 10MHz bandwidth with maximum (50) RB. The transmit frequency was varied in 3 steps consisting of 779.5 MHz, 2593.0 MHz and 784.5 MHz each was measured under 5 MHz bandwidth with maximum (25) RBs. This frequency was recorded in MHz and deviation from nominal, in Parts Per Million.

After the initial one-hour soak at the beginning of the tests, a period of thirty minutes soak was initialized between each ascending temperature step, before proceeding to the next measurement test cycle.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW


Procedure:

The test system software for commencing the Frequency Stability Tests carried through the following cycle.

127. Switch on the HP 6632B power supply; CMW 500 Communications test Set, and Environmental Chamber.
128. Start test program
129. Set the Temperature to –30°C and maintain a period of one- hour soak time, with the EUT supply voltage disabled.
130. Set power supply voltage to 3.6 volts.
131. Set up CMW 500 Radio Communication Tester.
132. Command the CMW 500 to switch to the low channel.
133. Enable the voltage to the EUT, and connect a link to the CMW 500 test set.
134. EUT is commanded to Transmit 100 Bursts.
135. Software logs the following data from the CMW 500, power supply and temperature chamber: Traffic Channel Number, Traffic Channel Frequency, Power Level, Chamber Temperature, Supply Voltage, Power and Frequency Error.
136. The CMW 500 commands the EUT to change frequency to the middle channel and high channel and repeats steps 7 to 9.
137. Repeat steps 5 to 10 changing the supply voltage to 3.8 Volts
138. Increase temperature by 10°C and soak for 1/2 hour.
139. Repeat steps 4 - 12 for temperatures –30°C to 60°C.
140. Repeat steps 5 to 10 changing the supply voltage to 4.35 volts

Procedure 5 to 10 was repeated at room temperature (20°C) with the power supply voltage set to 3.6, 3.8 and 4.35 volts


The maximum frequency error in the LTE Band 41 measured was **-2.5891PPM**.

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW

Date of test: August 28, 2015

LTE Band 41 results (20MHz Bandwidth): channels 40620 @ 20°C maximum transmitted power

Traffic Channel Number	LTE Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
40620	2593.00	3.6	20	-2661.92	-1.0266
40620	2593.00	3.8	20	933.12	0.3599
40620	2593.00	4.35	20	852.94	0.3289

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11B	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW, 2503A-RHL210LW


LTE Band 41 Results (20MHz Bandwidth): channel 40620 @ maximum transmitted power

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
40620	2593.00	3.6	-30	-943.48	-0.3639
40620	2593.00	3.6	-20	999.87	0.3856
40620	2593.00	3.6	-10	936.84	0.3613
40620	2593.00	3.6	0	-932.81	-0.3597
40620	2593.00	3.6	10	-960.92	-0.3706
40620	2593.00	3.6	20	-2661.92	-1.0266
40620	2593.00	3.6	30	1021.14	0.3938
40620	2593.00	3.6	40	-1006.67	-0.3882
40620	2593.00	3.6	50	818.70	0.3157
40620	2593.00	3.6	60	-999.16	-0.3853

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
40620	2593.00	3.8	-30	-998.00	-0.3849
40620	2593.00	3.8	-20	-954.18	-0.3680
40620	2593.00	3.8	-10	943.74	0.3640
40620	2593.00	3.8	0	-970.56	-0.3743
40620	2593.00	3.8	10	847.25	0.3267
40620	2593.00	3.8	20	933.12	0.3599
40620	2593.00	3.8	30	916.53	0.3535
40620	2593.00	3.8	40	-901.74	-0.3478
40620	2593.00	3.8	50	-6713.43	-2.5891
40620	2593.00	3.8	60	-641.61	-0.2474

Traffic Channel Number	Frequency (MHz)	Voltage (Volts)	Temperature (Celsius)	Frequency Error (Hz)	PPM
40620	2593.00	4.35	-30	-933.84	-0.3601
40620	2593.00	4.35	-20	913.24	0.3522
40620	2593.00	4.35	-10	873.23	0.3368
40620	2593.00	4.35	0	808.24	0.3117
40620	2593.00	4.35	10	1895.51	0.7310
40620	2593.00	4.35	20	852.94	0.3289
40620	2593.00	4.35	30	1059.45	0.4086
40620	2593.00	4.35	40	-970.67	-0.3743
40620	2593.00	4.35	50	-1901.19	-0.7332
40620	2593.00	4.35	60	-885.82	-0.3416

APPENDIX 11C – LTE Band 41 RADIATED EMISSIONS TEST DATA

	EMC Test Report for the BlackBerry® smartphone Model RHK211LW (STV100-1), RHL211LW (STV100-3) APPENDIX 11C	
Test Report No.: RTS-6066-1509-13A_Rev1	Dates of Test: July 21 to September 25, 2015	FCC ID: L6ARHK210LW, L6ARHL210LW IC: 2503A-RHK210LW,

Radiated Power Test Data Results

The following configurations were measured for model RHL211LW (STV100-3):

The following measurements were performed by Savtej Sandhu.

Date of Test: August 26, 2015

The environmental tests conditions were: Temperature: 26.1 °C

Relative Humidity: 31.0 %

The BlackBerry® smartphone was standalone, with horizontal top pointing up the RX antenna when the turntable is at 0 degree position.

Measurements were performed with QPSK and 16QAM modulations. The smallest test margins are reported below.

Test Distance was 3.0 meters with the RX antenna height scans between 3-4 meters height.

LTE Band 41, 15MHz BW, RB=1, QPSK modulation

EUT				Rx Antenna		Spectrum Analyzer		Substitution Method					
Type	Ch	Frequency (MHz)	Band	Type	Pol.	Reading (dBm)	Max (V, H) (dBm)	Pol. Tx-Rx	Reading (dBm)	Corrected Reading (relative to Dipole)		Li mit (dBm)	Diff. To Limit (dB)
										(dBm)	(W)		
F0	39725	2503.50	41	Horn	V	-42.27	-35.06	V-V	-17.42	18.94	0.08	33.00	14.06
F0	39725	2503.50	41	Horn	H	-35.06		H-H	-17.54				
F0	40620	2593.00	41	Horn	V	-41.86	-34.07	V-V	-16.28	19.87	0.10	33.00	13.13
F0	40620	2593.00	41	Horn	H	-34.07		H-H	-17.19				
F0	41515	2682.50	41	Horn	V	-40.67	-33.50	V-V	-14.81	21.14	0.13	33.00	11.86
F0	41515	2682.50	41	Horn	H	-33.50		H-H	-15.86				

LTE Band 41, 20MHz BW, RB=1, 16QAM modulation

EUT				Rx Antenna		Spectrum Analyzer		Substitution Method					
Type	Ch	Frequency (MHz)	Band	Type	Pol.	Reading (dBm)	Max (V, H) (dBm)	Pol. Tx-Rx	Reading (dBm)	Corrected Reading (relative to Dipole)		Li mit (dBm)	Diff. To Limit (dB)
										(dBm)	(W)		
F0	39750	2506.00	41	Horn	V	-42.72	-35.78	V-V	-17.94	18.42	0.07	33.00	14.58
F0	39750	2506.00	41	Horn	H	-35.78		H-H	-18.14				
F0	40620	2593.00	41	Horn	V	-42.34	-34.96	V-V	-17.21	18.94	0.08	33.00	14.06
F0	40620	2593.00	41	Horn	H	-34.96		H-H	-18.08				
F0	41490	2680.00	41	Horn	V	-41.83	-34.03	V-V	-15.25	20.70	0.12	33.00	12.30
F0	41490	2680.00	41	Horn	H	-34.03		H-H	-16.34				

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